

04-1200

A

04/10/00
JC777 U.S. PTO

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
REQUEST FOR FILING NEW UTILITY PATENT APPLICATION UNDER 37 CFR 1.53(b)
(Case No. RA043D2DC)

JC530 U.S. PTO
09/545648
04/10/00

To the Assistant Commission for Patents
Washington, D.C. 20231

Sir:

Transmitted herewith for filing under 35 U.S.C. 111(a) and 37
C.F.R. §1.53(b) is a new utility patent application for:

Title: INTEGRATED CIRCUIT I/O USING A
HIGH PERFORMANCE BUS INTERFACE

Inventors: Michael Farmwald
Mark Horowitz

This application is a CONTINUATION APPLICATION of:

Inventors: Michael Farmwald
Mark Horowitz

Ser. No.: 09/161,090

Art Unit: 2781

Filed: September 25, 1998

Examiner: G. Auve'

Title: INTEGRATED CIRCUIT HAVING
MEMORY WHICH SYNCHRONOUSLY
SAMPLES INFORMATION WITH RESPECT
TO EXTERNAL CLOCK SIGNALS

To effect the above-requested filing today:

1. Attached is a copy of the prior application as originally
filed, including:
 - [X] Specification, Claims, and Abstract (125 pages)
 - [X] Drawings: 1 set of **formal** drawings having 14 sheets
 - [X] Original Declaration and Power of Attorney (2 pages)
2. Incorporation by Reference: The entire disclosure of the prior
application, from which a copy of the oath or declaration is
supplied, is considered as being part of the disclosure of the
accompanying application and is hereby incorporated by
reference therein.

3. A Power of Attorney to Neil A. Steinberg, Reg. No. 34,735 is attached hereto and filed herewith. That Power of Attorney also revokes all other powers of attorney. Accordingly, kindly address all future communications to:

Neil A. Steinberg, Esq.
Rambus Inc.
2465 Latham Street
Mountain View, California 94040

Telephone No. 650-944-7772
Facsimile No. 650-428-0914

4. The Examiner's attention is directed to both the second paragraph of guideline (2) in MPEP 609 and to the last paragraph of MPEP 2001.06(b) and to the submission in the prior application of the Information Disclosure Statements and document copies filed in Application Serial Nos. 09/161,090 and 09/798,520.

5. Attached is a **PRELIMINARY AMENDMENT** which, among other things, cancels claims 1-150, and adds new claims 151-179. This Preliminary Amendment is to be entered **BEFORE** fee calculation.

6.

FILING FEE

(BASED ON THE NUMBER OF CLAIMS AS FILED AND CHANGED BY PRELIMINARY AMENDMENT)

Basic Fee \$ 690.00

Additional Fees:

Surcharge for more than 20 total claims (2 * \$18) \$ 162.00

Surcharge for more than 3 independent claims (0 * 78) \$ - 0 -

Surcharge for multiple dependent claims \$ - 0 -

Total Filing Fee \$ 852.00

7. Manner of Payment:

[] A check payable to the Commissioner of Patents and Trademarks, in the amount of \$_____ is enclosed as payment of the Total Filing Fee.

[XX] Please charge my Deposit Account No. 50-0998 in the amount of \$ 852.00 to cover the above fees. A duplicate copy of this sheet is enclosed.

[XX] The Commissioner is hereby authorized to charge any fees which may be required, or credit any overpayment to Deposit Account No. 50-0998. A duplicate copy of this sheet is enclosed.

Date: April 10, 2000

Respectfully submitted,



Neil A. Steinberg

Reg. No. 34,735

650-944-7772

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
(Case No. RA043D2DC)

In the Application of:)
)
FARMWALD ET AL.) Group
) Art Unit:
Serial No: CONTINUATION OF 09/161,090)
) Before
Filed: Herewith) Examiner:
)
Title: INTEGRATED CIRCUIT HAVING MEMORY)
WHICH SYNCHRONOUSLY SAMPLES)
INFORMATION WITH RESPECT TO)
EXTERNAL CLOCK SIGNALS)

Assistant Commissioner for Patents
Washington, DC 20231

PRELIMINARY AMENDMENT

Dear Sir:

Prior to the examination of the above-referenced application,
kindly amend the application as follows:

IN THE ABSTRACT:

Please delete the Abstract of the Disclosure and substitute
the attached Abstract of the Disclosure.

IN THE TITLE:

Please delete the title and substitute --SYSTEM HAVING DOUBLE
DATA TRANSFER RATE AND INTEGRATED CIRCUIT THEREFOR--.

IN THE SPECIFICATION:

On page 1, line 8, insert --This application is a continuation of Application No. 09/161,090, filed on September 25, 1998 (still pending), which is a division of Application No. 08/798,520, filed on February 10, 1997 (now U.S. Patent 5,841,580), which is a division of Application No. 08/448,657, filed May 24, 1995 (now U.S. Patent 5,638,334), which is a division of Application No. 08/222,646, filed on March 31, 1994 (now U.S. Patent 5,513,327), which is a continuation of Application No. 07/954,945, filed on September 30, 1992 (now U.S. Patent 5,319,755), which is a continuation of Application No. 07/510,898, filed on April 18, 1990 (now abandoned).--

On page 3, line 9, delete "micro-processor" and substitute --microprocessor--.

On page 6, line 1, delete "4,646,279" and substitute --4,646,270--.

On page 10, line 18, delete "Figure 7 shows" and substitute --Figures 7a and 7b show--.

On page 10, line 21, delete "Figure 8 shows" and substitute --Figures 8a and 8b show--.

On page 34, line 4, after "devices" insert --do--.

On page 41, line 1, delete "or'" and substitute -- or--.

On page 45, line 17, delete "Fig. 7" and substitute --Figures 7a and 7b--.

On page 47, line 2, delete "Figure 8" and substitute
--Figure 8a--.

On page 47, line 5, delete "from left to right" and substitute
-- from right to left--.

On page 47, line 8, delete "right" and substitute --left--.

On page 47, line 9, delete the first "left" and substitute
--right--.

On page 49, line 22, delete "primay" and substitute
--primary--.

On page 54, line 13, delete "70" and substitute --69--.

On page 56, line 2, delete "Figure11" and substitute
--Figure 11--.

On page 60, line 10, after "147" insert --A, B--.

IN THE CLAIMS:

Kindly **cancel** claims 1-150, without prejudice.

Kindly **add** the following claims:

- 1 --151. A system comprising:
- 2 a first integrated circuit device coupled to an external
- 3 signal line, the first integrated circuit device including:
- 4 output driver circuitry to output data onto the external
- 5 signal line wherein:

6 the output driver circuitry outputs a first portion of
7 data in response to a rising edge transition of an
8 external clock signal; and

9 the output driver circuitry outputs a second portion
10 of data in response to a falling edge transition of the
11 external clock signal; and

12 a second integrated circuit device coupled to the external
13 signal line, the second integrated circuit device including:

14 output driver circuitry to output data onto the external
15 signal line wherein:

16 the output driver circuitry outputs a first portion of
17 data in response to a rising edge transition of the
18 external clock signal; and

19 the output driver circuitry outputs a second portion
20 of data in response to a falling edge transition of the
21 external clock signal.

1 152. The system of claim 151 further including a clock
2 generator coupled to a second external signal line to generate the
3 external clock signal, wherein the first and second integrated
4 circuit devices are each coupled to the second external signal
5 line.

1 153. The system of claim 151 wherein the first and second
2 integrated circuit devices each include a clock alignment circuit
3 coupled to the output driver circuitry.

1 154. The system of claim 153 wherein each clock alignment
2 circuit is a delay lock loop circuit to generate an internal clock
3 signal, and wherein the output driver circuitry outputs data in
4 response to the internal clock signal.

1 155. The system of claim 151 wherein the first and second
2 integrated circuit devices each further include:

3 multiplexer circuitry coupled to the output driver circuitry,
4 wherein:

5 in response to a first transition of the external clock
6 signal, the multiplexer circuitry couples the first portion of
7 data to an input of the output driver circuitry; and

8 in response to a second transition of the external clock
9 signal, the multiplexer circuitry couples the second portion
10 of data to the input of the output driver circuitry.

1 156. The system of claim 155 wherein the first and second
2 integrated circuit devices each further include a clock alignment
3 circuit to generate a first internal clock signal, and wherein the
4 multiplexer circuitry couples the first portion of data to the

5 input of the output driver circuitry in response to the first
6 internal clock signal.

1 157. The system of claim 156 wherein the clock alignment
2 circuit generates a second internal clock signal, and wherein the
3 multiplexer circuitry couples the second portion of data to the
4 input of the output driver circuitry in response to the second
5 internal clock signal.

1 158. The system of claim 151 wherein both the rising edge
2 transition of the external clock signal and the falling edge
3 transition of the external clock signal transpire during a first
4 clock cycle of the external clock signal.

1 159. The system of claim 151 wherein both the rising and
2 falling edge transitions of the external clock signal each include
3 a voltage swing of less than one volt.

1 160. The system of claim 151 wherein the first and second
2 integrated circuit devices each further include:

3 input receiver circuitry to sample data from the external
4 signal line wherein:

5 the input receiver circuitry samples a first portion
6 of data in response to a rising edge transition of the
7 external clock signal; and

8 the input receiver circuitry samples a second portion
9 of data in response to a falling edge transition of the
10 external clock signal.

1 161. A system comprising:

2 a first integrated circuit device coupled to an external
3 signal line, the first integrated circuit device including:

4 output driver circuitry to output data onto the external
5 signal line wherein:

6 the output driver circuitry outputs a first portion of
7 data synchronously with respect to a rising edge transition
8 of an external clock signal; and

9 the output driver circuitry outputs a second portion of
10 data synchronously with respect to a falling edge transition
11 of the external clock signal; and

12 a second integrated circuit device coupled to the external
13 signal line, the second integrated circuit device including:

14 input receiver circuitry to sample data from the external
15 signal line wherein:

16 the input receiver circuitry samples the first portion
17 of data synchronously with respect to the rising edge
18 transition of the external clock signal; and

19 the input receiver circuitry samples the second
20 portion of data synchronously with respect to the falling
21 edge transition of the external clock signal.

1 162. The system of claim 161 further including a clock
2 generator coupled to a second external signal line to generate the
3 external clock signal, wherein the first and second integrated
4 circuit devices receive the external clock signal.

5 163. The system of claim 161 wherein the first integrated
6 circuit device further includes a clock alignment circuit to
7 receive the external clock signal and to generate an internal clock
8 signal, wherein the output driver circuitry outputs data in
9 response to the internal clock signal.

1 164. The system of claim 161 wherein the first integrated
2 circuit device further includes:

3 multiplexer circuitry coupled to the output driver circuitry,
4 wherein:

5 in response to a first transition of the external clock
6 signal, the multiplexer circuitry couples the first portion of
7 data to an input of the output driver circuitry; and

8 in response to a second transition of the external clock
9 signal, the multiplexer circuitry couples the second portion
10 of data to the input of the output driver circuitry.

1 165. The system of claim 161 wherein both the rising edge
2 transition of the external clock signal and the falling edge
3 transition of the external clock signal transpire during a first
4 clock cycle of the external clock signal.

5 166. The system of claim 161 wherein both the rising and
6 falling edge transitions of the external clock signal include
7 voltage swings of less than one volt.

8 167. The system of claim 161 wherein the second integrated
9 circuit further includes a clock alignment circuit to receive the
10 external clock signal and to generate an internal clock signal,
1 wherein the input receiver circuitry on the second integrated
2 circuit device samples data in response to the internal clock
3 signal.
4
5
6

1 168. An integrated circuit device comprising:
2 output driver circuitry to output data onto a first external
3 signal line wherein:

4 the output driver circuitry outputs a first portion of
5 data in response to a rising edge transition of a first
6 external clock signal and the output driver circuitry outputs
7 a second portion of data in response to a falling edge
8 transition of the first external clock signal.

1 169. The integrated circuit device of claim 168 further
2 including input receiver circuitry to sample data from a second
3 external signal line wherein:

4 the input receiver circuitry samples a first portion
5 of data in response to a rising edge transition of a
6 second external clock signal; and

7 the input receiver circuitry samples a second portion
8 of data in response to a falling edge transition of the
9 second external clock signal.

1 170. The integrated circuit of claim 169 further including
2 a clock alignment circuit to generate a first internal clock
3 signal, and wherein the input receiver circuitry samples the first
4 portion of data in response to the first internal clock signal.

1 171. The system of claim 170 wherein the clock alignment
2 circuit generates a second internal clock signal, and the input
3 receiver samples the second portion of data in response to the
4 second internal clock signal.

1 172. The integrated circuit device of claim 168 wherein the
2 clock alignment circuit generates an internal clock signal, and the
3 output driver circuitry outputs data in response to the internal
4 clock signal.

1 173. The integrated circuit device of claim 168 further
2 including input receiver circuitry to sample data from the first
3 external signal line wherein:
4

5 the input receiver circuitry samples a first portion of
6 data in response to a rising edge transition of the first
7 external clock signal; and
8

9 the input receiver circuitry samples a second portion
of data in response to a falling edge transition of the first
external clock signal.

1 174. The integrated circuit device of claim 168 further
2 including:

3 multiplexer circuitry coupled to the output driver circuitry,
4 wherein:

5 in response to a first transition of the first
6 external clock signal, the multiplexer circuitry couples the
7 first portion of data to an input of the output driver
8 circuitry; and

9 in response to a second transition of the first
10 external clock signal, the multiplexer circuitry couples the
11 second portion of data to the input of the output driver
12 circuitry.

1 175. The integrated circuit device of claim 174 further
2 including a clock alignment circuit to generate a first internal
3 clock signal using the first external clock signal, wherein the
4 multiplexer circuitry couples the first portion of data to the
5 input of the output driver circuitry in response to the first
6 internal clock signal.

1 176. The integrated circuit device of claim 175 wherein the
2 clock alignment circuit generates a second internal clock signal,
3 and wherein the multiplexer circuitry couples the second portion of
4 data to the input of the output driver circuitry in response to the
5 second internal clock signal.

1 177. The integrated circuit device of claim 176 further
2 including a clock alignment circuit coupled to the first external

3 clock signal, the clock alignment circuit to generate a first
4 internal clock signal, wherein the multiplexer circuitry couples
5 the first portion of data to the input of the output driver
6 circuitry in response to the first internal clock signal.

1 178. The integrated circuit device of claim 168 wherein both
2 the rising edge transition of the first external clock signal and
3 the falling edge transition of the first external clock signal
4 transpire during a first clock cycle of the first external clock
5 signal.

179. The system of claim 168 wherein both the rising and
falling edge transitions of the first external clock signal include
voltage swings of less than one volt.--

REMARKS

This Preliminary Amendment seeks to place this application in
condition for allowance. This application is a continuation of
Application No. 09/161,090, which is a division of Application No.
09/798,520, now U.S. Patent 5,841,580. Application Serial No.
09/161,090 is pending.

Applicants request priority to Application Serial No.
07/510,898, filed April 18, 1990, now abandoned. Applicants

request such priority through Application No. 09/161,090, filed on September 25, 1998 (still pending); which is a division of Application No. 08/798,520, filed on February 10, 1997 (now U.S. Patent 5,841,580); which is a division of Application No. 08/448,657, filed May 24, 1995 (now U.S. Patent 5,638,334); which is a division of Application No. 08/222,646, filed on March 31, 1994 (now U.S. Patent 5,513,327); which is a continuation of Application No. 07/954,945, filed on September 30, 1992 (now U.S. Patent 5,319,755); which is a continuation of Application No. 07/510,898, filed on April 18, 1990 (now abandoned).

Accordingly, Applicants claim the benefit of the filing date of Application Serial No. 07/510,898 -- i.e., April 18, 1990. The specification has been amended to identify the continuation or related U.S. application data identified above. No new matter has been added.

In this continuation application, Applicants present new claims which set forth novel and unobvious features of Applicants' invention. Applicants submit new claims 151-179 to more fully protect the instant invention. No new matter has been added.

The newly submitted claims are believed to be fully supported by the specification -- see, for example, Figures 2 and 10-13; page 13, line 7 to page 14, line 3; page 44, line 5 to page 45, line 16; page 46, line 19 to page 48, line 17; page 53, line 5 to page 59, line 2; and page 61 lines 9-16.

The specification has been amended to correct obvious spelling, typographical and grammatical errors. In addition, a new Abstract of the Disclosure is attached hereto. No new matter has been added.

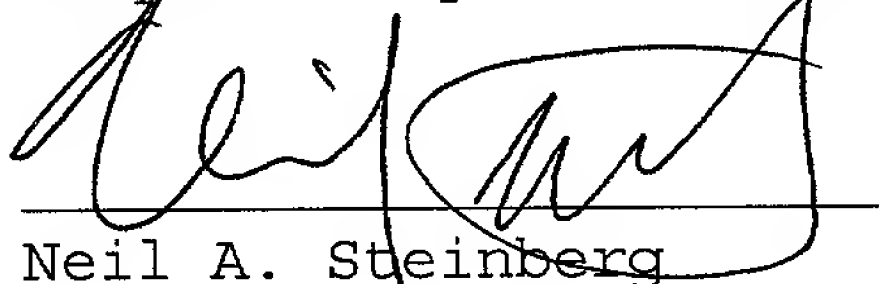
Finally, accompanying this Preliminary Amendment is a Request to Approve Drawing Changes. In that Request, Applicants seek to amend Figure 10 to more fully reflect the discussion in the specification, in particular, page 55, lines 12-16 and page 58, lines 13-23. The proposed changes are indicated in red. No new matter has been added. Applicants respectfully request that the Examiner approve the proposed changes to Figure 10. A new Figure 10 which incorporates the changes is also attached to the Request.

CONCLUSION

Applicants request entry of the foregoing amendment prior to examination of this application. Applicants submit that all of the claims present patentable subject matter. Accordingly, Applicants respectfully request allowance of all of the claims.

Date: April 10, 2000

Respectfully submitted,



Neil A. Steinberg
Reg. No. 34,735
650-944-7772

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
(Case No. RA043D2DC)

In the Application of:)	
)	
FARMWALD ET AL.)	Group
)	Art Unit:
Serial No: CONTINUATION OF 09/161,090)	
)	Before
Filed: Herewith)	Examiner:
)	
Title: INTEGRATED CIRCUIT HAVING MEMORY)	
WHICH SYNCHRONOUSLY SAMPLES)	
INFORMATION WITH RESPECT TO)	
EXTERNAL CLOCK SIGNALS)	

Assistant Commissioner for Patents
Washington, DC 20231

REQUEST TO APPROVE DRAWING CHANGES

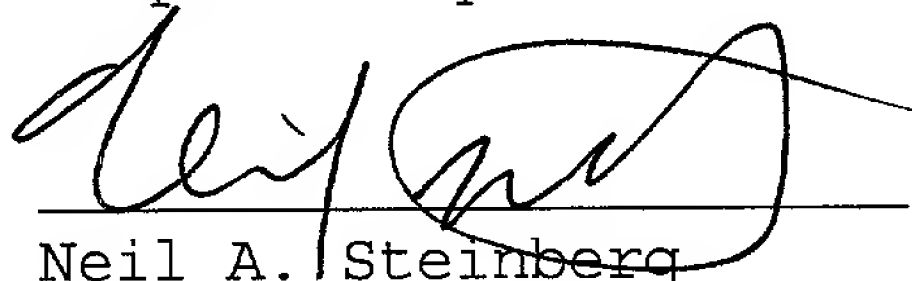
Dear Sir:

Applicants seek to amend Figure 10 to more fully reflect the discussion in the specification, specifically, page 55, line 12-16 and page 58, lines 13-23. Attached is a photocopy of Figure 10 with the proposed changes indicated in red. No new matter has been added.

Applicants respectfully request approval of the proposed changes. A new Figure 10 which incorporates the changes is also attached to hereto.

Respectfully submitted,

Date: April 10, 2000


Neil A. Steinberg
Reg. No. 34,735
650-944-7772

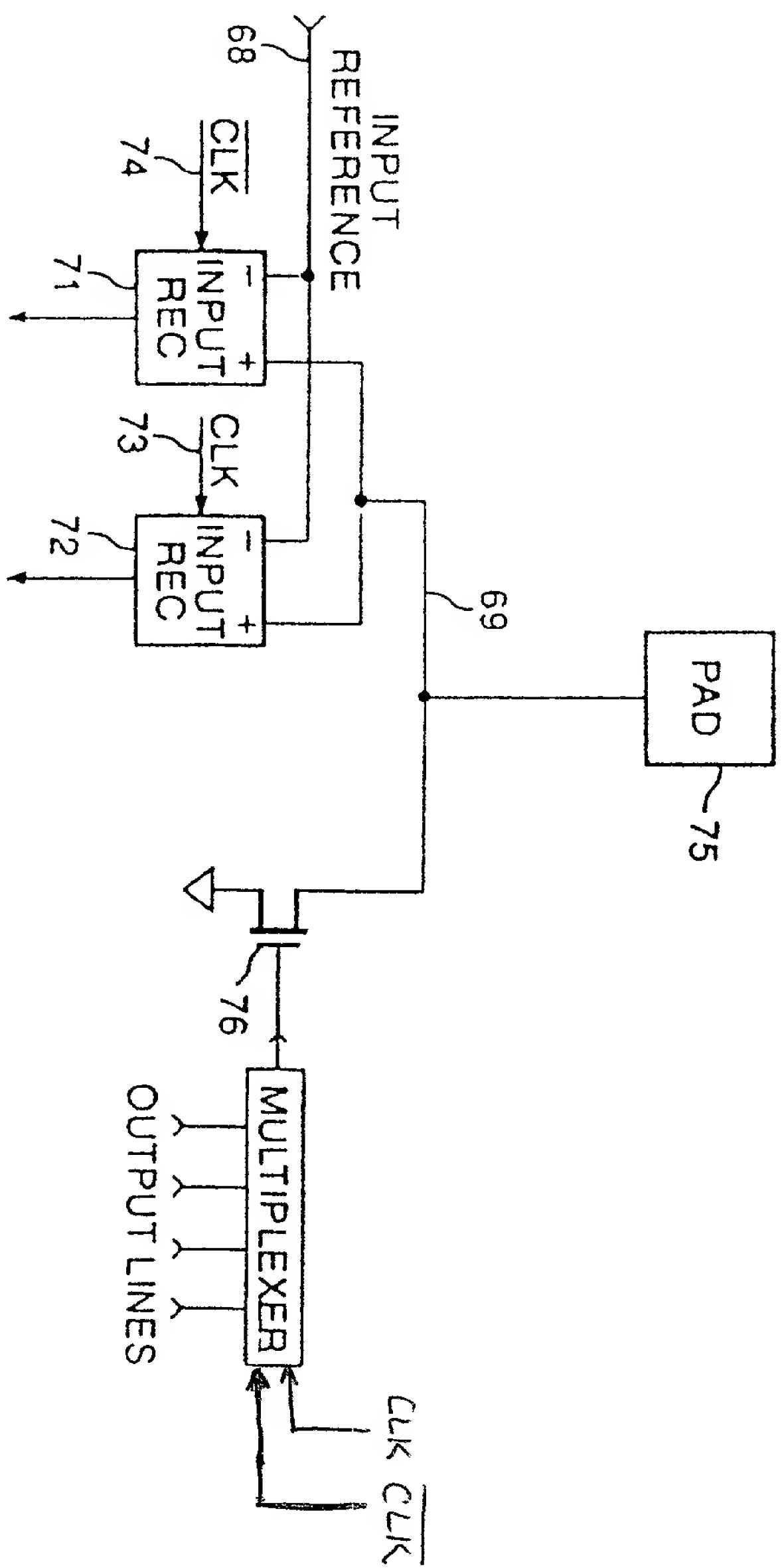


FIG. 10

73305.P001

UNITED STATES PATENT APPLICATION FOR

INTEGRATED CIRCUIT I/O USING A HIGH

PERFORMANCE BUS INTERFACE

Inventor:

Michael Farmwald

Mark Horowitz

Prepared by:

BROWN & BAIN
600 Hansen Way
Suite 100
Palo Alto, California 94306
(415) 856-9411

I hereby certify that this correspondence is being deposited with the United States Postal Service as Express Mail (Label No. RB317101180) in an envelope addressed to: Commissioner of Patents and Trademarks, Washington, D.C. 20231.

on: April 18, 1990

(Date of Deposit)

Tricia Rues 4/18/90
(Signature) (Reg. No.) (Date)

Integrated Circuit I/O Using A
High Performance Bus Interface

FIELD OF THE INVENTION

An integrated circuit bus interface for computer and video systems is described which allows high speed transfer of blocks of data, particularly to and from memory devices, with reduced power consumption and increased system reliability. A new method of physically implementing the bus architecture is also described.

BACKGROUND OF THE INVENTION

Semiconductor computer memories have traditionally been designed and structured to use one memory device for each bit, or small group of bits, of any individual computer word, where the word size is governed by the choice of computer. Typical word sizes range from 4 to 64 bits. Each memory device typically is connected in parallel to a series of address lines and connected to one of a series of data lines. When the computer seeks to read from or write to a specific memory location, an address is put on the address lines and some or all of the memory devices are activated using a separate device select line for each needed device. One or more devices may be connected to each data line but typically only a small number of data lines are connected to

a single memory device. Thus data line 0 is connected to device(s) 0, data line 1 is connected to device(s) 1, and so on. Data is thus accessed or provided in parallel for each memory read or write operation. For the system to operate properly, every single memory bit in every memory device must operate dependably and correctly.

To understand the concept of the present invention, it is helpful to review the architecture of conventional memory devices. Internal to nearly all types of memory devices (including the most widely used Dynamic Random Access Memory (DRAM), Static RAM (SRAM) and Read Only Memory (ROM) devices), a large number of bits are accessed in parallel each time the system carries out a memory access cycle. However, only a small percentage of accessed bits which are available internally each time the memory device is cycled ever make it across the device boundary to the external world.

Referring to Fig. 1, all modern DRAM, SRAM and ROM designs have internal architectures with row (word) lines and column (bit) lines to allow the memory cells to tile a two dimensional area. One bit of data is stored at the intersection of each word and bit line. When a particular word line is enabled, all of the corresponding data bits are transferred onto the bit lines. Some prior art DRAMs take advantage of this organization to reduce the number of pins needed to transmit the address. The address of a given memory

cell is split into two addresses, row and column, each of which can be multiplexed over a bus only half as wide as the memory cell address of the prior art would have required.

5 COMPARISON WITH PRIOR ART

Prior art memory systems have attempted to solve the problem of high speed access to memory with limited success.

10 U.S. Patent No. 3,821,715 (Hoff et. al.), was issued to Intel Corporation for the earliest 4-bit micro-processor. That patent describes a bus connecting a single central processing unit (CPU) with multiple RAMs and ROMs. That bus multiplexes addresses and data over a 4-bit wide bus and uses point-to-point control signals to select particular RAMs or ROMs. The access time is fixed and only a single processing element is permitted. There is no block-mode type of operation, and most important, not all of the interface signals between the devices are bused (the ROM and RAM control lines and the RAM select lines are point-to-point).

15 In U.S. Patent No. 4,315,308 (Jackson), a bus connecting a single CPU to a bus interface unit is described. The invention uses multiplexed address, data, and control information over a single 16-bit wide bus. Block-mode operations are defined, with the length of the block sent as part of the control sequence. In addition, variable access-time operations using a "stretch" cycle signal are provided. There are no

multiple processing elements and no capability for multiple outstanding requests, and again, not all of the interface signals are bused.

In U.S. Patent No. 4,449,207 (Kung, et. al.), a DRAM is described which multiplexes address and data on an internal bus. The external interface to this DRAM is conventional, with separate control, address and data connections.

In U.S. Patent Nos. 4,764,846 and 4,706,166 (Go), a 3-D package arrangement of stacked die with connections along a single edge is described. Such packages are difficult to use because of the point-to-point wiring required to interconnect conventional memory devices with processing elements. Both patents describe complex schemes for solving these problems. No attempt is made to solve the problem by changing the interface.

In U.S. Patent No. 3,969,706 (Proebsting, et. al.), the current state-of-the-art DRAM interface is described. The address is two-way multiplexed, and there are separate pins for data and control (RAS, CAS, WE, CS). The number of pins grows with the size of the DRAM, and many of the connections must be made point-to-point in a memory system using such DRAMs.

There are many backplane buses described in the prior art, but not in the combination described or having the features of this invention. Many backplane buses multiplex addresses and data on a single bus (e.g., the NU bus). ELXSI and others have implemented split-transaction buses (U.S. Patent No. 4,595,923

and 4,481,625 (Roberts)). ELXSI has also implemented a relatively low-voltage-swing current-mode ECL driver (approximately 1 V swing). Address-space registers are implemented on most backplane buses, as is some form of block mode operation.

Nearly all modern backplane buses implement some type of arbitration scheme, but the arbitration scheme used in this invention differs from each of these. U.S. Patent Nos. 4,837,682 (Culler), 4,818,985 (Ikeda), 4,779,089 (Theus) and 4,745,548 (Blahut) describe prior art schemes. All involve either log N extra signals, (Theus, Blahut), where N is the number of potential bus requestors, or additional delay to get control of the bus (Ikeda, Culler). None of the buses described in patents or other literature use only bused connections. All contain some point-to-point connections on the backplane. None of the other aspects of this invention such as power reduction by fetching each data block from a single device or compact and low-cost 3-D packaging even apply to backplane buses.

The clocking scheme used in this invention has not been used before and in fact would be difficult to implement in backplane buses due to the signal degradation caused by connector stubs. U.S. Patent No. 4,247,817 (Heller) describes a clocking scheme using two clock lines, but relies on ramp-shaped clock signals in contrast to the normal rise-time signals used in the present invention.

10
15
20
25
30
35
40
45
50
55
60
65
70
75
80
85
90
95
100
105
110
115
120
125
130
135
140
145
150
155
160
165
170
175
180
185
190
195
200
205
210
215
220
225
230
235
240
245
250
255
260
265
270
275
280
285
290
295
300
305
310
315
320
325
330
335
340
345
350
355
360
365
370
375
380
385
390
395
400
405
410
415
420
425
430
435
440
445
450
455
460
465
470
475
480
485
490
495
500
505
510
515
520
525
530
535
540
545
550
555
560
565
570
575
580
585
590
595
600
605
610
615
620
625
630
635
640
645
650
655
660
665
670
675
680
685
690
695
700
705
710
715
720
725
730
735
740
745
750
755
760
765
770
775
780
785
790
795
800
805
810
815
820
825
830
835
840
845
850
855
860
865
870
875
880
885
890
895
900
905
910
915
920
925
930
935
940
945
950
955
960
965
970
975
980
985
990
995

In U.S. Patent No. 4,646,279 (Voss), a video RAM is described which implements a parallel-load, serial-out shift register on the output of a DRAM. This generally allows greatly improved bandwidth (and has been extended to 2, 4 and greater width shift-out paths.) The rest of the interfaces to the DRAM (RAS, CAS, multiplexed address, etc.) remain the same as for conventional DRAMS.

One object of the present invention is to use a new bus interface built into semiconductor devices to support high-speed access to large blocks of data from a single memory device by an external user of the data, such as a microprocessor, in an efficient and cost-effective manner.

Another object of this invention is to provide a clocking scheme to permit high speed clock signals to be sent along the bus with minimal clock skew between devices.

Another object of this invention is to allow mapping out defective memory devices or portions of memory devices.

Another object of this invention is to provide a method for distinguishing otherwise identical devices by assigning a unique identifier to each device.

Yet another object of this invention is to provide a method for transferring address, data and control information over a relatively narrow bus and to provide a method of bus arbitration when multiple devices seek to use the bus simultaneously.

Another object of this invention is to provide a method of distributing a high-speed memory cache within the DRAM chips of a memory system which is much more effective than previous cache methods.

5 Another object of this invention is to provide devices, especially DRAMs, suitable for use with the bus architecture of the invention.

SUMMARY OF INVENTION

10 The present invention includes a memory subsystem comprising at least two semiconductor devices, including at least one memory device, connected in parallel to a bus, where the bus includes a plurality of bus lines for carrying substantially all address, data and control information needed by said memory
15 devices, where the control information includes device-select information and the bus has substantially fewer bus lines than the number of bits in a single address, and the bus carries device-select information without the need for separate device-select lines connected directly to individual devices.

20 Referring to Fig. 2, a standard DRAM 13, 14, ROM (or SRAM) 12, microprocessor CPU 11, I/O device, disk controller or other special purpose device such as a high speed switch is modified to use a wholly bus-based interface rather than the
25 prior art combination of point-to-point and bus-based wiring used with conventional versions of these devices. The new bus

includes clock signals, power and multiplexed address, data and control signals. In a preferred implementation, 8 bus data lines and an AddressValid bus line carry address, data and control information for memory addresses up to 40 bits wide. Persons skilled in the art will recognize that 16 bus data lines or other numbers of bus data lines can be used to implement the teaching of this invention. The new bus is used to connect elements such as memory, peripheral, switch and processing units.

In the system of this invention, DRAMs and other devices receive address and control information over the bus and transmit or receive requested data over the same bus. Each memory device contains only a single bus interface with no other signal pins. Other devices that may be included in the system can connect to the bus and other non-bus lines, such as input/output lines. The bus supports large data block transfers and split transactions to allow a user to achieve high bus utilization. This ability to rapidly read or write a large block of data to one single device at a time is an important advantage of this invention.

The DRAMs that connect to this bus differ from conventional DRAMs in a number of ways. Registers are provided which may store control information, device identification, device-type and other information appropriate for the chip such as the address range for each independent portion of the device. New bus interface circuits must be added and the internals of

prior art DRAM devices need to be modified so they can provide and accept data to and from the bus at the peak data rate of the bus. This requires changes to the column access circuitry in the DRAM, with only a minimal increase in die size. A circuit is provided to generate a low skew internal device clock for devices on the bus, and other circuits provide for demultiplexing input and multiplexing output signals.

High bus bandwidth is achieved by running the bus at a very high clock rate (hundreds of MHz). This high clock rate is made possible by the constrained environment of the bus. The bus lines are controlled-impedance, doubly-terminated lines. For a data rate of 500 MHz, the maximum bus propagation time is less than 1 ns (the physical bus length is about 10 cm). In addition, because of the packaging used, the pitch of the pins can be very close to the pitch of the pads. The loading on the bus resulting from the individual devices is very small. In a preferred implementation, this generally allows stub capacitances of 1-2 pF and inductances of 0.5 - 2 nH. Each device 15, 16, 17, shown in Figure 3, only has pins on one side and these pins connect directly to the bus 18. A transceiver device 19 can be included to interface multiple units to a higher order bus through pins 20.

A primary result of the architecture of this invention is to increase the bandwidth of DRAM access. The invention also

reduces manufacturing and production costs, power consumption, and increases packing density and system reliability.

BRIEF DESCRIPTION OF THE DRAWINGS

5 Figure 1 is a diagram which illustrates the basic 2-D organization of memory devices.

Figure 2 is a schematic block diagram which illustrates the parallel connection of all bus lines and the serial Reset line to each device in the system.

10 Figure 3 is a perspective view of a system of the invention which illustrates the 3-D packaging of semiconductor devices on the primary bus.

Figure 4 shows the format of a request packet.

15 Figure 5 shows the format of a retry response from a slave.

Figure 6 shows the bus cycles after a request packet collision occurs on the bus and how arbitration is handled.

20 Figure 7 shows the timing whereby signals from two devices can overlap temporarily and drive the bus at the same time.

Figure 8 shows the connection and timing between bus clocks and devices on the bus.

Figure 9 is a perspective view showing how transceivers can be used to connect a number of bus units to a transceiver

bus. Figure 10 is a block and schematic diagram of input/output circuitry used to connect devices to the bus.

Figure 11 is a schematic diagram of a clocked sense-amplifier used as a bus input receiver.

Figure 12 is a block diagram showing how the internal device clock is generated from two bus clock signals using a set of adjustable delay lines.

Figure 13 is a timing diagram showing the relationship of signals in the block diagram of Figure 12.

Figure 14 is timing diagram of a preferred means of implementing the reset procedure of this invention.

Figure 15 is a diagram illustrating the general organization of a 4 Mbit DRAM divided into 8 subarrays.

DETAILED DESCRIPTION

The present invention is designed to provide a high speed, multiplexed bus for communication between processing devices and memory devices and to provide devices adapted for use in the bus system. The invention can also be used to connect processing devices and other devices, such as I/O interfaces or disk controllers, with or without memory devices on the bus. The bus consists of a relatively small number of lines connected in parallel to each device on the bus. The bus carries substantially all address, data and control information needed by devices for communication with other devices on the bus. In many

systems using the present invention, the bus carries almost every signal between every device in the entire system. There is no need for separate device-select lines since device-select information for each device on the bus is carried over the bus.

5 There is no need for separate address and data lines because address and data information can be sent over the same lines. Using the organization described herein, very large addresses (40 bits in the preferred implementation) and large data blocks (1024 bytes) can be sent over a small number of bus lines (8 plus one control line in the preferred implementation).

10
15
20
25
0954543 "041000
Virtually all of the signals needed by a computer system can be sent over the bus. Persons skilled in the art recognize that certain devices, such as CPUs, may be connected to other signal lines and possibly to independent buses, for example a bus to an independent cache memory, in addition to the bus of this invention. Certain devices, for example cross-point switches, could be connected to multiple, independent buses of this invention. In the preferred implementation, memory devices are provided that have no connections other than the bus connections described herein and CPUs are provided that use the bus of this invention as the principal, if not exclusive, connection to memory and to other devices on the bus.

All modern DRAM, SRAM and ROM designs have internal architectures with row (word) and column (bit) lines to efficiently tile a 2-D area. Referring to Fig. 1, one bit of

data is stored at the intersection of each word line 5 and bit line 6. When a particular word line is enabled, all of the corresponding data bits are transferred onto the bit lines. This data, about 4000 bits at a time in a 4 MBit DRAM, is then loaded into column sense amplifiers 3 and held for use by the I/O circuits.

In the invention presented here, the data from the sense amplifiers is enabled 32 bits at a time onto an internal device bus running at approximately 125 MHz. This internal device bus moves the data to the periphery of the devices where the data is multiplexed into an 8-bit wide external bus interface, running at approximately 500 MHz.

The bus architecture of this invention connects master or bus controller devices, such as CPUs, Direct Memory Access devices (DMAs) or Floating Point Units (FPUs), and slave devices, such as DRAM, SRAM or ROM memory devices. A slave device responds to control signals; a master sends control signals. Persons skilled in the art realize that some devices may behave as both master and slave at various times, depending on the mode of operation and the state of the system. For example, a memory device will typically have only slave functions, while a DMA controller, disk controller or CPU may include both slave and master functions. Many other semiconductor devices, including I/O devices, disk controllers, or other special purpose devices

such as high speed switches can be modified for use with the bus of this invention.

Each semiconductor device contains a set of internal registers, preferably including a device identification (device ID) register, a device-type descriptor register, control registers and other registers containing other information relevant to that type of device. In a preferred implementation, semiconductor devices connected to the bus contain registers which specify the memory addresses contained within that device and access-time registers which store a set of one or more delay times at which the device can or should be available to send or receive data.

Most of these registers can be modified and preferably are set as part of an initialization sequence that occurs when the system is powered up or reset. During the initialization sequence each device on the bus is assigned a unique device ID number, which is stored in the device ID register. A bus master can then use these device ID numbers to access and set appropriate registers in other devices, including access-time registers, control registers, and memory registers, to configure the system. Each slave may have one or several access-time registers (four in a preferred embodiment). In a preferred embodiment, one access-time register in each slave is permanently or semi-permanently programmed with a fixed value to facilitate

certain control functions. A preferred implementation of an initialization sequence is described below in more detail.

All information sent between master devices and slave devices is sent over the external bus, which, for example, may be 8 bits wide. This is accomplished by defining a protocol whereby a master device, such as a microprocessor, seizes exclusive control of the external bus (i.e., becomes the bus master) and initiates a bus transaction by sending a request packet (a sequence of bytes comprising address and control information) to one or more slave devices on the bus. An address can consist of 16 to 40 or more bits according to the teachings of this invention. Each slave on the bus must decode the request packet to see if that slave needs to respond to the packet. The slave that the packet is directed to must then begin any internal processes needed to carry out the requested bus transaction at the requested time. The requesting master may also need to transact certain internal processes before the bus transaction begins. After a specified access time the slave(s) respond by returning one or more bytes (8 bits) of data or by storing information made available from the bus. More than one access time can be provided to allow different types of responses to occur at different times.

A request packet and the corresponding bus access are separated by a selected number of bus cycles, allowing the bus to be used in the intervening bus cycles by the same or other

masters for additional requests or brief bus accesses. Thus multiple, independent accesses are permitted, allowing maximum utilization of the bus for transfer of short blocks of data. Transfers of long blocks of data use the bus efficiently even without overlap because the overhead due to bus address, control and access times is small compared to the total time to request and transfer the block.

Device Address Mapping

Another unique aspect of this invention is that each memory device is a complete, independent memory subsystem with all the functionality of a prior art memory board in a conventional backplane-bus computer system. Individual memory devices may contain a single memory section or may be subdivided into more than one discrete memory section. Memory devices preferably include memory address registers for each discrete memory section. A failed memory device (or even a subsection of a device) can be "mapped out" with only the loss of a small fraction of the memory, maintaining essentially full system capability. Mapping out bad devices can be accomplished in two ways, both compatible with this invention.

The preferred method uses address registers in each memory device (or independent discrete portion thereof) to store information which defines the range of bus addresses to which this memory device will respond. This is similar to prior art

schemes used in memory boards in conventional backplane bus systems. The address registers can include a single pointer, usually pointing to a block of known size, a pointer and a fixed or variable block size value or two pointers, one pointing to the beginning and one to the end (or to the "top" and "bottom") of each memory block. By appropriate settings of the address registers, a series of functional memory devices or discrete memory sections can be made to respond to a contiguous range of addresses, giving the system access to a contiguous block of good memory, limited primarily by the number of good devices connected to the bus. A block of memory in a first memory device or memory section can be assigned a certain range of addresses, then a block of memory in a next memory device or memory section can be assigned addresses starting with an address one higher (or lower, depending on the memory structure) than the last address of the previous block.

Preferred devices for use in this invention include device-type register information specifying the type of chip, including how much memory is available in what configuration on that device. A master can perform an appropriate memory test, such as reading and writing each memory cell in one or more selected orders, to test proper functioning of each accessible discrete portion of memory (based in part on information like device ID number and device-type) and write address values (up to 40 bits in the preferred embodiment, 10^{12} bytes), preferably

contiguous, into device address-space registers. Non-functional or impaired memory sections can be assigned a special address value which the system can interpret to avoid using that memory.

The second approach puts the burden of avoiding the bad devices on the system master or masters. CPUs and DMA controllers typically have some sort of translation look-aside buffers (TLBs) which map virtual to physical (bus) addresses. With relatively simple software, the TLBs can be programmed to use only working memory (data structures describing functional memories are easily generated). For masters which don't contain TLBs (for example, a video display generator), a small, simple RAM can be used to map a contiguous range of addresses onto the addresses of the functional memory devices.

Either scheme works and permits a system to have a significant percentage of non-functional devices and still continue to operate with the memory which remains. This means that systems built with this invention will have much improved reliability over existing systems, including the ability to build systems with almost no field failures.

Bus

The preferred bus architecture of this invention comprises 11 signals: BusData[0:7]; AddrValid; Clk1 and Clk2; plus an input reference level and power and ground lines connected in parallel to each device. Signals are driven onto

the bus during conventional bus cycles. The notation
"Signal[i:j]" refers to a specific range of signals or lines, for
example, BusData[0:7] means BusData0, BusData1, . . ., BusData7.
The bus lines for BusData[0:7] signals form a byte-wide,
5 multiplexed data/address/control bus. AddrValid is used to
indicate when the bus is holding a valid address request, and
instructs a slave to decode the bus data as an address and, if
the address is included on that slave, to handle the pending
request. The two clocks together provide a synchronized, high
10 speed clock for all the devices on the bus. In addition to the
bused signals, there is one other line (ResetIn, ResetOut)
connecting each device in series for use during initialization to
assign every device in the system a unique device ID number
(described below in detail).

15 To facilitate the extremely high data rate of this
external bus relative to the gate delays of the internal logic,
the bus cycles are grouped into pairs of even/odd cycles. Note
that all devices connected to a bus should preferably use the
same even/odd labeling of bus cycles and preferably should begin
20 operations on even cycles. This is enforced by the clocking
scheme.

Protocol and Bus Operation

25 The bus uses a relatively simple, synchronous, split-
transaction, block-oriented protocol for bus transactions. One

of the goals of the system is to keep the intelligence concentrated in the masters, thus keeping the slaves as simple as possible (since there are typically many more slaves than masters). To reduce the complexity of the slaves, a slave should preferably respond to a request in a specified time, sufficient to allow the slave to begin or possibly complete a device-internal phase including any internal actions that must precede the subsequent bus access phase. The time for this bus access phase is known to all devices on the bus - each master being responsible for making sure that the bus will be free when the bus access begins. Thus the slaves never worry about arbitrating for the bus. This approach eliminates arbitration in single master systems, and also makes the slave-bus interface simpler.

In a preferred implementation of the invention, to initiate a bus transfer over the bus, a master sends out a request packet, a contiguous series of bytes containing address and control information. It is preferable to use a request packet containing an even number of bytes and also preferable to start each packet on an even bus cycle.

The device-select function is handled using the bus data lines. AddrValid is driven, which instructs all slaves to decode the request packet address, determine whether they contain the requested address, and if they do, provide the data back to the master (in the case of a read request) or accept data from the master (in the case of a write request) in a data block

transfer. A master can also select a specific device by transmitting a device ID number in a request packet. In a preferred implementation, a special device ID number is chosen to indicate that the packet should be interpreted by all devices on the bus. This allows a master to broadcast a message, for example to set a selected control register of all devices with the same value.

The data block transfer occurs later at a time specified in the request packet control information, preferably beginning on an even cycle. A device begins a data block transfer almost immediately with a device-internal phase as the device initiates certain functions, such as setting up memory addressing, before the bus access phase begins. The time after which a data block is driven onto the bus lines is selected from values stored in slave access-time registers. The timing of data for reads and writes is preferably the same; the only difference is which device drives the bus. For reads, the slave drives the bus and the master latches the values from the bus. For writes the master drives the bus and the selected slave latches the values from the bus.

In a preferred implementation of this invention shown in Figure 4, a request packet 22 contains 6 bytes of data -- 4.5 address bytes and 1.5 control bytes. Each request packet uses all nine bits of the multiplexed data/address lines (AddrValid 23 + BusData[0:7] 24) for all six bytes of the request packet.

Setting 23 AddrValid = 1 in an otherwise unused even cycle indicates the start of an request packet (control information). In a valid request packet, AddrValid 27 must be 0 in the last byte. Asserting this signal in the last byte invalidates the request packet. This is used for the collision detection and arbitration logic (described below). Bytes 25-26 contain the first 35 address bits, Address[0:35]. The last byte contains AddrValid 27 (the invalidation switch) and 28, the remaining address bits, Address[36:39], and BlockSize[0:3] (control information).

The first byte contains two 4 bit fields containing control information, AccessType[0:3], an op code (operation code) which, for example, specifies the type of access, and Master[0:3], a position reserved for the master sending the packet to include its master ID number. Only master numbers 1 through 15 are allowed - master number 0 is reserved for special system commands. Any packet with Master[0:3] = 0 is an invalid or special packet and is treated accordingly.

The AccessType field specifies whether the requested operation is a read or write and the type of access, for example, whether it is to the control registers or other parts of the device, such as memory. In a preferred implementation, AccessType[0] is a Read/Write switch: if it is a 1, then the operation calls for a read from the slave (the slave to read the requested memory block and drive the memory contents onto the

bus); if it is a 0, the operation calls for a write into the
slave (the slave to read data from the bus and write it to
memory). AccessType[1:3] provides up to 8 different access types
for a slave. AccessType[1:2] preferably indicates the timing of
the response, which is stored in an access-time register,
AccessRegN. The choice of access-time register can be selected
directly by having a certain op code select that register, or
indirectly by having a slave respond to selected op codes with
pre-selected access times (see table below). The remaining bit,
AccessType[3] may be used to send additional information about
the request to the slaves.

One special type of access is control register access,
which involves addressing a selected register in a selected
slave. In the preferred implementation of this invention,
AccessType[1:3] equal to zero indicates a control register
request and the address field of the packet indicates the desired
control register. For example, the most significant two bytes
can be the device ID number (specifying which slave is being
addressed) and the least significant three bytes can specify a
register address and may also represent or include data to be
loaded into that control register. Control register accesses are
used to initialize the access-time registers, so it is preferable
to use a fixed response time which can be preprogrammed or even
hard wired, for example the value in AccessReg0, preferably 8

cycles. Control register access can also be used to initialize or modify other registers, including address registers.

The method of this invention provides for access mode control specifically for the DRAMs. One such access mode determines whether the access is page mode or normal RAS access. In normal mode (in conventional DRAMS and in this invention), the DRAM column sense amps or latches have been precharged to a value intermediate between logical 0 and 1. This precharging allows access to a row in the RAM to begin as soon as the access request for either inputs (writes) or outputs (reads) is received and allows the column sense amps to sense data quickly. In page mode (both conventional and in this invention), the DRAM holds the data in the column sense amps or latches from the previous read or write operation. If a subsequent request to access data is directed to the same row, the DRAM does not need to wait for the data to be sensed (it has been sensed already) and access time for this data is much shorter than the normal access time. Page mode generally allows much faster access to data but to a smaller block of data (equal to the number of sense amps). However, if the requested data is not in the selected row, the access time is longer than the normal access time, since the request must wait for the RAM to precharge before the normal mode access can start. Two access-time registers in each DRAM preferably contain the access times to be used for normal and for page-mode accesses, respectively.

The access mode also determines whether the DRAM should precharge the sense amplifiers or should save the contents of the sense amps for a subsequent page mode access. Typical settings are "precharge after normal access" and "save after page mode access" but "precharge after page mode access" or "save after normal access" are allowed, selectable modes of operation. The DRAM can also be set to precharge the sense amps if they are not accessed for a selected period of time.

In page mode, the data stored in the DRAM sense amplifiers may be accessed within much less time than it takes to read out data in normal mode (~10-20 nS vs. 40-100 nS). This data may be kept available for long periods. However, if these sense amps (and hence bit lines) are not precharged after an access, a subsequent access to a different memory word (row) will suffer a precharge time penalty of about 40-100 nS because the sense amps must precharge before latching in a new value.

The contents of the sense amps thus may be held and used as a cache, allowing faster, repetitive access to small blocks of data. DRAM-based page-mode caches have been attempted in the prior art using conventional DRAM organizations but they are not very effective because several chips are required per computer word. Such a conventional page-mode cache contains many bits (for example, 32 chips x 4Kbits) but has very few independent storage entries. In other words, at any given point in time the sense amps hold only a few different blocks or memory

"locales" (a single block of 4K words, in the example above).

Simulations have shown that upwards of 100 blocks are required to achieve high hit rates (>90% of requests find the requested data already in cache memory) regardless of the size of each block.

5 See, for example, Anant Agarwal, et. al., "An Analytic Cache Model," *ACM Transactions on Computer Systems*, Vol. 7(2), pp. 184-215 (May 1989).

10 The organization of memory in the present invention
allows each DRAM to hold one or more (4 for 4MBit DRAMS)
separately- addressed and independent blocks of data. A personal
computer or workstation with 100 such DRAMS (i.e. 400 blocks or
locales) can achieve extremely high, very repeatable hit rates
15 (98-99% on average) as compared to the lower (50-80%), widely
varying hit rates using DRAMS organized in the conventional
fashion. Further, because of the time penalty associated with
the deferred precharge on a "miss" of the page-mode cache, the
conventional DRAM-based page-mode cache generally has been found
to work less well than no cache at all.

For DRAM slave access, the access types are preferably used in the following way:

<u>AccessType[1:3]</u>	<u>Use</u>	<u>AccessTime</u>
0	Control Register Access	Fixed, 8[AccessReg0]
1	Unused	Fixed, 8[AccessReg0]
2-3	Unused	AccessReg1
4-5	Page Mode DRAM access	AccessReg2
6-7	Normal DRAM access	AccessReg3

Persons skilled in the art will recognize that a series of available bits could be designated as switches for controlling these access modes. For example:

AccessType[2] = page mode/normal switch

AccessType[3] = precharge/save-data switch

BlockSize[0:3] specifies the size of the data block transfer. If BlockSize[0] is 0, the remaining bits are the binary representation of the block size (0-7). If BlockSize[0] is 1, then the remaining bits give the block size as a binary power of 2, from 8 to 1024. A zero-length block can be interpreted as a special command, for example, to refresh a DRAM without returning any data, or to change the DRAM from page mode to normal access mode or vice-versa.

	<u>BlockSize[0:2]</u>	<u>Number of Bytes in Block</u>
	0-7	0-7 respectively
5	8	8
	9	16
	10	32
	11	64
	12	128
	13	256
10	14	512
	15	1024

Persons skilled in the art will recognize that other block size encoding schemes or values can be used.

15 In most cases, a slave will respond at the selected access time by reading or writing data from or to the bus over bus lines BusData[0:7] and AddrValid will be at logical 0. In a preferred embodiment, substantially each memory access will involve only a single memory device, that is, a single block will
20 be read from or written to a single memory device.

Retry Format

In some cases, a slave may not be able to respond correctly to a request, e.g., for a read or write. In such a
25 situation, the slave should return an error message, sometimes called a N(o)ACK(nowledge) or retry message. The retry message can include information about the condition requiring a retry, but this increases system requirements for circuitry in both slave and masters. A simple message indicating only that an
30 error has occurred allows for a less complex slave, and the

master can take whatever action is needed to understand and correct the cause of the error.

For example, under certain conditions a slave might not be able to supply the requested data. During a page-mode access, the DRAM selected must be in page mode and the requested address must match the address of the data held in the sense amps or latches. Each DRAM can check for this match during a page-mode access. If no match is found, the DRAM begins precharging and returns a retry message to the master during the first cycle of the data block (the rest of the returned block is ignored). The master then must wait for the precharge time (which is set to accommodate the type of slave in question, stored in a special register, PreChargeReg), and then resend the request as a normal DRAM access (AccessType = 6 or 7).

In the preferred form of the present invention, a slave signals a retry by driving AddrValid true at the time the slave was supposed to begin reading or writing data. A master which expected to write to that slave must monitor AddrValid during the write and take corrective action if it detects a retry message.

Figure 5 illustrates the format of a retry message 28 which is useful for read requests, consisting of 23 AddrValid=1 with Master[0:3] = 0 in the first (even) cycle. Note that AddrValid is normally 0 for data block transfers and that there is no master 0 (only 1 through 15 are allowed). All DRAMs and masters can easily recognize such a packet as an invalid request packet,

and therefore a retry message. In this type of bus transaction all of the fields except for Master[0:3] and AddrValid 23 may be used as information fields, although in the implementation described, the contents are undefined. Persons skilled in the art recognize that another method of signifying a retry message is to add a DataInvalid line and signal to the bus. This signal could be asserted in the case of a NACK.

Bus Arbitration

In the case of a single master, there are by definition no arbitration problems. The master sends request packets and keeps track of periods when the bus will be busy in response to that packet. The master can schedule multiple requests so that the corresponding data block transfers do not overlap.

The bus architecture of this invention is also useful in configurations with multiple masters. When two or more masters are on the same bus, each master must keep track of all the pending transactions, so each master knows when it can send a request packet and access the corresponding data block transfer. Situations will arise, however, where two or more masters send a request packet at about the same time and the multiple requests must be detected, then sorted out by some sort of bus arbitration.

There are many ways for each master to keep track of when the bus is and will be busy. A simple method is for each

master to maintain a bus-busy data structure, for example by maintaining two pointers, one to indicate the earliest point in the future when the bus will be busy and the other to indicate the earliest point in the future when the bus will be free, that is, the end of the latest pending data block transfer. Using this information, each master can determine whether and when there is enough time to send a request packet (as described above under Protocol) before the bus becomes busy with another data block transfer and whether the corresponding data block transfer will interfere with pending bus transactions. Thus each master must read every request packet and update its bus-busy data structure to maintain information about when the bus is and will be free.

With two or more masters on the bus, masters will occasionally transmit independent request packets during the same bus cycle. Those multiple requests will collide as each such master drives the bus simultaneously with different information, resulting in scrambled request information and neither desired data block transfer. In a preferred form of the invention, each device on the bus seeking to write a logical 1 on a BusData or AddrValid line drives that line with a current sufficient to sustain a voltage greater than or equal to the high-logic value for the system. Devices do not drive lines that should have a logical 0; those lines are simply held at a voltage corresponding to a low-logic value. Each master tests the voltage on at least

some, preferably all, bus data and the AddrValid lines so the master can detect a logical '1' where the expected level is '0' on a line that it does not drive during a given bus cycle but another master does drive.

5 Another way to detect collisions is to select one or more bus lines for collision signalling. Each master sending a request drives that line or lines and monitors the selected lines for more than the normal drive current (or a logical value of ">1"), indicating requests by more than one master. Persons skilled in the art will recognize that this can be implemented with a protocol involving BusData and AddrValid lines or could be implemented using an additional bus line.

10 In the preferred form of this invention, each master detects collisions by monitoring lines which it does not drive to see if another master is driving those lines. Referring to Fig. 4, the first byte of the request packet includes the number of each master attempting to use the bus (Master[0:3]). If two masters send packet requests starting at the same point in time, the master numbers will be logical "or"ed together by at least those masters, and thus one or both of the masters, by monitoring the data on the bus and comparing what it sent, can detect a collision. For instance if requests by masters number 2 (0010) and 5 (0101) collide, the bus will be driven with the value Master[0:3]=7 (0010 + 0101 = 0111). Master number 5 will detect that the signal Master[2] = 1 and master 2 will detect that

Master[1] and Master[3] = 1, telling both masters that a collision has occurred. Another example is masters 2 and 11, for which the bus will be driven with the value Master[0:3]=11 (0010 + 1011 = 1011), and although master 11 can't readily detect this collision, master 2 can. When any collision is detected, each master detecting a collision drives the value of AddrValid 27 in byte 5 of the request packet 22 to 1, which is detected by all masters, including master 11 in the second example above, and forces a bus arbitration cycle, described below.

Another collision condition may arise where master A sends a request packet in cycle 0 and master B tries to send a request packet starting in cycle 2 of the first request packet, thereby overlapping the first request packet. This will occur from time to time because the bus operates at high speeds, thus the logic in a second-initiating master may not be fast enough to detect a request initiated by a first master in cycle 0 and to react fast enough by delaying its own request. Master B eventually notices that it wasn't supposed to try to send a request packet (and consequently almost surely destroyed the address that master A was trying to send), and, as in the example above of a simultaneous collision, drives a 1 on AddrValid during byte 5 of the first request packet 27 forcing an arbitration. The logic in the preferred implementation is fast enough that a master should detect a request packet by another master by cycle

3 of the first request packet, so no master is likely to attempt to send a potentially colliding request packet later than cycle 2.

Slave devices not need to detect a collision directly, but they must wait to do anything irrecoverable until the last byte (byte 5) is read to ensure that the packet is valid. A request packet with Master[0:3] equal to 0 (a retry signal) is ignored and does not cause a collision. The subsequent bytes of such a packet are ignored.

To begin arbitration after a collision, the masters wait a preselected number of cycles after the aborted request packet (4 cycles in a preferred implementation), then use the next free cycle to arbitrate for the bus (the next available even cycle in the preferred implementation). Each colliding master signals to all other colliding masters that it seeks to send a request packet, a priority is assigned to each of the colliding masters, then each master is allowed to make its request in the order of that priority.

Figure 6 illustrates one preferred way of implementing this arbitration. Each colliding master signals its intent to send a request packet by driving a single BusData line during a single bus cycle corresponding to its assigned master number (1-15 in the present example). During two-byte arbitration cycle 29, byte 0 is allocated to requests 1-7 from masters 1-7, respectively, (bit 0 is not used) and byte 1 is allocated to

requests 8-15 from masters 8-15, respectively. At least one device and preferably each colliding master reads the values on the bus during the arbitration cycles to determine and store which masters desire to use the bus. Persons skilled in the art will recognize that a single byte can be allocated for arbitration requests if the system includes more bus lines than masters. More than 15 masters can be accommodated by using additional bus cycles.

A fixed priority scheme (preferably using the master numbers, selecting lowest numbers first) is then used to prioritize, then sequence the requests in a bus arbitration queue which is maintained by at least one device. These requests are queued by each master in the bus-busy data structure and no further requests are allowed until the bus arbitration queue is cleared. Persons skilled in the art will recognize that other priority schemes can be used, including assigning priority according to the physical location of each master.

System Configuration/Reset

In the bus-based system of this invention, a mechanism is provided to give each device on the bus a unique device identifier (device ID) after power-up or under other conditions as desired or needed by the system. A master can then use this device ID to access a specific device, particularly to set or modify registers of the specified device, including the control

and address registers. In the preferred embodiment, one master is assigned to carry out the entire system configuration process. The master provides a series of unique device ID numbers for each unique device connected to the bus system. In the preferred
5 embodiment, each device connected to the bus contains a special device-type register which specifies the type of device, for instance CPU, 4 MBit memory, 64 MBit memory or disk controller. The configuration master should check each device, determine the device type and set appropriate control registers, including
10 access-time registers. The configuration master should check each memory device and set all appropriate memory address registers.

One means to set up unique device ID numbers is to have each device to select a device ID in sequence and store the value in an internal device ID register. For example, a master can
15 pass sequential device ID numbers through shift registers in each of a series of devices, or pass a token from device to device whereby the device with the token reads in device ID information from another line or lines. In a preferred embodiment, device ID
20 numbers are assigned to devices according to their physical relationship, for instance, their order along the bus.

In a preferred embodiment of this invention, the device ID setting is accomplished using a pair of pins on each device, ResetIn and ResetOut. These pins handle normal logic signals and
25 are used only during device ID configuration. On each rising

edge of the clock, each device copies ResetIn (an input) into a four-stage reset shift register. The output of the reset shift register is connected to ResetOut, which in turn connects to ResetIn for the next sequentially connected device.

5 Substantially all devices on the bus are thereby daisy-chained together. A first reset signal, for example, while ResetIn at a device is a logical 1, or when a selected bit of the reset shift register goes from zero to non-zero, causes the device to hard reset, for example by clearing all internal registers and
10 resetting all state machines. A second reset signal, for example, the falling edge of ResetIn combined with changeable values on the external bus, causes that device to latch the contents of the external bus into the internal device ID register (Device[0:7]).

15 To reset all devices on a bus, a master sets the ResetIn line of the first device to a "1" for long enough to ensure that all devices on the bus have been reset (4 cycles times the number of devices -- note that the maximum number of devices on the preferred bus configuration is 256 (8 bits), so
20 that 1024 cycles is always enough time to reset all devices.) Then ResetIn is dropped to "0" and the BusData lines are driven with the first followed by successive device ID numbers, changing after every 4 clock pulses. Successive devices set those device ID numbers into the corresponding device ID register as the
25 falling edge of ResetIn propagates through the shift registers of

the daisy-chained devices. Figure 14 shows ResetIn at a first device going low while a master drives a first device ID onto the bus data lines BusData[0:3]. The first device then latches in that first device ID. After four clock cycles, the master changes BusData[0:3] to the next device ID number and ResetOut at the first device goes low, which pulls ResetIn for the next daisy-chained device low, allowing the next device to latch in the next device ID number from BusData[0:3]. In the preferred embodiment, one master is assigned device ID 0 and it is the responsibility of that master to control the ResetIn line and to drive successive device ID numbers onto the bus at the appropriate times. In the preferred embodiment, each device waits two clock cycles after ResetIn goes low before latching in a device ID number from BusData[0:3].

Persons skilled in the art recognize that longer device ID numbers could be distributed to devices by having each device read in multiple bytes from the bus and latch the values into the device ID register. Persons skilled in the art also recognize that there are alternative ways of getting device ID numbers to unique devices. For instance, a series of sequential numbers could be clocked along the ResetIn line and at a certain time each device could be instructed to latch the current reset shift register value into the device ID register.

The configuration master should choose and set an access time in each access-time register in each slave to a

period sufficiently long to allow the slave to perform an actual, desired memory access. For example, for a normal DRAM access, this time must be longer than the row address strobe (RAS) access time. If this condition is not met, the slave may not deliver the correct data. The value stored in a slave access-time register is preferably one-half the number of bus cycles for which the slave device should wait before using the bus in response to a request. Thus an access time value of '1' would indicate that the slave should not access the bus until at least two cycles after the last byte of the request packet has been received. The value of AccessReg0 is preferably fixed at 8 (cycles) to facilitate access to control registers.

The bus architecture of this invention can include more than one master device. The reset or initialization sequence should also include a determination of whether there are multiple masters on the bus, and if so to assign unique master ID numbers to each. Persons skilled in the art will recognize that there are many ways of doing this. For instance, the master could poll each device to determine what type of device it is, for example, by reading a special register then, for each master device, write the next available master ID number into a special register.

ECC

Error detection and correction ("ECC") methods well known in the art can be implemented in this system. ECC

information typically is calculated for a block of data at the time that block of data is first written into memory. The data block usually has an integral binary size, e.g. 256 bits, and the ECC information uses significantly fewer bits. A potential problem arises in that each binary data block in prior art schemes typically is stored with the ECC bits appended, resulting in a block size that is not an integral binary power.

In a preferred embodiment of this invention, ECC information is stored separately from the corresponding data, which can then be stored in blocks having integral binary size. ECC information and corresponding data can be stored, for example, in separate DRAM devices. Data can be read without ECC using a single request packet, but to write or read error-corrected data requires two request packets, one for the data and a second for the corresponding ECC information. ECC information may not always be stored permanently and in some situations the ECC information may be available without sending a request packet or without a bus data block transfer.

In a preferred embodiment, a standard data block size can be selected for use with ECC, and the ECC method will determine the required number of bits of information in a corresponding ECC block. RAMs containing ECC information can be programmed to store an access time that is equal to: (1) the access time of the normal RAM (containing data) plus the time to access a standard data block (for corrected data) minus the time

to send a request packet (6 bytes); or' (2) the access time of a normal RAM minus the time to access a standard ECC block minus the time to send a request packet. To read a data block and the corresponding ECC block, the master simply issues a request for the data immediately followed by a request for the ECC block. The ECC RAM will wait for the selected access time then drive its data onto the bus right after (in case (1) above)) the data RAM has finished driving out the data block. Persons skilled in the art will recognize that the access time described in case (2) above can be used to drive ECC data before the data is driven onto the bus lines and will recognize that writing data can be done by analogy with the method described for a read. Persons skilled in the art will also recognize the adjustments that must be made in the bus-busy structure and the request packet arbitration methods of this invention in order to accommodate these paired ECC requests.

Since this system is quite flexible, the system designer can choose the size of the data blocks and the number of ECC bits using the memory devices of this invention. Note that the data stream on the bus can be interpreted in various ways. For instance the sequence can be 2^n data bytes followed by 2^n ECC bytes (or vice versa), or the sequence can be 2^k iterations of 8 data bytes plus 1 ECC byte. Other information, such as information used by a directory-based cache coherence scheme, can also be managed this way. See, for example, Anant Agarwal, et

al., "Scaleable Directory Schemes for Cache Consistency," 15th
International Symposium on Computer Architecture, June 1988, pp.
280-289. Those skilled in the art will recognize alternative
methods of implementing ECC schemes that are within the teachings
of this invention.

Low Power 3-D Packaging

Another major advantage of this invention is that it
drastically reduces the memory system power consumption. Nearly
all the power consumed by a prior art DRAM is dissipated in
performing row access. By using a single row access in a single
RAM to supply all the bits for a block request (compared to a
row-access in each of multiple RAMs in conventional memory
systems) the power per bit can be made very small. Since the
power dissipated by memory devices using this invention is
significantly reduced, the devices potentially can be placed much
closer together than with conventional designs.

The bus architecture of this invention makes possible
an innovative 3-D packaging technology. By using a narrow,
multiplexed (time-shared) bus, the pin count for an arbitrarily
large memory device can be kept quite small - on the order of 20
pins. Moreover, this pin count can be kept constant from one
generation of DRAM density to the next. The low power
dissipation allows each package to be smaller, with narrower pin
itches (spacing between the IC pins). With current surface

mount technology supporting pin pitches as low as 20 mils, all off-device connections can be implemented on a single edge of the memory device. Semiconductor die useful in this invention preferably have connections or pads along one edge of the die which can then be wired or otherwise connected to the package pins with wires having similar lengths. This geometry also allows for very short leads, preferably with an effective lead length of less than 4 mm. Furthermore, this invention uses only bused interconnections, i.e., each pad on each device is connected by the bus to the corresponding pad of each other device.

The use of a low pin count and an edge-connected bus permits a simple 3-D package, whereby the devices are stacked and the bus is connected along a single edge of the stack. The fact that all of the signals are bused is important for the implementation of a simple 3-D structure. Without this, the complexity of the "backplane" would be too difficult to make cost effectively with current technology. The individual devices in a stack of the present invention can be packed quite tightly because of the low power dissipated by the entire memory system, permitting the devices to be stacked bumper-to-bumper or top to bottom. Conventional plastic-injection molded small outline (SO) packages can be used with a pitch of about 2.5 mm (100 mils), but the ultimate limit would be the device die thickness, which is

about an order of magnitude smaller, 0.2-0.5 mm using current wafer technology.

Bus Electrical Description

5 By using devices with very low power dissipation and close physical packing, the bus can be made quite short, which in turn allows for short propagation times and high data rates. The bus of a preferred embodiment of the present invention consists of a set of resistor-terminated controlled impedance transmission lines which can operate up to a data rate of 500 MHz (2 ns cycles). The characteristics of the transmission lines are strongly affected by the loading caused by the DRAMs (or other slaves) mounted on the bus. These devices add lumped capacitance to the lines which both lowers the impedance of the lines and decreases the transmission speed. In the loaded environment, the bus impedance is likely to be on the order of 25 ohms and the propagation velocity about $c/4$ (c = the speed of light), or 7.5 cm/ns. To operate at a 2 ns data rate, the transit time on the bus should preferably be kept under 1 ns, to leave 1 ns for the setup and hold time of the input receivers (described below) plus clock skew. Thus the bus lines must be kept quite short, under about 8 cm for maximum performance. Lower performance systems may have much longer lines, e.g. a 4 ns bus may have 24 cm lines (3 ns transit time, 1 ns setup and hold time).

In the preferred embodiment, the bus uses current source drivers. Each output must be able to sink 50 mA, which provides an output swing of about 500 mV or more. In the preferred embodiment of this invention, the bus is active low. The unasserted state (the high value) is preferably considered a logical zero, and the asserted value (low state) is therefore a logical 1. Those skilled in the art understand that the method of this invention can also be implemented using the opposite logical relation to voltage. The value of the unasserted state is set by the voltage on the termination resistors, and should be high enough to allow the outputs to act as current sources, while being as low as possible to reduce power dissipation. These constraints may yield a termination voltage about 2V above ground in the preferred implementation. Current source drivers cause the output voltage to be proportional to the sum of the sources driving the bus.

Referring to Fig.7, although there is no stable condition where two devices drive the bus at the same time, conditions can arise because of propagation delay on the wires where one device, A 41, can start driving its part of the bus 44 while the bus is still being driven by another device, B 42 (already asserting a logical 1 on the bus). In a system using current drivers, when B 42 is driving the bus (before time 46), the value at points 44 and 45 is logical 1. If B 42 switches off at time 46 just when A 41 switches on, the additional drive by

device A 41 causes the voltage at the output 44 of A 41 to drop briefly below the normal value. The voltage returns to its normal value at time 47 when the effect of device B 42 turning off is felt. The voltage at point 45 goes to logical 0 when device B 42 turns off, then drops at time 47 when the effect of device A 41 turning on is felt. Since the logical 1 driven by current from device A 41 is propagated irrespective of the previous value on the bus, the value on the bus is guaranteed to settle after one time of flight (t_f) delay, that is, the time it takes a signal to propagate from one end of the bus to the other. If a voltage drive was used (as in ECL wired-ORing), a logical 1 on the bus (from device B 42 being previously driven) would prevent the transition put out by device A 41 being felt at the most remote part of the system, e.g., device 43, until the turnoff waveform from device B 42 reached device A 41 plus one time of flight delay, giving a worst case settling time of twice the time of flight delay.

Clocking

Clocking a high speed bus accurately without introducing error due to propagation delays can be implemented by having each device monitor two bus clock signals and then derive internally a device clock, the true system clock. The bus clock information can be sent on one or two lines to provide a mechanism for each bused device to generate an internal device

clock with zero skew relative to all the other device clocks.

Referring to Figure 8, in the preferred implementation, a bus clock generator 50 at one end of the bus propagates an early bus clock signal in one direction along the bus, for example on line 53 from left to right, to the far end of the bus. The same clock signal then is passed through the direct connection shown to a second line 54, and returns as a late bus clock signal along the bus from the far end to the origin, propagating from right to left. A single bus clock line can be used if it is left unterminated at the far end of the bus, allowing the early bus clock signal to reflect back along the same line as a late bus clock signal.

Figure 8b illustrates how each device 51, 52 receives each of the two bus clock signals at a different time (because of propagation delay along the wires), with constant midpoint in time between the two bus clocks along the bus. At each device 51, 52, the rising edge 55 of Clock1 53 is followed by the rising edge 56 of Clock2 54. Similarly, the falling edge 57 of Clock1 53 is followed by the falling edge 58 of Clock2 54. This waveform relationship is observed at all other devices along the bus. Devices which are closer to the clock generator have a greater separation between Clock1 and Clock2 relative to devices farther from the generator because of the longer time required for each clock pulse to traverse the bus and return along line 54, but the midpoint in time 59, 60 between corresponding rising

or falling edges is fixed because, for any given device, the length of each clock line between the far end of the bus and that device is equal. Each device must sample the two bus clocks and generate its own internal device clock at the midpoint of the two.

Clock distribution problems can be further reduced by using a bus clock and device clock rate equal to the bus cycle data rate divided by two, that is, the bus clock period is twice the bus cycle period. Thus a 500 MHz bus preferably uses a 250 MHz clock rate. This reduction in frequency provides two benefits. First it makes all signals on the bus have the same worst case data rates -- data on a 500 MHz bus can only change every 2 ns. Second, clocking at half the bus cycle data rate makes the labeling of the odd and even bus cycles trivial, for example, by defining even cycles to be those when the internal device clock is 0 and odd cycles when the internal device clock is 1.

Multiple Buses

The limitation on bus length described above restricts the total number of devices that can be placed on a single bus. Using 2.5 mm spacing between devices, a single 8 cm bus will hold about 32 devices. Persons skilled in the art will recognize certain applications of the present invention wherein the overall data rate on the bus is adequate but memory or processing

requirements necessitate a much larger number of devices (many more than 32). Larger systems can easily be built using the teachings of this invention by using one or more memory subsystems, designated primary bus units, each of which consists of two or more devices, typically 32 or close to the maximum allowed by bus design requirements, connected to a transceiver device.

Referring to Figure 9, each primary bus unit can be mounted on a single circuit board 66, sometimes called a memory stick. Each transceiver device 19 in turn connects to a transceiver bus 65, similar or identical in electrical and other respects to the primary bus 18 described at length above. In a preferred implementation, all masters are situated on the transceiver bus so there are no transceiver delays between masters and all memory devices are on primary bus units so that all memory accesses experience an equivalent transceiver delay, but persons skilled in the art will recognize how to implement systems which have masters on more than one bus unit and memory devices on the transceiver bus as well as on primary bus units. In general, each teaching of this invention which refers to a memory device can be practiced using a transceiver device and one or more memory devices on an attached primary bus unit. Other devices, generically referred to as peripheral devices, including disk controllers, video controllers or I/O devices can also be attached to either the transceiver bus or a primary bus unit, as

desired. Persons skilled in the art will recognize how to use a single primary bus unit or multiple primary bus units as needed with a transceiver bus in certain system designs.

5 The transceivers are quite simple in function. They detect request packets on the transceiver bus and transmit them to their primary bus unit. If the request packet calls for a write to a device on a transceiver's primary bus unit, that transceiver keeps track of the access time and block size and forwards all data from the transceiver bus to the primary bus unit during that time. The transceivers also watch their primary bus unit, forwarding any data that occurs there to the transceiver bus. The high speed of the buses means that the transceivers will need to be pipelined, and will require an additional one or two cycle delay for data to pass through the transceiver in either direction. Access times stored in masters on the transceiver bus must be increased to account for transceiver delay but access times stored in slaves on a primary bus unit should not be modified.

10
15
20
25

Persons skilled in the art will recognize that a more sophisticated transceiver can control transmissions to and from primary bus units. An additional control line, TrncvrRW can be bused to all devices on the transceiver bus, using that line in conjunction with the AddrValid line to indicate to all devices on the transceiver bus that the information on the data lines is: 1) a request packet, 2) valid data to a slave, 3) valid data from a

slave, or 4) invalid data (or idle bus). Using this extra control line obviates the need for the transceivers to keep track of when data needs to be forwarded from its primary bus to the transceiver bus - all transceivers send all data from their primary bus to the transceiver bus whenever the control signal indicates condition 2) above. In a preferred implementation of this invention, if AddrValid and TrncvrRW are both low, there is no bus activity and the transceivers should remain in an idle state. A controller sending a request packet will drive AddrValid high, indicating to all devices on the transceiver bus that a request packet is being sent which each transceiver should forward to its primary bus unit. Each controller seeking to write to a slave should drive both AddrValid and TrncvrRW high, indicating valid data for a slave is present on the data lines. Each transceiver device will then transmit all data from the transceiver bus lines to each primary bus unit. Any controller expecting to receive information from a slave should also drive the TrncvrRW line high, but not drive AddrValid, thereby indicating to each transceiver to transmit any data coming from any slave on its primary local bus to the transceiver bus. A still more sophisticated transceiver would recognize signals addressed to or coming from its primary bus unit and transmit signals only at requested times.

An example of the physical mounting of the transceivers is shown in Figure 9. One important feature of this physical

arrangement is to integrate the bus of each transceiver 19 with the original bus of DRAMs or other devices 15, 16, 17 on the primary bus unit 66. The transceivers 19 have pins on two sides, and are preferably mounted flat on the primary bus unit with a first set of pins connected to primary bus 18. A second set of transceiver pins 20, preferably orthogonal to the first set of pins, are oriented to allow the transceiver 19 to be attached to the transceiver bus 65 in much the same way as the DRAMs were attached to the primary bus unit. The transceiver bus can be generally planar and in a different plane, preferably orthogonal to the plane of each primary bus unit. The transceiver bus can also be generally circular with primary bus units mounted perpendicular and tangential to the transceiver bus.

Using this two level scheme allows one to easily build a system that contains over 500 slaves (16 buses of 32 DRAMs each). Persons skilled in the art can modify the device ID scheme described above to accommodate more than 256 devices, for example by using a longer device ID or by using additional registers to hold some of the device ID. This scheme can be extended in yet a third dimension to make a second-order transceiver bus, connecting multiple transceiver buses by aligning transceiver bus units parallel to and on top of each other and busing corresponding signal lines through a suitable transceiver. Using such a second-order transceiver bus, one

could connect many thousands of slave devices into what is effectively a single bus.

Device Interface

5 The device interface to the high-speed bus can be divided into three main parts. The first part is the electrical interface. This part includes the input receivers, bus drivers and clock generation circuitry. The second part contains the address comparison circuitry and timing registers. This part
0 takes the input request packet and determines if the request is for this device, and if it is, starts the internal access and delivers the data to the pins at the correct time. The final part, specifically for memory devices such as DRAMs, is the DRAM column access path. This part needs to provide bandwidth into
5 and out of the DRAM sense amps greater than the bandwidth provided by conventional DRAMs. The implementation of the electrical interface and DRAM column access path are described in more detail in the following sections. Persons skilled in the art recognize how to modify prior-art address comparison
10 circuitry and prior-art register circuitry in order to practice the present invention.

Electrical Interface - Input/Output Circuitry

25 A block diagram of the preferred input/output circuit for address/data/control lines is shown in Figure 10. This

circuitry is particularly well-suited for use in DRAM devices but it can be used or modified by one skilled in the art for use in other devices connected to the bus of this invention. It consists of a set of input receivers 71, 72 and output driver 76 connected to input/output line 69 and pad 75 and circuitry to use the internal clock 73 and internal clock complement 74 to drive the input interface. The clocked input receivers take advantage of the synchronous nature of the bus. To further reduce the performance requirements for device input receivers, each device pin, and thus each bus line, is connected to two clocked receivers, one to sample the even cycle inputs, the other to sample the odd cycle inputs. By thus de-multiplexing the input 70 at the pin, each clocked amplifier is given a full 2 ns cycle to amplify the bus low-voltage-swing signal into a full value CMOS logic signal. Persons skilled in the art will recognize that additional clocked input receivers can be used within the teachings of this invention. For example, four input receivers could be connected to each device pin and clocked by a modified internal device clock to transfer sequential bits from the bus to internal device circuits, allowing still higher external bus speeds or still longer settling times to amplify the bus low-voltage-swing signal into a full value CMOS logic signal.

The output drivers are quite simple, and consist of a single NMOS pulldown transistor 76. This transistor is sized so that under worst case conditions it can still sink the 50 mA

required by the bus. For 0.8 micron CMOS technology, the transistor will need to be about 200 microns long. Overall bus performance can be improved by using feedback techniques to control output transistor current so that the current through the device is roughly 50 mA under all operating conditions, although this is not absolutely necessary for proper bus operation. An example of one of many methods known to persons skilled in the art for using feedback techniques to control current is described in Hans Schumacher, et al., "CMOS Subnanosecond True-ECL Output Buffer," *J. Solid State Circuits*, Vol. 25 (1), pp. 150-154 (Feb. 1990). Controlling this current improves performance and reduces power dissipation. This output driver which can be operated at 500 MHz, can in turn be controlled by a suitable multiplexer with two or more (preferably four) inputs connected to other internal chip circuitry, all of which can be designed according to well known prior art.

The input receivers of every slave must be able to operate during every cycle to determine whether the signal on the bus is a valid request packet. This requirement leads to a number of constraints on the input circuitry. In addition to requiring small acquisition and resolution delays, the circuits must take little or no DC power, little AC power and inject very little current back into the input or reference lines. The standard clocked DRAM sense amp shown in Figure 11 satisfies all these requirements except the need for low input currents. When

this sense amp goes from sense to sample, the capacitance of the internal nodes 83 and 84 in Figure 11 is discharged through the reference line 68 and input 69, respectively. This particular current is small, but the sum of such currents from all the inputs into the reference lines summed over all devices can be reasonably large.

The fact that the sign of the current depends upon on the previous received data makes matters worse. One way to solve this problem is to divide the sample period into two phases.

During the first phase, the inputs are shorted to a buffered version of the reference level (which may have an offset). During the second phase, the inputs are connected to the true inputs. This scheme does not remove the input current completely, since the input must still charge nodes 83 and 84 from the reference value to the current input value, but it does reduce the total charge required by about a factor of 10 (requiring only a 0.25V change rather than a 2.5V change). Persons skilled in the art will recognize that many other methods can be used to provide a clocked amplifier that will operate on very low input currents.

One important part of the input/output circuitry generates an internal device clock based on early and late bus clocks. Controlling clock skew (the difference in clock timing between devices) is important in a system running with 2 ns cycles, thus the internal device clock is generated so the input

sampler and the output driver operate as close in time as possible to midway between the two bus clocks.

A block diagram of the internal device clock generating circuit is shown in Figure 12 and the corresponding timing diagram in Figure 13. The basic idea behind this circuit is relatively simple. A DC amplifier 102 is used to convert the small-swing bus clock into a full-swing CMOS signal. This signal is then fed into a variable delay line 103. The output of delay line 103 feeds three additional delay lines: 104 having a fixed delay; 105 having the same fixed delay plus a second variable delay; and 106 having the same fixed delay plus one half of the second variable delay. The outputs 107, 108 of the delay lines 104 and 105 drive clocked input receivers 101 and 111 connected to early and late bus clock inputs 100 and 110, respectively. These input receivers 101 and 111 have the same design as the receivers described above and shown in Fig. 11. Variable delay lines 103 and 105 are adjusted via feedback lines 116, 115 so that input receivers 101 and 111 sample the bus clocks just as they transition. Delay lines 103 and 105 are adjusted so that the falling edge 120 of output 107 precedes the falling edge 121 of the early bus clock, Clock1 53, by an amount of time 128 equal to the delay in input sampler 101. Delay line 108 is adjusted in the same way so that falling edge 122 precedes the falling edge 123 of late bus clock, Clock2 54, by the delay 128 in input sampler 111.

Since the outputs 107 and 108 are synchronized with the two bus clocks and the output 73 of the last delay line 106 is midway between outputs 107 and 108, that is, output 73 follows output 107 by the same amount of time 129 that output 73 precedes output 108, output 73 provides an internal device clock midway between the bus clocks. The falling edge 124 of internal device clock 73 precedes the time of actual input sampling 125 by one sampler delay. Note that this circuit organization automatically balances the delay in substantially all device input receivers 71 and 72 (Fig. 10), since outputs 107 and 108 are adjusted so the bus clocks are sampled by input receivers 101 and 111 just as the bus clocks transition.

In the preferred embodiment, two sets of these delay lines are used, one to generate the true value of the internal device clock 73, and the other to generate the complement 74 without adding any inverter delay. The dual circuit allows generation of truly complementary clocks, with extremely small skew. The complement internal device clock is used to clock the 'even' input receivers to sample at time 127, while the true internal device clock is used to clock the 'odd' input receivers to sample at time 125. The true and complement internal device clocks are also used to select which data is driven to the output drivers. The gate delay between the internal device clock and output circuits driving the bus is slightly greater than the corresponding delay for the input circuits, which means that the

new data always will be driven on the bus slightly after the old data has been sampled.

DRAM Column Access Modification

5 A block diagram of a conventional 4 MBit DRAM 130 is shown in Figure 15. The DRAM memory array is divided into a number of subarrays 150-157, for example, 8. Each subarray is divided into arrays 148, 149 of memory cells. Row address selection is performed by decoders 146. A column decoder 147A, 10 147B, including column sense amps on either side of the decoder, runs through the core of each subarray. These column sense amps can be set to precharge or latch the most-recently stored value, as described in detail above. Internal I/O lines connect each set of sense-amps, as gated by corresponding column decoders, to 15 input and output circuitry connected ultimately to the device pins. These internal I/O lines are used to drive the data from the selected bit lines to the data pins (some of pins 131-145), or to take the data from the pins and write the selected bit lines. Such a column access path organized by prior art 20 constraints does not have sufficient bandwidth to interface with a high speed bus. The method of this invention does not require changing the overall method used for column access, but does change implementation details. Many of these details have been implemented selectively in certain fast memory devices, but never 25 in conjunction with the bus architecture of this invention.

Running the internal I/O lines in the conventional way at high bus cycle rates is not possible. In the preferred method, several (preferably 4) bytes are read or written during each cycle and the column access path is modified to run at a lower rate (the inverse of the number of bytes accessed per cycle, preferably 1/4 of the bus cycle rate). Three different techniques are used to provide the additional internal I/O lines required and to supply data to memory cells at this rate. First, the number of I/O bit lines in each subarray running through the column decoder 147 is increased, for example, to 16, eight for each of the two columns of column sense amps and the column decoder selects one set of columns from the "top" half 148 of subarray 150 and one set of columns from the "bottom" half 149 during each cycle, where the column decoder selects one column sense amp per I/O bit line. Second, each column I/O line is divided into two halves, carrying data independently over separate internal I/O lines from the left half 147A and right half 147B of each subarray (dividing each subarray into quadrants) and the column decoder selects sense amps from each right and left half of the subarray, doubling the number of bits available at each cycle. Thus each column decode selection turns on n column sense amps, where n equals four (top left and right, bottom left and right quadrants) times the number of I/O lines in the bus to each subarray quadrant (8 lines each \times 4=32 lines in the preferred implementation). Finally, during each RAS cycle,

two different subarrays, e.g. 157 and 153, are accessed. This doubles again the available number of I/O lines containing data. Taken together, these changes increase the internal I/O bandwidth by at least a factor of 8. Four internal buses are used to route these internal I/O lines. Increasing the number of I/O lines and then splitting them in the middle greatly reduces the capacitance of each internal I/O line which in turn reduces the column access time, increasing the column access bandwidth even further.

The multiple, gated input receivers described above allow high speed input from the device pins onto the internal I/O lines and ultimately into memory. The multiplexed output driver described above is used to keep up with the data flow available using these techniques. Control means are provided to select whether information at the device pins should be treated as an address, and therefore to be decoded, or input or output data to be driven onto or read from the internal I/O lines.

Each subarray can access 32 bits per cycle, 16 bits from the left subarray and 16 from the right subarray. With 8 I/O lines per sense-amplifier column and accessing two subarrays at a time, the DRAM can provide 64 bits per cycle. This extra I/O bandwidth is not needed for reads (and is probably not used), but may be needed for writes. Availability of write bandwidth is a more difficult problem than read bandwidth because over-writing a value in a sense-amplifier may be a slow operation, depending on how the sense amplifier is connected to the bit line. The

extra set of internal I/O lines provides some bandwidth margin for write operations.

Persons skilled in the art will recognize that many variations of the teachings of this invention can be practiced that still fall within the claims of this invention which follow.

CLAIMS

What is claimed is:

1. A memory subsystem comprising
two memory devices connected in parallel to a bus,
said bus including a plurality of bus lines for
5 carrying substantially all address, data and control in-
formation needed by said memory devices,
said control information including device-select
information,
said bus containing substantially fewer bus lines than
10 the number of bits in a single address, and
said bus carrying device-select information without the
need for separate device-select lines connected directly to
individual memory devices.
- 15 2. The memory subsystem of claim 1 wherein said bus
contains at least 8 bus lines adapted to carry at least 16
address bits and at least 8 data bits.
- 20 3. The memory subsystem of claim 1 wherein said bus also
includes parallel lines for clock and power.
4. A system comprising
a memory subsystem of claim 1 wherein each bus of said
memory subsystem is connected to its own transceiver device,

a transceiver bus connecting said transceiver devices,
and

a means for transferring information between each of
said buses of said memory subsystems and said transceiver
bus, whereby memory subsystems may be integrated into a
larger system having more memory than an individual memory
subsystem.

5. The system of claim 4 having a plurality of memory
subsystems.

6. The system of claim 4 further comprising a master
device connected to said transceiver bus.

7. The system of claim 6 wherein said master device is
selected from the group consisting of a central processing unit,
a floating point unit and a direct memory access unit.

8. The system of claim 4 further comprising a peripheral
device connected to the transceiver bus, said peripheral device
adapted for connection to other devices not on the bus.

9. The system of claim 8 wherein said peripheral device is
selected from the group consisting of an I/O interface port, a
video controller and a disk controller.

10. The system of claim 5 wherein said transceiver bus is in a different plane than the plane of the bus of each of said memory subsystems.

5

11. The system of claim 5 wherein the bus of each memory subsystem lies substantially in a subsystem bus plane and said transceiver bus lies substantially in a plane orthogonal to said subsystem bus plane.

10

12. The system of claim 4 having at least two transceiver buses, each transceiver bus having a plurality of memory subsystem buses connected through a first transceiver to said transceiver bus,

15

each of said transceiver buses being further connected to a second transceiver adapted to interface to a second-order transceiver bus, whereby each transceiver bus is connected through said second transceiver to form a second-order transceiver bus unit.

20

13. A semiconductor subsystem bus for interconnecting semiconductor devices comprising

a plurality of semiconductor devices connected in parallel to a bus, at least one of said semiconductor

devices being a memory device or a transceiver device which
in turn is connected to a memory subsystem,

said bus including a plurality of bus lines for
carrying substantially all address, data and control
information needed by said semiconductor devices,

said control information including semiconductor
device-select information,

said bus containing substantially fewer bus lines than
the number of bits in a single address, and

said bus carrying device-select information without the
need for separate device-select lines connected directly to
individual semiconductor devices, and

at least one modifiable register in each of the semi-
conductor devices on said bus, said modifiable registers
being accessible from said bus, whereby the subsystem can be
configured using signals transmitted on said bus.

14. The semiconductor subsystem bus of claim 13 wherein one
type of modifiable register is an access-time register designed
to store a time delay after which a device may take some
specified action on said bus.

15. The semiconductor subsystem bus of claim 13 further
comprising a semiconductor device having at least two access-time
registers and

one of said access-time registers is permanently programmed to contain a fixed value and at least one of said access-time registers can be modified by information carried on said bus.

5

16. The semiconductor subsystem bus of claim 13 further comprising a memory device having at least one discrete memory section and also having a modifiable address register adapted to store memory address information which corresponds to each said discrete memory section.

10
15
20
25
30
35
40
45
50
55
60
65
70
75
80
85
90
95
100

17. The semiconductor subsystem bus of claim 16 wherein said memory address information comprises a pointer to said discrete memory section.

18. The semiconductor subsystem bus of claim 16 wherein said discrete memory section has a top and a bottom and said memory address information comprises pointers to said top and said bottom.

20

19. The semiconductor subsystem bus of claim 16 wherein said memory address information comprises

a pointer to said discrete memory section and

a range value indicating the size of said discrete memory section.

25

10
15
20
25
30
35
40
45
50
55
60
65
70
75
80
85
90
95
100
105
110
115
120
125
130
135
140
145
150
155
160
165
170
175
180
185
190
195
200
205
210
215
220
225
230
235
240
245
250
255
260
265
270
275
280
285
290
295
300
305
310
315
320
325
330
335
340
345
350
355
360
365
370
375
380
385
390
395
400
405
410
415
420
425
430
435
440
445
450
455
460
465
470
475
480
485
490
495
500
505
510
515
520
525
530
535
540
545
550
555
560
565
570
575
580
585
590
595
600
605
610
615
620
625
630
635
640
645
650
655
660
665
670
675
680
685
690
695
700
705
710
715
720
725
730
735
740
745
750
755
760
765
770
775
780
785
790
795
800
805
810
815
820
825
830
835
840
845
850
855
860
865
870
875
880
885
890
895
900
905
910
915
920
925
930
935
940
945
950
955
960
965
970
975
980
985
990
995

20. The semiconductor subsystem bus of claim 16 wherein said address registers of each of said discrete memory sections of each of said memory devices connected to said bus are set to contain memory address information that is different for each discrete memory section and such that the highest memory address in each discrete memory section is one less than the lowest memory address in another discrete memory section,

whereby memory may be organized into one or a small number of contiguous memory blocks.

21. The semiconductor subsystem bus of claim 16 further comprising a means for testing each of said discrete memory sections of each of said memory devices for proper function, and

for each non-functional discrete memory section, a means for setting at least one address register which corresponds to said discrete memory section to indicate that said discrete memory section is non-functional,

for each functional discrete memory section, a means for setting at least one address register which corresponds to said discrete memory section to contain such corresponding address information.

22. The semiconductor subsystem bus of claim 21 wherein said address registers corresponding to said discrete memory

sections are set to provide one contiguous memory block within the subsystem.

5 23. The semiconductor subsystem bus of claim 13 wherein one of said modifiable registers is a device identification register which can be modified to contain a value unique to that semiconductor device.

10 24. The semiconductor subsystem bus of claim 23 wherein said device identification register is set to contain a unique value which is a function of the physical position of that semiconductor device either along said bus or in relationship to other semiconductor devices or said bus.

15 25. A bus subsystem comprising
two semiconductor devices connected in parallel to a bus, wherein one of said semiconductor devices is a master device,
said master device including a means for initiating bus
20 transactions,
said bus including a plurality of bus lines for carrying substantially all address, data and control information needed by said devices,
said control information including device-select
25 information,

said bus containing substantially fewer lines than the number of bits in a single address, and

said bus carrying device-select information without the need for separate device-select lines connected directly to individual devices on said bus, whereby said master device initiates bus transactions which transfer information between said semiconductor devices on said bus.

26. The bus subsystem of claim 25 wherein one of said semiconductor devices is a memory device connected to said bus, said memory device having at least one discrete memory section and also having a modifiable address register adapted to store memory address information which corresponds to each said discrete memory section.

27. The bus subsystem of claim 26 wherein one of said semiconductor devices comprises a transceiver device connected in parallel to said bus and connected in parallel to a memory device on a bus other than said bus.

28. The bus subsystem of claim 26 further including a means for said master device to request said memory device to prepare for a bus transaction by sending a request packet along said bus, said memory device and said master device each having a device-internal means to prepare to begin said bus transaction during a

device-internal phase and further having a bus access means to effect said bus transaction during a bus access phase, said request packet including

5 a sequence of bytes containing address and control information,

said control information including information about the requested bus transaction and about the access time, which corresponds to a number of bus cycles, which needs to intervene before beginning said bus-access phase, and

10 said address information pointing to at least one memory location within one of said discrete memory sections of said memory device.

29. The bus subsystem of claim 28 wherein said memory device includes a means to read said control information and initiate said device-internal means at a time so as to complete said device-internal phase within said access time and begin said bus access phase after said number of bus cycles.

20 30. The bus subsystem of claim 28 wherein said control information comprises an op code.

31. The bus subsystem of claim 30 wherein said memory device includes sense amplifiers adapted to hold a bit of information or to precharge after a selected time and a means to

transfer a data block during a data block transfer either reading data from said memory device or writing data into said memory device, and

wherein said op code instructs said memory device to activate a response means, said response means including a means to

initiate a data block transfer,

select the size of said data block,

select the time to initiate said data block transfer,

access a control register, including reading from or writing to said control register,

precharge said sense amplifiers after each of said data block transfers is complete,

hold a bit of information in each of said sense amplifiers after each of said data block transfers is complete, or

select normal or page-mode access.

32. The bus subsystem of claim 31 wherein said data block transfer comprises a read from or a write to memory within a single memory device.

33. The bus subsystem of claim 28 further comprising a means for said master device to send control information to a specific one of said semiconductor devices on said bus by

including in said request packet a device identification number unique to said semiconductor device.

5 34. The bus subsystem of claim 28 further comprising a means for said master device to send control information to a selected one of said discrete memory portions by including in said request packet a specific memory address.

10 35. The bus subsystem of claim 28 further comprising a means for said master device to send control information to substantially all semiconductor devices on said bus by including in said request packet a special device identification number which is recognized by said semiconductor devices.

15 36. The bus subsystem of claim 28 wherein said control information specifies directly or indirectly the number of bus cycles for said master device and said memory device to wait before beginning said bus access phase.

20 37. The bus subsystem of claim 36 wherein, for a data block transfer, said master device and said memory device use the same access time and same data block size regardless of whether said data block transfer is a read or write operation.

38. The bus subsystem of claim 28 wherein said control information further includes a block-size value that encodes and specifies the size of the block of data to be transferred.

39. The bus subsystem of claim 38 wherein said block-size value is encoded as a linear value for relatively small block sizes values and is encoded as a logarithmic value for relatively larger block sizes.

40. The bus subsystem of claim 38 wherein said block-size value is encoded using four bits, and where the encoded value is

<u>Encoded Value</u>	<u>Block Size (Bytes)</u>
0	0
1	1
2	2
3	3
4	4
5	5
6	6
7	7
8	8
9	16
10	32
11	64
12	128
13	256
14	512
15	1024

41. The bus subsystem of claim 26 wherein said memory device is a DRAM device containing
a plurality of sense amplifiers,

a means to hold said sense amplifiers in an unmodified state after a read or write operation, leaving the device in page mode,

a means to precharge said sense amplifiers and

5 a means for selecting whether to precharge said sense amplifiers or to hold said sense amplifiers in an unmodified state.

10 42. The bus subsystem of claim 28 wherein said request packet comprises an even number of bytes.

15 43. The bus subsystem of claim 28 further including a means for generating and controlling a plurality of bus cycles, during which said bus carries said address, data and control information, and wherein alternate said bus cycles are designated odd cycles and even cycles, respectively, and wherein said request packet begins only on an even cycle.

20 44. The bus subsystem of claim 28 further including a means for generating ECC information corresponding to a block of data and a means for using said ECC information to correct errors in storing or reading said block of data, wherein said ECC information may be stored separately from said block of data.

45. The bus subsystem of claim 44 further comprising at least two of said memory devices wherein said ECC information and said corresponding block of data are stored in a first and a second said memory device, respectively, and said master device includes a means to write or read said block of data with error correction by sending separate ones of said request packets for said ECC information and for said corresponding block of data.

46. A bus subsystem comprising

a memory device and a master device connected in parallel on a bus,

a means for said master device to send a request packet and initiate a bus transaction and

a means for said master device to keep track of current and pending bus transactions,

said bus including a plurality of bus lines for carrying substantially all address, data and control information needed by said memory devices,

said bus containing substantially fewer lines than the number of bits in a single address, and

said bus carrying device-select information without the need for separate device-select lines connected directly to individual devices on said bus, whereby said master device initiates bus transactions which transfer information between devices on said bus and collisions on said bus are

avoided because said master device avoids initiating bus transactions which would conflict with current or pending bus transactions.

5 47. The bus subsystem of claim 46 having at least two of said master devices and including

10 a collision detecting means whereby a first said master device sending a first said request packet can detect a second said master device sending one of said colliding request packets, where one of said said colliding request packet may be sent simultaneous with the initial sending of or overlapping the sending of said first request packet, and

15 an arbitration means whereby said first and said second master devices select a priority order in which each of said master devices will be allowed to access said bus sequentially.

20 48. The bus subsystem of claim 47 wherein each of said master devices has a master ID number and each of said request packets includes a master ID position which is a predetermined number of bits in a predetermined position in said request packet, and wherein said collision detection means comprises

25 a means included in each master device for sending a request packet including said master ID number of said

master device in said master ID position of said request packet and

a means to detect a collision and invoke said arbitration means if any master device detects any other master ID number in said master ID position.

49. The bus subsystem of claim 47 wherein each of said master devices includes

a means for sending a request packet,

a means for driving a selected bus line or lines during at least one selected bus cycle while said request packet is being sent,

a means for monitoring said selected bus line or lines to see if a said master device is sending a colliding request packet and

a means for informing all other master devices that a collision has occurred and for invoking said arbitration means.

50. The bus subsystem of claim 47 wherein each of said master devices includes

a means, when sending a request packet, to drive a selected bus line or lines with a certain current during at least one selected bus cycle,

a means for monitoring said selected bus line or lines for a greater than normal current to see if another master device is driving that line or lines,

5 a means for detecting said greater than normal current, and

a means for informing all said master devices that a collision has occurred and for invoking said arbitration means.

10 51. The bus subsystem of claim 47 wherein said arbitration means comprises

a means for initiating an arbitration cycle,

15 a means for allocating a single bus line to each master device during at least one selected bus cycle relative to the start of said arbitration cycle,

a means for allocating each master device to a single bus line during one of said selected bus cycles if there are more master devices than available bus lines,

20 a means for each of said master devices which sent a colliding request packet to drive said bus line allocated to said master device during said selected bus cycle, and

a means in at least one of said master devices for storing information about which master devices sent a colliding request packet,

whereby said master devices can monitor selected bus lines during said arbitration cycle and identify each said master device which sent a colliding request packet.

5 52. The bus subsystem of claim 47 wherein said arbitration means comprises

a means included in a first one of said master devices which sent colliding request packets for identifying each of said master devices which sent colliding request packets,

10 a means for assigning a priority to each said master device which sent a colliding request packet, and

a means for allowing each said master device which sent a colliding request packet to access the bus sequentially according to that priority.

15 53. The bus subsystem of claim 52 wherein said priority is based on the physical location of each of said master devices.

20 54. The bus subsystem of claim 52 wherein said priority is based on said master ID number of said master devices.

25 55. The bus subsystem of claim 52 wherein each of said master devices includes a means, when sending a colliding request packet, for deciding which master device can send the next request packet in what order or at what time, whereby no master

device may send a new request packet until responses to each pending request packet have been completed or scheduled.

56. A bus subsystem comprising
5 a plurality of semiconductor devices connected in parallel to a bus,
said bus including a plurality of bus lines for carrying substantially all address, data and control information needed by said semiconductor devices,
10 said control information including device-select information,
said bus containing substantially fewer lines than the number of bits in a single address,
said bus carrying said device-select information without the need for separate device-select lines connected
15 directly to individual semiconductor devices,
said semiconductor devices including a reset means having an input and an output, the output of the reset means of one semiconductor device being connected to the input of the reset means of the next semiconductor device in series.
20

57. The bus subsystem of claim 56 further including system reset means comprising

a means for generating a first and a second reset
25 signal,

a means for passing said first reset signal to a first of said semiconductor devices and then to subsequent ones of said semiconductor devices in series and

a means for passing a second reset signal to said first semiconductor device and then to said subsequent semiconductor devices in series,

said bus subsystem including one of said semiconductor devices containing

a device identification register adapted to contain a number unique to said semiconductor device within said bus subsystem,

a device identification register setting means, and
a device reset means for resetting said semiconductor device to some desired, known reset state in response to said first reset signal and for setting said device identification register in response to said second reset signal,

whereby said bus subsystem can be reset to a known reset state with a unique device identification value in said device identification register of each of said semiconductor devices.

58. The bus subsystem of claim 57 wherein said desired, known reset state is where all registers in the semiconductor device are cleared and the state machines are reset.

59. The bus subsystem of claim 57 wherein said device identification register setting means comprises

a means for detecting said second reset signal,

a means for reading a device identification number from said bus lines at a specific time relative to said second reset signal and

a means for storing said device identification number in said device identification register of said semiconductor device.

60. The bus subsystem of claim 57 wherein said second reset signal comprises multiple pulse sequences and wherein said device identification setting means includes

a means for interpreting said pulse sequences as a device identification number and

a means for storing said device identification number in said device identification register of said semiconductor device.

61. The bus subsystem of claim 57 wherein said device reset means comprises an n-stage shift register capable of storing n-bit values, wherein said device reset means interprets a specific value in said shift register as said first reset signal and

interprets a specific value in said shift register as said second reset signal.

62. The bus subsystem of claim 57 wherein one of said semiconductor devices is a master device, said master device including a means for generating said first and said second reset signals.

63. The bus subsystem of claim 57 wherein one of said semiconductor devices is a master device, said master device including

a master ID register,

a means for assigning a master ID number to said master device and

a means for storing said master ID number in said master ID register.

64. The bus subsystem of claim 63 further comprising a second one of said master devices, and a means for a first one of said master devices to assign a master ID number to substantially all other said master devices, whereby said first master device assigns one of said master ID numbers to each of said master devices on said bus subsystem and each said master device stores said assigned master ID number in said master ID register.

65. The bus subsystem of claim 57 wherein one of said semiconductor devices includes a device-type register adapted to contain an identifier characteristic of that type of semiconductor device, and one or more modifiable registers, at least one of which is an access-time register adapted for storing access times.

66. The bus subsystem of claim 65 wherein one of said semiconductor devices is a master device having

a means for selecting a semiconductor device,

a means for reading said device-type register of said selected semiconductor device,

a means for determining the device type of said selected semiconductor device,

a means for determining access-time values appropriate for said selected semiconductor device and for storing said access-time values in said access-time registers of said selected semiconductor device, and

a means for selecting and storing other values appropriate for said selected semiconductor device in corresponding registers of said selected semiconductor device,

whereby said master device can select a semiconductor device, determine what type it is, and set said access-time and other registers to contain appropriate values.

67. The bus subsystem of claim 66 further comprising a memory device having at least one discrete memory section and at least one modifiable address register adapted to store memory address information which corresponds to each of said discrete memory sections, and

said master device further comprising a means for selecting and testing each of said discrete memory sections and a means for storing address information in said address registers corresponding to each of said discrete memory sections, whereby said master device can test all said discrete memory sections and assign unique address values thereto.

68. A bus subsystem comprising

two semiconductor devices connected in parallel to a bus, one of said semiconductor devices being a master device,

said bus including a plurality of bus data lines for carrying substantially all address, data and control information needed by said semiconductor devices,

said control information including device-select information,

said bus containing substantially fewer of said bus data lines than the number of bits in a single address, and

said bus carrying device-select information without the need for separate device-select lines connected directly to individual semiconductor devices,

wherein all of said bus data lines are terminated transmission lines and all of said address, data and control information is carried on said bus data lines as a sequential series of bits in the form of low-voltage-swing signals.

69. The bus subsystem of claim 68 further comprising a semiconductor device including a current-mode driver connected to drive one of said bus data lines.

70. The bus subsystem of claim 69 further comprising a semiconductor device having a means to measure the voltage of said low-voltage-swing signals on a selected one of said bus data lines, whereby said semiconductor device can determine whether zero, one, or more than one of said current-mode drivers are driving said selected bus data line.

71. The bus subsystem of claim 70 further comprising a semiconductor device having

a plurality of input receivers connected to one of said bus data lines, and

a selection means for selecting said input receivers one by one to sense and store, one at a time, the bits of said sequential series of bits.

5 72. The bus subsystem of claim 70 further comprising a semiconductor device having two input receivers connected to one of said bus data lines.

73. A bus subsystem comprising

10 two semiconductor devices connected in parallel to a bus having a first and a second end, said bus including a bus clock line, said bus clock line having first and second ends corresponding to said first and second ends of said bus, respectively,

15 a clock generator connected to said first end of said bus clock line to generate early bus clock signals with a normal rise time, and

20 signal return means at said second end of said bus clock line to return said early bus clock signals to said first end of said bus as corresponding late bus clock signals,

25 whereby each of said early bus clock signals will propagate from said clock generator along said clock line starting from said first end to said second end of said bus and then return at a later time to said first end of said

bus as a corresponding late bus clock signal, whereby each semiconductor device on said bus can detect said early bus clock signals and said corresponding late bus clock signals.

5 74. The bus subsystem of claim 73 further comprising a
first and a second said bus clock line having first and second
ends at said first and said second ends of said bus,
respectively, wherein said signal return means directly connects
said second ends of said first and said second bus clock lines
10 whereby each of said early bus clock signals will propagate from
said clock generator at said first end of said bus along said
first bus clock line to said second end of said bus and then
return on said second bus clock line to said first end of said
bus as one of said corresponding late bus clock signals.

15 75. The bus subsystem of claim 73 wherein said signal
return means comprises said first bus clock line without a line
terminator at said second end thereof whereby each of said early
bus clock signals reaching said second end of said first bus
20 clock line will be reflected back along said first bus clock line
as said corresponding late bus clock signals.

76. The bus subsystem of claim 73 further comprising
a means for operating said bus in bus cycles timed to
have a certain bus cycle frequency and a corresponding bus
cycle period and

5 a means for operating said clock generator with a
period of twice the bus cycle period.

77. The bus subsystem of claim 76 wherein said bus cycle
frequency is greater than approximately 50 MHz and less than or
10 equal to approximately 500 MHz.

78. The bus subsystem of claim 73 further including a
semiconductor device having an internal device clock generating
means to derive the midpoint time between said early and
15 corresponding late bus clock signals and to generate an internal
device clock synchronized to said midpoint time.

79. The bus subsystem of claim 73 further including a
semiconductor device having a low-skew clock generator circuit
20 comprising

a first delay line having an input, an output and a
basic delay and means for synchronizing the output of said
first delay line with said early bus clock signal,

a second delay line having said basic delay plus a
25 variable delay, said second delay line having an output and

a means for synchronizing the output of said second delay line with said late bus clock signal, and

a third delay line having a third delay and a means to set said third delay midway between the delays of said first and second delay lines, said third delay line having an output which provides an internal device clock signal synchronized to a time halfway between said early and said late bus clock signals.

80. The bus subsystem of claim 73 wherein said early and said late bus clock signals are low-voltage-swing signals that transition cyclically between low and high logical values, and further including a semiconductor device having a low-skew clock generator circuit comprising

a DC amplifier to convert said early and said late bus clock signals into full-swing logic signals,

a first variable delay line having a first variable delay and an input and an output, the input of said first variable delay line being connected to said DC amplifier

a first, a second and a third additional delay line, each having an input and an output, the input of each of said additional delay lines being connected to the output of said first delay line,

said first additional delay line having a fixed delay,

said second additional delay line having said
fixed delay plus a second variable delay, and

said third additional delay line having said fixed
delay plus one half of said second variable delay,

5 a first clocked input receiver connected to sample said
early bus clock signal and gated by said output of said
first additional delay line,

10 a means for adjusting said first variable delay so said
first clocked input receiver samples said early bus clock
signal just as said early bus clock signal transitions,

15 a second clocked input receiver connected to sample
said late bus clock signal and gated by said output of said
second additional delay line,

20 a means for adjusting said second variable delay so
said second clocked input receiver samples said late bus
clock signal just as said late bus clock signal transitions,

whereby said output of said third additional delay line
is synchronized to a time halfway between said outputs of
said first and said second additional delay lines, and said
output of said third additional delay line provides an
internal device clock signal.

81. The bus subsystem of claim 80 further comprising a
semiconductor device having

a first one of said low-skew clock generator circuits which generates a "true" internal device clock signal and

a second one of said low-skew clock generator circuits connected to generate a "complement" internal device clock signal synchronized with but opposite in logical value to said "true" internal device clock signal.

82. A DRAM device designed to be connected to an external bus having a plurality of bus lines for carrying substantially all address, data and control information needed by said DRAM device as a sequential series of bits, said control information including device-select information, said external bus containing substantially fewer said bus lines than the number of bits in a single address, and said bus carrying device-select information without the need for separate device-select lines connected directly to said DRAM device, said DRAM device comprising

an array of memory cells connected in rows and columns, each of said memory cells adapted to store one of said bits,

a row address selection means for selecting one of said rows,

a column sense amp connected to each of said columns, each of said column sense amps adapted to latch one of said

bits as a binary logical value or to precharge to a selected state,

5 a column decoding means connected to each of said column sense amps for selecting a plurality of said column sense amps for inputting one of said bits to or outputting one of said bits from said memory cells,

an internal I/O bus having a plurality of internal I/O lines wherein each of said internal I/O lines is connected to a plurality of said column sense amps, and

10 a plurality of bus connection means designed to connect said internal I/O lines to said external bus,

15 whereby a selected bit of said sequential series of bits can be transferred from said external bus to a selected one of said memory cells or said bit contained in a selected one of said memory cells can be transferred to said external bus.

83. The DRAM device of claim 82 further comprising

20 an output driver connected to one said bus connection means,

an output multiplexer having an output connected to said output driver and a plurality of inputs, each of said inputs being connected to one of said internal I/O lines, and

a control means to select whether said output driver can drive said external bus,

whereby a plurality of memory cells are selected using said row address selection means and said column decoding means and a plurality of bits contained in said plurality of memory cells are output through said column sense amps to said internal I/O bus to said output multiplexer to said output driver to said external bus.

84. The DRAM device of claim 82 further comprising

a plurality of input receivers connected to one of said bus data lines and to said internal I/O bus,

a selection means for selecting said input receivers one by one to sense and store, one at a time, the bits of said sequential series of bits, and

a control means to select whether an input receiver can drive said internal I/O bus, whereby a bit of said sequential series of bits is input from said external bus through one of said input receivers to one of said internal I/O lines to one of said column sense amps to one of said memory cells.

85. The DRAM device of claim 82 further comprising
a first and a second half-array of said memory cells
wherein each said row of said array of said memory cells is
subdivided into two parts,

5 a first and a second one of said internal I/O buses
connected to said column sense amps in said first and said
second half-arrays, respectively, and

10 a column decoder means to gate selected ones of said
column sense amps connected to said memory cells in a
selected row of said first and said second half-arrays
simultaneously.

15 86. The DRAM device of claim 85 wherein said column decoder
means selects sixteen column sense amps at a time.

20 87. The DRAM device of claim 82 wherein said external bus
operates at a certain speed and wherein said DRAM device includes
four of said internal I/O buses, each of which operates at one-
fourth the speed of said external bus.

88. The DRAM device of claim 82 further comprising
a means for precharging one of said column sense amps
to a precharged state from which a binary logical value can
quickly be loaded into said column sense amp,

if said column sense amp contains a binary logical value, a means for latching the logical value currently contained in said column sense amp and

a means for instructing said DRAM device to precharge said column sense amp or latch said binary logical value in said column sense amp.

89. The DRAM device of claim 88 further comprising a means for instructing said DRAM device to precharge said column sense amp without further instruction whenever said row address selection means selects a different one of said rows.

90. The DRAM device of claim 88 further comprising a means for instructing said DRAM device to precharge said column sense amp without further instruction at a first or a second preselected time after latching the latest said binary logical value, said first preselected time being long enough for said DRAM to latch said binary logical value into said column sense amp and transfer said binary logical value into memory or onto one of said internal I/O lines, and said second preselected time being a variable which can be stored in said DRAM device whereby said DRAM can latch a binary logical value into said column sense amp for transferring said binary logical value into or out of a selected said memory cell, then precharge to allow a faster subsequent read or write.

91. A package containing

a semiconductor die having a side, circuitry and a plurality of connecting areas positioned along or near said side, spaced at a selected pitch and connected to said circuitry,

said package comprising a plurality of bus connecting means for connecting to a plurality of external bus lines, each of said external bus lines corresponding to one of said connecting areas, each of said bus connecting means being

positioned on a first side of said package, connected to one said external bus line and to said corresponding connecting area on said semiconductor die, and

spaced at a pitch substantially identical to said selected pitch of said connecting areas,

whereby each of said external bus lines can be connected to said corresponding connecting area on said semiconductor die by bus connection means positioned along a single side of said package.

92. The package of claim 91 further comprising a plurality of said bus connecting means wherein each of said bus connecting means includes

a pin adapted for connection to one of said external bus lines and

a wire connecting said pin to one of said connecting areas on said semiconductor die,

said wire having an effective lead length less than about 4 millimeters and wherein the effective lead length of said wire of each of said bus connection means for said package is approximately equal.

93. A plurality of packages of claim 91 wherein at least two of said semiconductor die are memory devices, each of said packages being generally flat, having a top and a bottom, and wherein

said packages are physically secured adjacent and parallel to each other in a stack,

where a first one of said packages is adjacent to a second one of said packages in said stack, said top of said first package is substantially aligned with said bottom of said second package, and

said bus connecting means of each of said packages are substantially aligned and are lying substantially in a plane.

94. The plurality of packages of claim 93 further comprising a plurality of stacks wherein each of said bus connecting means can be electrically connected to corresponding said bus connecting means in each of said stacks.

95. A semiconductor device capable of use in a semiconductor bus architecture including a plurality of semiconductor devices connected in parallel to a bus wherein said bus includes a plurality of bus lines for carrying substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said bus, and

at least one modifiable identification register accessible to said bus through said connection means, whereby data may be transmitted to said register via said bus and enable said device thereafter to be uniquely identified.

96. The semiconductor device of claim 95 wherein said semiconductor device is a memory device which connects substantially only to said bus and sends and receives substantially all address, data and control information over said bus.

97. A semiconductor device capable of use in a semiconductor bus architecture including a plurality of semiconductor devices connected in parallel to a bus wherein said bus includes a plurality of bus lines for carrying substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said bus, and

at least one modifiable register to hold device address information, said modifiable register accessible to said bus through said connection means, whereby data may be transmitted to said register via said bus which enables said device thereafter to respond to a predetermined range of addresses.

98. The semiconductor device of claim 97 wherein said semiconductor device is a memory device which connects substantially only to said bus and sends and receives

substantially all address, data and control information over said bus.

5 99. The semiconductor device of claim 98 wherein said memory device has at least one discrete memory section and also has at least one modifiable address register adapted to store memory address information which corresponds to each said discrete memory section.

10 100. The semiconductor device of claim 99 wherein said memory address information comprises a pointer to said discrete memory section.

15 101. The semiconductor device of claim 100 wherein said discrete memory section has a top and a bottom and said memory address information comprises pointers to said top and said bottom.

20 102. The semiconductor device of claim 100 wherein said memory address information comprises
a pointer to said discrete memory section and
a range value indicating the size of said discrete memory section.

103. A semiconductor device capable of use in a semi-
conductor bus architecture including a plurality of semiconductor
devices connected in parallel to a bus wherein said bus includes
a plurality of bus lines for carrying substantially all address,
5 data and control information needed by said semiconductor device
for communication with substantially every other semiconductor
device connected to said bus, and has substantially fewer bus
lines than the number of bits in a single address, said
semiconductor device comprising

10 connection means adapted to connect said semiconductor
device to said bus, and

at least one modifiable access-time register accessible
to said bus through said connection means, whereby data may
be transmitted to said register via said bus which
15 establishes a predetermined amount of time that said
semiconductor device thereafter must wait before using said
bus in response to a request.

104. The semiconductor device of claim 103 wherein said
20 semiconductor device is a memory device which connects
substantially only to said bus and sends and receives
substantially all address, data and control information over said
bus.

105. The semiconductor device of claim 103 further comprising at least two access-time registers and one of said access-time registers is permanently programmed to contain a fixed value and at least one of said access-time registers can be modified by information carried on said bus.

106. A semiconductor device capable of use in a semiconductor bus architecture including a plurality of semiconductor devices connected in parallel to a bus wherein said bus includes a plurality of bus lines for carrying substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, and wherein each said bus line is a terminated transmission line, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said bus, and

a bus line driver capable of producing a low-voltage-swing signal on one of said terminated transmission lines.

107. The semiconductor device of claim 106 wherein said
semiconductor device is a memory device which connects
substantially only to said bus and sends and receives
substantially all address, data and control information over said
bus.

108. A semiconductor device capable of use in a semi-
conductor bus architecture including a plurality of semiconductor
devices connected in parallel to a bus wherein said bus includes
a plurality of bus lines for carrying substantially all address,
data, control and device-select information needed by said
semiconductor device for communication with substantially every
other semiconductor device connected to said bus, and has
substantially fewer bus lines than the number of bits in a single
address, and carries device-select information for said
semiconductor device without the need for a separate device-
select line connected directly to said individual semiconductor
device, said bus further including at least one bus clock line
for carrying early and late bus clock signals, said semiconductor
device comprising

connection means adapted to connect said semiconductor
device to said bus, and

an internal device clock generating means which
generates an internal device clock synchronized to a time
halfway between said early and said late bus clock signals.

109. The semiconductor device of claim 108 wherein said bus further includes a first and a second one of said bus clock lines, said first bus clock line carries said early bus clock signal and said second bus clock line carries said late bus clock signal, said semiconductor device further comprising a means to detect said early bus clock signal on said first bus clock line and a means to detect said late bus clock signal on said second bus clock line.

110. The semiconductor device of claim 109 wherein said semiconductor device is a memory device which connects substantially only to said bus and sends and receives substantially all address, data and control information over said bus.

111. A semiconductor device capable of use in a semiconductor bus architecture including a plurality of semiconductor devices connected in parallel to a bus wherein said bus includes a plurality of bus lines for carrying as a sequential series of bits substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a

separate device-select line connected directly to said individual semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said bus,

5 a plurality of input receivers connected to one of said bus data lines and

a selection means for selecting said input receivers one by one to sense and store, one at a time, the bits of said sequential series of bits.

10 112. The semiconductor device of claim 111 wherein said semiconductor device is a memory device which connects substantially only to said bus and sends and receives substantially all address, data and control information over said
15 bus.

113. The semiconductor device of claim 112 wherein two input receivers are connected to one of said bus lines.

20 114. A semiconductor device capable of use in an architecture for a semiconductor system bus including a plurality of semiconductor devices connected in parallel to a bus wherein said bus system includes a plurality of bus lines for carrying substantially all address, data, control and device-select
25 information needed by said semiconductor device for communication

with substantially every other semiconductor device connected to
said system bus, and has substantially fewer bus lines than the
number of bits in a single address, and carries device-select
information for said semiconductor device without the need for a
5 separate device-select line connected directly to said individual
semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor
device to said system bus,

an internal input/output bus within said semiconductor
10 device having more lines than said system bus, and

a means for multiplexing the lines of said internal bus
to the lines of said system bus, whereby said system bus can
run at a higher speed than said internal bus.

115. The semiconductor device of claim 114 wherein said
semiconductor device is a memory device which connects
substantially only to said system bus and sends and receives
substantially all address, data and control information over said
system bus.

116. A semiconductor device capable of use in an
architecture for a semiconductor system bus including a plurality
of semiconductor devices connected in parallel to a bus wherein
said system bus includes a plurality of bus lines for carrying
25 substantially all address, data, control and device-select

information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said system bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said system bus,

an internal input/output bus within said semiconductor device having more lines than said system bus,

a means for multiplexing the lines of said internal bus to the lines of said system bus, whereby said system bus can run at a higher speed than said internal bus, and

at least one modifiable identification register accessible to said system bus through said connection means, whereby data may be transmitted to said register via said system bus and which enables said device thereafter to be uniquely identified.

117. The semiconductor device of claim 116 wherein said semiconductor device is a memory device which connects substantially only to said system bus and sends and receives substantially all address, data and control information over said system bus.

118. A semiconductor device capable of use in an architecture for a semiconductor system bus including a plurality of semiconductor devices connected in parallel to a bus wherein said system bus includes a plurality of bus lines for carrying substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said system bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said system bus,

an internal input/output bus within said semiconductor device having more lines than said system bus,

a means for multiplexing the lines of said internal bus to the lines of said system bus, whereby said system bus can run at a higher speed than said internal bus, and

at least one modifiable register to hold device address information, said modifiable register accessible to said system bus through said connection means, whereby data may be transmitted to said register via said system bus which enables said device thereafter to respond to a predetermined range of addresses.

119. The semiconductor device of claim 118 wherein said semiconductor device is a memory device which connects substantially only to said system bus and sends and receives substantially all address, data and control information over said system bus.

120. The semiconductor device of claim 119 wherein said memory device has at least one discrete memory section and also has at least one modifiable address register adapted to store memory address information which corresponds to each said discrete memory section.

121. A semiconductor device capable of use in an architecture for a semiconductor system bus including a plurality of semiconductor devices connected in parallel to a bus wherein said system bus includes a plurality of bus lines for carrying substantially all address, data and control information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said system bus, and has substantially fewer bus lines than the number of bits in a single address, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said system bus,

an internal input/output bus within said semiconductor device having more lines than said system bus,

a means for multiplexing the lines of said internal bus to the lines of said system bus, whereby said system bus can run at a higher speed than said internal bus, and

at least one modifiable access-time register accessible to said system bus through said connection means, whereby data may be transmitted to said register via said system bus which establishes a predetermined amount of time that said semiconductor device thereafter must wait before using said system bus in response to a request.

122. The semiconductor device of claim 121 wherein said semiconductor device is a memory device which connects substantially only to said system bus and sends and receives substantially all address, data and control information over said system bus.

123. The semiconductor device of claim 121 further comprising at least two access-time registers and one of said access-time registers is permanently programmed to contain a fixed value and at least one of said access-time registers can be modified by information carried on said system bus.

124. A semiconductor device capable of use in a semiconductor bus architecture including a plurality of semiconductor devices connected in parallel to a bus wherein said bus includes

a plurality of bus lines for carrying substantially all address, data, control and device-select information needed by said semiconductor device for communication with substantially every other semiconductor device connected to said bus, and has substantially fewer bus lines than the number of bits in a single address, and carries device-select information for said semiconductor device without the need for a separate device-select line connected directly to said individual semiconductor device, wherein said address, data, control and device-select information is carried over said bus in the form of request packets and bus transactions, said semiconductor device comprising

connection means adapted to connect said semiconductor device to said bus,

a means to receive said request packets over said bus,

a means to decode information in said request packets,

and

a means to respond to said information in said request packets.

125. The semiconductor device of claim 124 wherein said means to decode information in said request packet further comprises

a means to identify and decode said control information in said request packet,

a means to identify and decode said device-select information in said request packet,

a means to identify and decode said address information in said request packet and

5 a means to determine whether said control information or said address information instructs said semiconductor device to begin a response.

10 126. The semiconductor device of claim 124 wherein each of said bus transactions is carried out in response to said address and said control information in one of said request packets, and wherein said means to identify and decode information in said request packets includes a means to identify a sequence of bytes on said bus as one of said request packets containing said
15 address and said control information, said control information including information about the type of said bus transaction being requested and the access time which needs to intervene before beginning said bus transaction over said bus and said address and said control information includes device-select
20 information instructing one or more said semiconductor devices to respond to said address and said control information.

127. The semiconductor device of claim 124 further comprising

a plurality of sense amplifiers adapted to precharge to a selected state or to latch a bit of information,

a means to hold said sense amplifiers in an unmodified state after latching one of said bits of information,

a means to precharge said sense amplifiers and

a means for selecting whether said semiconductor device should precharge said sense amplifiers or should hold said sense amplifiers in an unmodified state.

128. The semiconductor device of claim 124 wherein said means to respond to said information, where said information is control information, further comprises a means to

transfer a data block during a data block transfer, further including a means to

read data from said semiconductor device and

write data into said semiconductor device, and

initiate a data block transfer,

transfer a data block of a selected size,

transfer a data block at a selected time,

access a control register, including a means to read from or write to said control register, or select normal or page-mode access.

129. The semiconductor device of claim 124 further comprising a means to respond to said information in said request

packet if said information includes a device identification number unique to said semiconductor device.

5 130. The semiconductor device of claim 124 further comprising a means to respond to said information in said request packet if said information includes a special device identification number which calls for said semiconductor device to respond.

10 131. The semiconductor device of claim 124 further comprising a means to respond to said information in said request packet if said information includes an address unique to said semiconductor device.

15 132. The semiconductor device of claim 124 further comprising a means to interpret said control information and decode the time to wait before beginning said bus transaction over said bus.

20 133. The semiconductor device of claim 124 further comprising a means to interpret said control information and decode the size of a data block to transfer during one of said bus transactions.

134. The semiconductor device of claim 124, 125, 126, 127,
128, 129, 130, 131, 132 or 133 wherein said semiconductor device
is a memory device which connects substantially only to said bus
and sends and receives substantially all address, data and
control information over said bus.

135. A semiconductor device capable of use in a semi-
conductor bus architecture including a plurality of semiconductor
devices connected in parallel to a bus wherein said bus includes
a plurality of bus lines for carrying substantially all address,
data, control and device-select information needed by said
semiconductor device for communication with substantially every
other semiconductor device connected to said bus, and has
substantially fewer bus lines than the number of bits in a single
address, and carries device-select information for said
semiconductor device without the need for a separate device-
select line connected directly to said individual semiconductor
device, wherein said address, data, control and device-select
information is carried over said bus in the form of request
packets and bus transactions, said semiconductor device
comprising

connection means adapted to connect said semiconductor
device to said bus,

a means to encode address and control information in
said request packets and

a means to send said request packets over said bus.

136. The semiconductor device of claim 135 further comprising a means to request a bus transaction wherein each of said bus transactions is carried out in response to said address and said control information in one of said request packets, and wherein said means to encode information in said request packets includes a means to mark a sequence of bytes on said bus as one of said request packets, said control information including information about the type of said bus transaction being requested and the access time which needs to intervene before beginning said bus transaction over said bus and said address and said control information includes device-select information instructing one or more said semiconductor devices to respond to said address and said control information.

137. The semiconductor device of claim 135 wherein one or more of said plurality of semiconductor devices has a unique device identification number, said semiconductor device further comprising a means to send control information to a specific one of said plurality of semiconductor devices by including in said request packet a selected said device identification number.

138. The semiconductor device of claim 135 wherein each of said plurality of semiconductor devices is adapted to respond to

a special device identification number, said semiconductor device further comprising a means to send control information to each of said plurality of semiconductor devices by including in said request packet said special device identification number.

5

139. The semiconductor device of claim 135 wherein one or more of said plurality of semiconductor devices is a memory device having a plurality of addresses, said semiconductor device further comprising a means to send control information to a specific address or range of addresses in one of said plurality of semiconductor devices by including said specific address or range of addresses in said request packet.

10
095549
15
004000

140. The semiconductor device of claim 135 wherein at least one of said request packets is a request packet requesting a bus transaction which is followed by a corresponding one of said bus transactions, said semiconductor device further comprising a means to encode said control information to specify directly or indirectly the time between the end of said request packet requesting a bus transaction and said corresponding bus transaction over said bus.

20

141. The semiconductor device of claim 140 wherein one type of said bus transactions is a transfer of a data block, said semiconductor device further comprising a means to encode said

25

control information to specify the size of said data block to transfer.

142. The semiconductor device of claim 140 further comprising a means to keep track of current and pending bus transactions, whereby collisions on said bus are avoided because said semiconductor device avoids initiating bus transactions which would conflict with current or pending bus transactions.

143. The semiconductor device of claim 135 wherein said semiconductor device is a first master device and one of said plurality of semiconductor devices is a second master device, further comprising

a collision detecting means whereby said first master device when sending a first one of said request packets can detect said second master device sending a colliding one of said request packets, where said colliding request packet may be sent simultaneous with the initial sending of or overlapping the sending of said first request packet, and

an arbitration means whereby said first and said second master devices select a priority order in which each of said master devices will be allowed to access said bus sequentially.

144. The semiconductor device of claim 143 wherein said semiconductor device is a master device and at least one of said plurality of semiconductor devices is a master device, each of said master devices has a master ID number and each of said request packets includes a master ID position which is a predetermined number of bits in a predetermined position in said request packet, and wherein said collision detection means comprises

a means for said semiconductor device to send its master ID number in said request packet and

a means to detect a collision and invoke said arbitration means if said semiconductor device detects any other master ID number in said master ID position.

145. The semiconductor device of claim 144 wherein said system bus architecture includes a means for carrying information on said bus during bus cycles, said semiconductor device further comprising

a means for driving a selected bus line or lines during at least one selected bus cycle while sending each said request packet,

a means for monitoring said selected bus line or lines to see if another said master device is sending one of said colliding request packets and

a means for informing all said master devices that a collision has occurred and for invoking said arbitration means.

5 146. The semiconductor device of claim 145 further comprising

a means, when sending a request packet, for driving a selected bus line or lines with a certain current during at least one selected bus cycle,

10 a means for monitoring said selected bus line or lines for a greater than normal current to see if another said master device is driving that line or lines,

a means for detecting said greater than normal current, and

15 a means for informing all said master devices that a collision has occurred and for invoking said arbitration means.

20 147. The semiconductor device of claim 143 wherein said arbitration means comprises

a means for initiating an arbitration cycle,

a means for allocating a single bus line to each said master device during at least one selected bus cycle relative to the start of said arbitration cycle,

a means for allocating each said master device to a single bus line during one of said selected bus cycles if there are more master devices than available bus lines,

a means for each of said master devices which sent one of said colliding request packets to drive said bus line allocated to said master device during said selected bus cycle, and

a means in at least one of said master devices for storing information about which master devices sent one of said colliding request packets,

whereby said master devices can monitor selected bus lines during said arbitration cycle and identify each said master device which sent one of said colliding request packets.

148. The semiconductor device of claim 143 wherein said arbitration means comprises

a means for identifying each of said master devices which sent one of said colliding request packets,

a means for assigning a priority to each said master device which sent one of said colliding request packets, and

a means for allowing each said master device which sent one of said colliding request packets to access the bus sequentially according to that priority.

149. The semiconductor device of claim 143 wherein said priority is based on the physical location of each of said master devices.

5 150. The semiconductor device of claim 143 wherein said priority is based on said master ID number of said master devices.

10
11
12
13
14
15
16
17
18
19
20
21
22
23
24
25
26
27
28
29
30
31
32
33
34
35
36
37
38
39
40
41
42
43
44
45
46
47
48
49
50
51
52
53
54
55
56
57
58
59
60
61
62
63
64
65
66
67
68
69
70
71
72
73
74
75
76
77
78
79
80
81
82
83
84
85
86
87
88
89
90
91
92
93
94
95
96
97
98
99
100
101
102
103
104
105
106
107
108
109
110
111
112
113
114
115
116
117
118
119
120
121
122
123
124
125
126
127
128
129
130
131
132
133
134
135
136
137
138
139
140
141
142
143
144
145
146
147
148
149
150
151
152
153
154
155
156
157
158
159
160
161
162
163
164
165
166
167
168
169
170
171
172
173
174
175
176
177
178
179
180
181
182
183
184
185
186
187
188
189
190
191
192
193
194
195
196
197
198
199
200
201
202
203
204
205
206
207
208
209
210
211
212
213
214
215
216
217
218
219
220
221
222
223
224
225
226
227
228
229
230
231
232
233
234
235
236
237
238
239
240
241
242
243
244
245
246
247
248
249
250
251
252
253
254
255
256
257
258
259
260
261
262
263
264
265
266
267
268
269
270
271
272
273
274
275
276
277
278
279
280
281
282
283
284
285
286
287
288
289
290
291
292
293
294
295
296
297
298
299
300
301
302
303
304
305
306
307
308
309
310
311
312
313
314
315
316
317
318
319
320
321
322
323
324
325
326
327
328
329
330
331
332
333
334
335
336
337
338
339
340
341
342
343
344
345
346
347
348
349
350
351
352
353
354
355
356
357
358
359
360
361
362
363
364
365
366
367
368
369
370
371
372
373
374
375
376
377
378
379
380
381
382
383
384
385
386
387
388
389
390
391
392
393
394
395
396
397
398
399
400
401
402
403
404
405
406
407
408
409
410
411
412
413
414
415
416
417
418
419
420
421
422
423
424
425
426
427
428
429
430
431
432
433
434
435
436
437
438
439
440
441
442
443
444
445
446
447
448
449
450
451
452
453
454
455
456
457
458
459
460
461
462
463
464
465
466
467
468
469
470
471
472
473
474
475
476
477
478
479
480
481
482
483
484
485
486
487
488
489
490
491
492
493
494
495
496
497
498
499
500
501
502
503
504
505
506
507
508
509
510
511
512
513
514
515
516
517
518
519
520
521
522
523
524
525
526
527
528
529
530
531
532
533
534
535
536
537
538
539
540
541
542
543
544
545
546
547
548
549
550
551
552
553
554
555
556
557
558
559
560
561
562
563
564
565
566
567
568
569
570
571
572
573
574
575
576
577
578
579
580
581
582
583
584
585
586
587
588
589
590
591
592
593
594
595
596
597
598
599
600
601
602
603
604
605
606
607
608
609
610
611
612
613
614
615
616
617
618
619
620
621
622
623
624
625
626
627
628
629
630
631
632
633
634
635
636
637
638
639
640
641
642
643
644
645
646
647
648
649
650
651
652
653
654
655
656
657
658
659
660
661
662
663
664
665
666
667
668
669
670
671
672
673
674
675
676
677
678
679
680
681
682
683
684
685
686
687
688
689
690
691
692
693
694
695
696
697
698
699
700
701
702
703
704
705
706
707
708
709
710
711
712
713
714
715
716
717
718
719
720
721
722
723
724
725
726
727
728
729
730
731
732
733
734
735
736
737
738
739
740
741
742
743
744
745
746
747
748
749
750
751
752
753
754
755
756
757
758
759
760
761
762
763
764
765
766
767
768
769
770
771
772
773
774
775
776
777
778
779
780
781
782
783
784
785
786
787
788
789
790
791
792
793
794
795
796
797
798
799
800
801
802
803
804
805
806
807
808
809
810
811
812
813
814
815
816
817
818
819
820
821
822
823
824
825
826
827
828
829
830
831
832
833
834
835
836
837
838
839
840
841
842
843
844
845
846
847
848
849
850
851
852
853
854
855
856
857
858
859
860
861
862
863
864
865
866
867
868
869
870
871
872
873
874
875
876
877
878
879
880
881
882
883
884
885
886
887
888
889
890
891
892
893
894
895
896
897
898
899
900
901
902
903
904
905
906
907
908
909
910
911
912
913
914
915
916
917
918
919
920
921
922
923
924
925
926
927
928
929
930
931
932
933
934
935
936
937
938
939
940
941
942
943
944
945
946
947
948
949
950
951
952
953
954
955
956
957
958
959
960
961
962
963
964
965
966
967
968
969
970
971
972
973
974
975
976
977
978
979
980
981
982
983
984
985
986
987
988
989
990
991
992
993
994
995
996
997
998
999
1000
1001
1002
1003
1004
1005
1006
1007
1008
1009
1010
1011
1012
1013
1014
1015
1016
1017
1018
1019
1020
1021
1022
1023
1024
1025
1026
1027
1028
1029
1030
1031
1032
1033
1034
1035
1036
1037
1038
1039
1040
1041
1042
1043
1044
1045
1046
1047
1048
1049
1050
1051
1052
1053
1054
1055
1056
1057
1058
1059
1060
1061
1062
1063
1064
1065
1066
1067
1068
1069
1070
1071
1072
1073
1074
1075
1076
1077
1078
1079
1080
1081
1082
1083
1084
1085
1086
1087
1088
1089
1090
1091
1092
1093
1094
1095
1096
1097
1098
1099
1100
1101
1102
1103
1104
1105
1106
1107
1108
1109
1110
1111
1112
1113
1114
1115
1116
1117
1118
1119
1120
1121
1122
1123
1124
1125
1126
1127
1128
1129
1130
1131
1132
1133
1134
1135
1136
1137
1138
1139
1140
1141
1142
1143
1144
1145
1146
1147
1148
1149
1150
1151
1152
1153
1154
1155
1156
1157
1158
1159
1160
1161
1162
1163
1164
1165
1166
1167
1168
1169
1170
1171
1172
1173
1174
1175
1176
1177
1178
1179
1180
1181
1182
1183
1184
1185
1186
1187
1188
1189
1190
1191
1192
1193
1194
1195
1196
1197
1198
1199
1200
1201
1202
1203
1204
1205
1206
1207
1208
1209
1210
1211
1212
1213
1214
1215
1216
1217
1218
1219
1220
1221
1222
1223
1224
1225
1226
1227
1228
1229
1230
1231
1232
1233
1234
1235
1236
1237
1238
1239
1240
1241
1242
1243
1244
1245
1246
1247
1248
1249
1250
1251
1252
1253
1254
1255
1256
1257
1258
1259
1260
1261
1262
1263
1264
1265
1266
1267
1268
1269
1270
1271
1272
1273
1274
1275
1276
1277
1278
1279
1280
1281
1282
1283
1284
1285
1286
1287
1288
1289
1290
1291
1292
1293
1294
1295
1296
1297
1298
1299
1300
1301
1302
1303
1304
1305
1306
1307
1308
1309
1310
1311
1312
1313
1314
1315
1316
1317
1318
1319
1320
1321
1322
1323
1324
1325
1326
1327
1328
1329
1330
1331
1332
1333
1334
1335
1336
1337
1338
1339
1340
1341
1342
1343
1344
1345
1346
1347
1348
1349
1350
1351
1352
1353
1354
1355
1356
1357
1358
1359
1360
1361
1362
1363
1364
1365
1366
1367
1368
1369
1370
1371
1372
1373
1374
1375
1376
1377
1378
1379
1380
1381
1382
1383
1384
1385
1386
1387
1388
1389
1390
1391
1392
1393
1394
1395
1396
1397
1398
1399
1400
1401
1402
1403
1404
1405
1406
1407
1408
1409
1410
1411
1412
1413
1414
1415
1416
1417
1418
1419
1420
1421
1422
1423
1424
1425
1426
1427
1428
1429
1430
1431
1432
1433
1434
1435
1436
1437
1438
1439
1440
1441
1442
1443
1444
1445
1446
1447
1448
1449
1450
1451
1452
1453
1454
1455
1456
1457
1458
1459
1460
1461
1462
1463
1464
1465
1466
1467
1468
1469
1470
1471
1472
1473
1474
1475
1476
1477
1478
1479
1480
1481
1482
1483
1484
1485
1486
1487
1488
1489
1490
1491
1492
1493
1494
1495
1496
1497
1498
1499
1500
1501
1502
1503
1504
1505
1506
1507
1508
1509
1510
1511
1512
1513
1514
1515
1516
1517
1518
1519
1520
1521
1522
1523
1524
1525
1526
1527
1528
1529
1530
1531
1532
1533
1534
1535
1536
1537
1538
1539
1540
1541
1542
1543
1544
1545
1546
1547
1548
1549
1550
1551
1552
1553
1554
1555
1556
1557
1558
1559
1560
1561
1562
1563
1564
1565
1566
1567
1568
1569
1570
1571
1572
1573
1574
1575
1576
1577
1578
1579
1580
1581
1582
1583
1584
1585
1586
1587
1588
1589
1590
1591
1592
1593
1594
1595
1596
1597
1598
1599
1600
1601
1602
1603
1604
1605
1606
1607
1608
1609
1610
1611
1612
1613
1614
1615
1616
1617
1618
1619
1620
1621
1622
1623
1624
1625
1626
1627
1628
1629
1630
1631
1632
1633
1634
1635
1636
1637
1638
1639
1640
1641
1642
1643
1644
1645
1646
1647
1648
1649
1650
1651
1652
1653
1654
1655
1656
1657
1658
1659
1660
1661
1662
1663
1664
1665
1666
1667
1668
1669
1670
1671
1672
1673
1674
1675
1676
1677
1678
1679
1680
1681
1682
1683
1684
1685
1686
1687
1688
1689
1690
1691
1692
1693
1694
1695
1696
1697
1698
1699
1700
1701
1702
1703
1704
1705
1706
1707
1708
1709
1710
1711
1712
1713
1714
1715
1716
1717
1718
1719
1720
1721
1722
1723
1724
1725
1726
1727
1728
1729
1730
1731
1732
1733
1734
1735
1736
1737
1738
1739
1740
1741
1742
1743
1744
1745
1746
1747
1748
1749
1750
1751
1752
1753
1754
1755
1756
1757
1758
1759
1760
1761
1762
1763
1764
1765
1766
1767
1768
1769
1770
1771
1772
1773
1774
1775
1776
1777
1778
1779
1780
1781
1782
1783
1784
1785
1786
1787
1788
1789
1790
1791
1792
1793
1794
1795
1796
1797
1798
1799
1800
1801
1802
1803
1804
1805
1806
1807
1808
1809
1810
1811
1812
1813
1814
1815
1816
1817
1818
1819
1820
1821
1822
1823
1824
1825
1826
1827
1828
1829
1830
1831
1832
1833
1834
1835
1836
1837
1838
1839
1840
1841
1842
1843
1844
1845
1846
1847
1848
1849
1850
1851
1852
1853
1854
1855
1856
1857
1858
1859
1860
1861
1862
1863
1864
1865
1866
1867
1868
1869
1870
1871
1872
1873
1874
1875
1876
1877
1878
1879
1880
1881
1882
1883
1884
1885
1886
1887
1888
1889
1890
1891
1892
1893
1894
1895
1896
1897
1898
1899
1900
1901
1902
1903
1904
1905
1906
1907
1908
1909
1910
1911
1912
1913
1914
1915
1916
1917
1918
1919
1920
1921
1922
1923
1924
1925
1926
1927
1928
1929
1930
1931
1932
1933
1934
1935
1936
1937
1938
1939
1940
1941
1942
1943
1944
1945
1946
1947
1948
1949
1950
1951
1952
1953
1954
1955
1956
1957
1958
1959
1960
1961
1962
1963
1964
1965
1966
1967
1968
1969
1970
1971
1972
1973
1974
1975
1976
1977
1978
1979
1980
1981
1982
1983
1984
1985
1986
1987
1988
1989
1990
1991
1992
1993
1994
1995
1996
1997
1998
1999
2000
2001
2002
2003
2004
2005
2006
2007
2008
2009
2010
2011
2012
2013
2014
2015
2016
2017
2018
2019
2020
2021
2022
2023
2024
2025
2026
2027
2028
2029
2030
2031
2032
2033
2034
2035
2036
2037
2038
2039
2040
2041
2042
2043
2044
2045
2046
2047
2048
2049
2050
2051
2052
2053
2054
2055
2056
2057
2058
2059
2060
2061
2062
2063
2064
2065
2066
2067
2068
2069
2070
2071
2072
2073
2074
2075
2076
2077
2078
2079
2080
2081
2082
2083
2084
2085
2086
2087
2088
2089
2090
2091
2092
2093
2094
2095
2096
2097
2098
2099
2100
2101
2102
2103
2104
2105
2106
2107
2108
2109
2110
2111
2112
2113
2114
2115
2116
2117
2118
2119
2120
2121
2122
2123
2124
2125
2126
2127
2128
2129
2130
2131
2132
2133
2134
2135
2136
2137
2138
2139
2140
2141
2142
2143
2144
2145
2146
2147
2148
2149
2150
2151
2152
2153
2154
2155
2156
2157
2158
2159
2160
2161
2162
2163
2164
2165
2166
2167
2168
2169
2170
2171
2172
2173
2174
2175
2176
2177
2178
2179
2180
2181
2182
2183
2184
2185
2186
2187
2188
2189
2190
2191
2192
2193
2194
2195
2196
2197
2198
2199
2200
2201
2202
2203
2204
2205
2206
2207
2208
2209
2210
2211
2212
2213
2214
2215
2216
2217
2218
2219
2220
2221
2222
2223
2224
2225
2226
2227
2228
222

ABSTRACT

5 The present invention includes a memory subsystem comprising
at least two semiconductor devices, including at least one memory
device, connected to a bus, where the bus includes a plurality of
bus lines for carrying substantially all address, data and
control information needed by said memory devices, where the
control information includes device-select information and the
bus has substantially fewer bus lines than the number of bits in
a single address, and the bus carries device-select information
10 without the need for separate device-select lines connected
directly to individual devices.

15 The present invention also includes a protocol for master
and slave devices to communicate on the bus and for registers in
each device to differentiate each device and allow bus requests
to be directed to a single or to all devices. The present
invention includes modifications to prior-art devices to allow
them to implement the new features of this invention. In a
preferred implementation, 8 bus data lines and an AddressValid
bus line carry address, data and control information for memory
20 addresses up to 40 bits wide.

FIG. 2

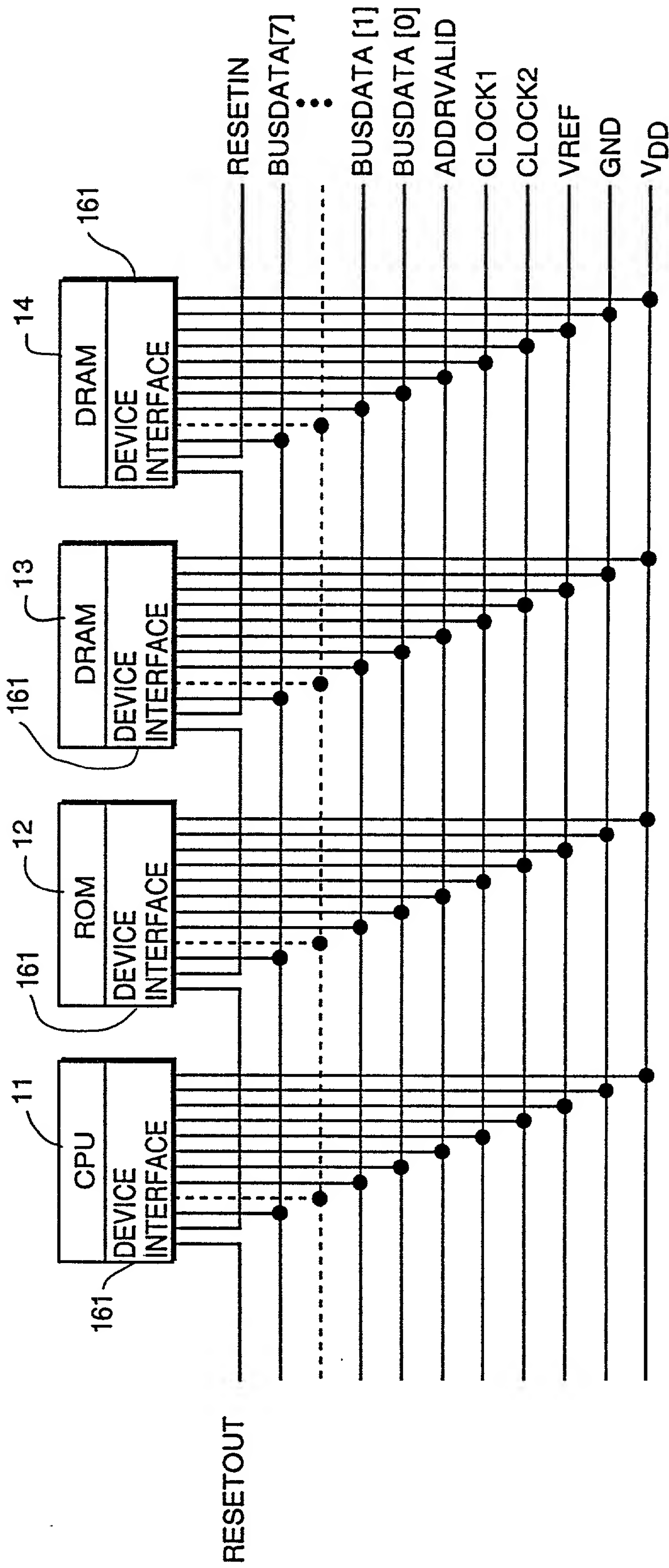
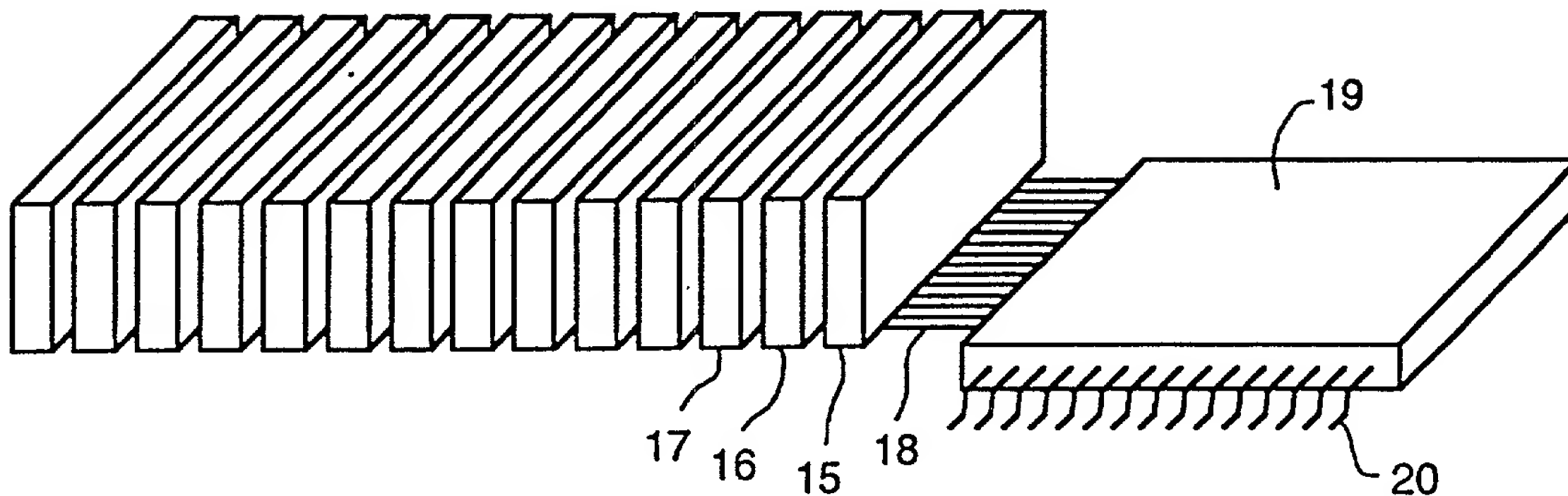


FIG 3



REGULAR ACCESS

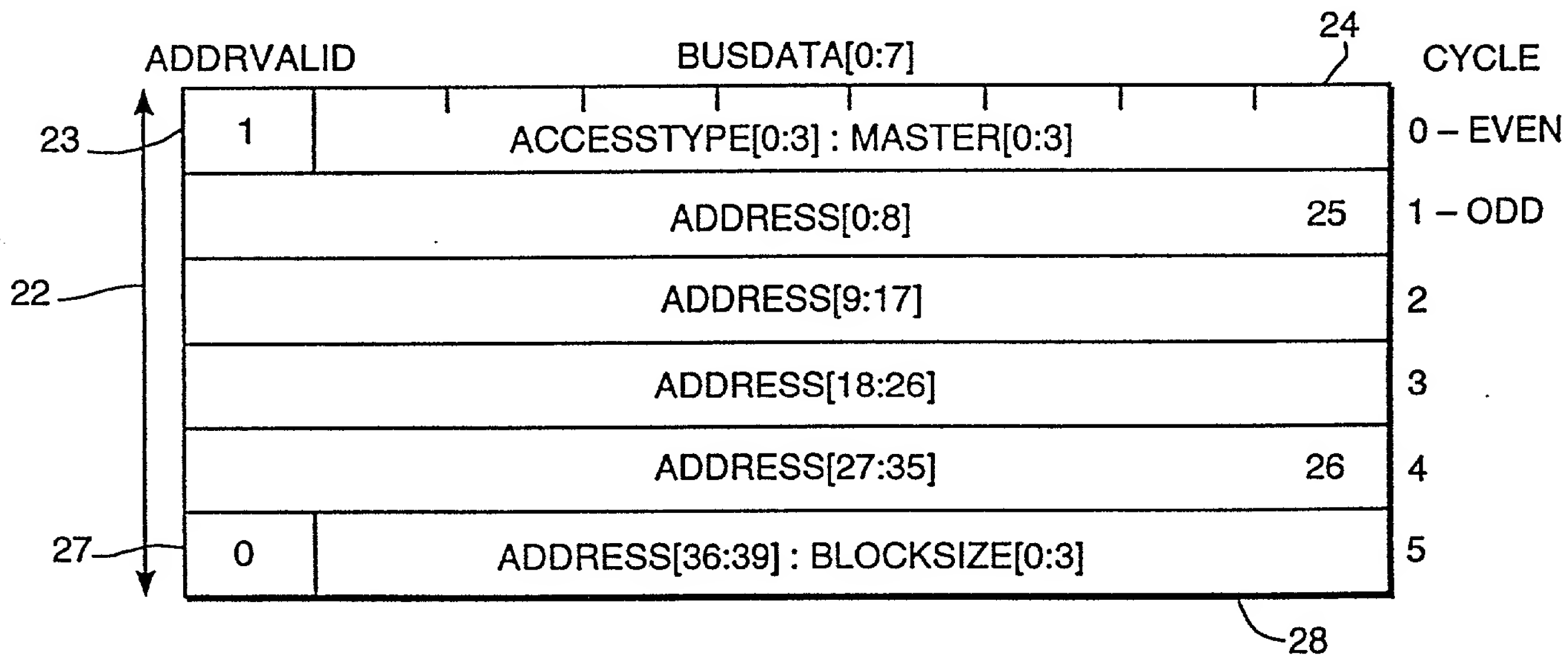


FIG 4

REJECT (NACK) CONTROL PACKET

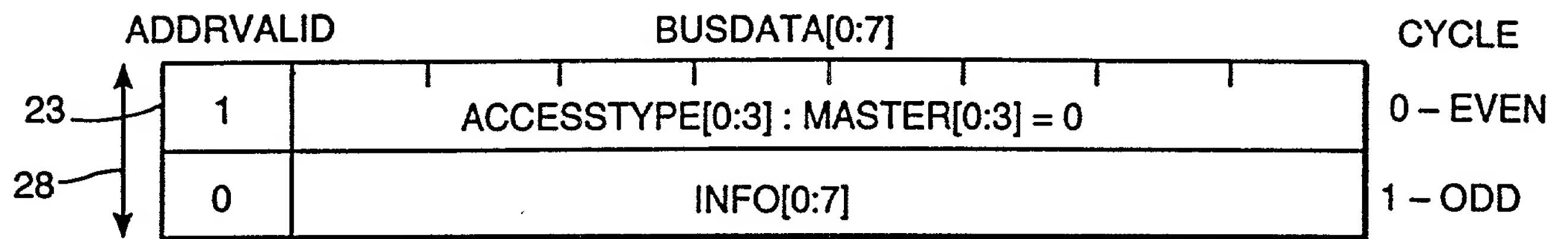


FIG 5

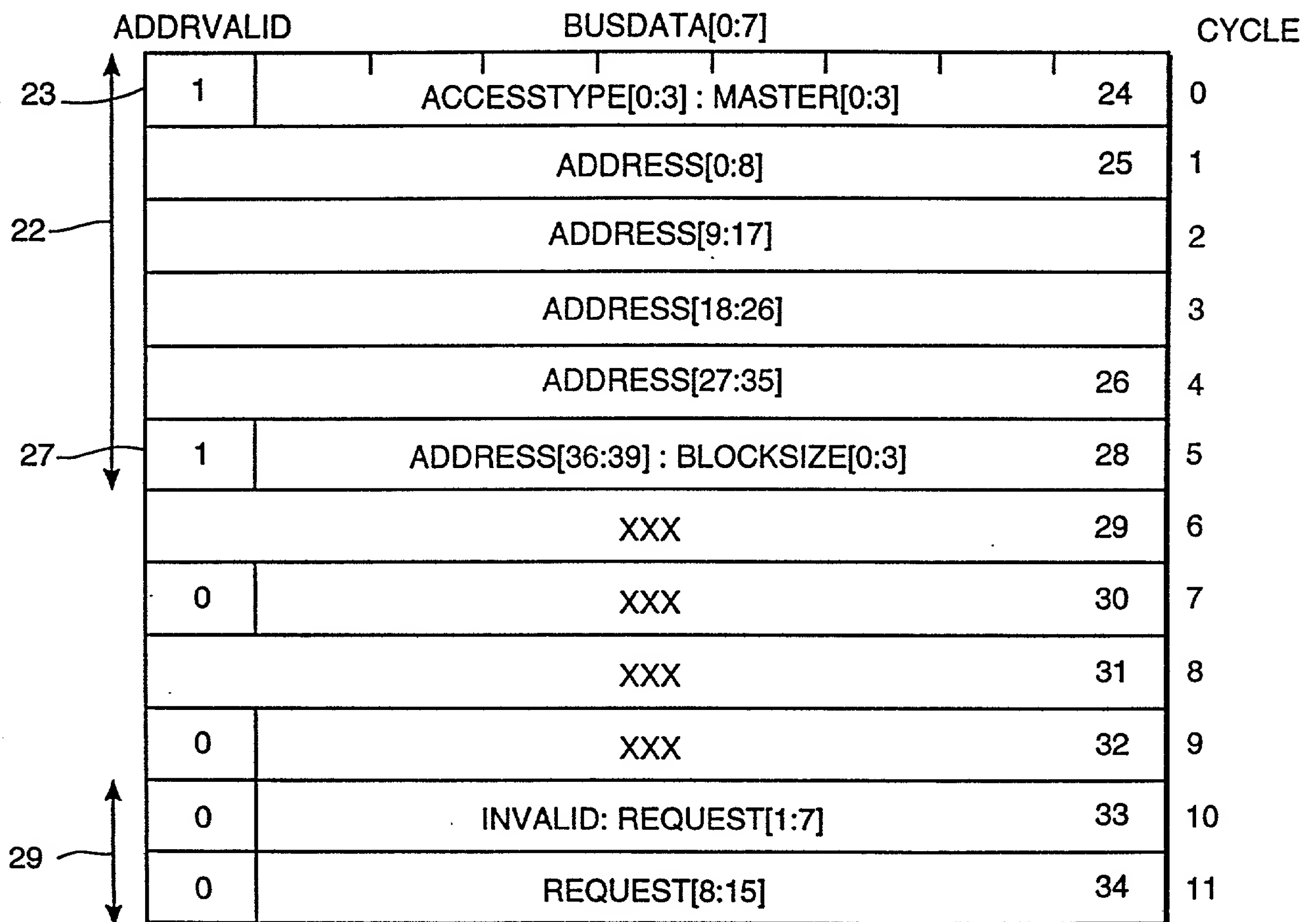
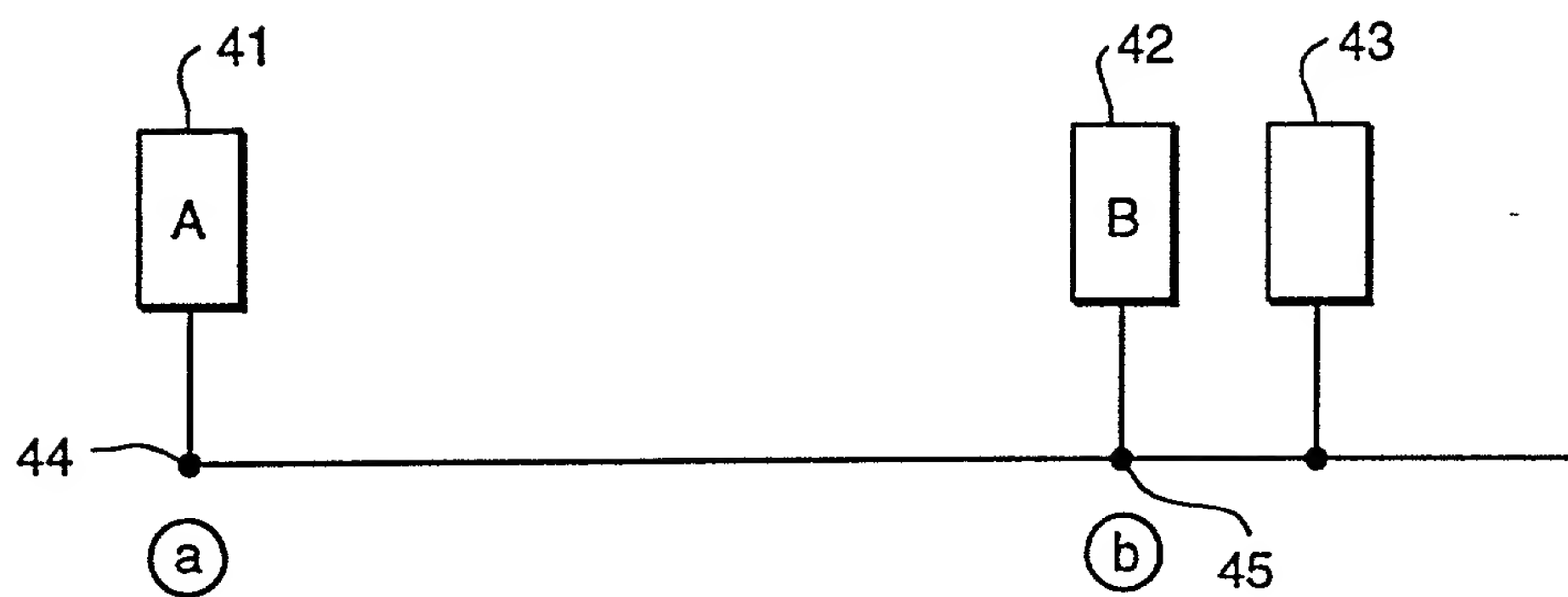


FIG 6



FIG_7A

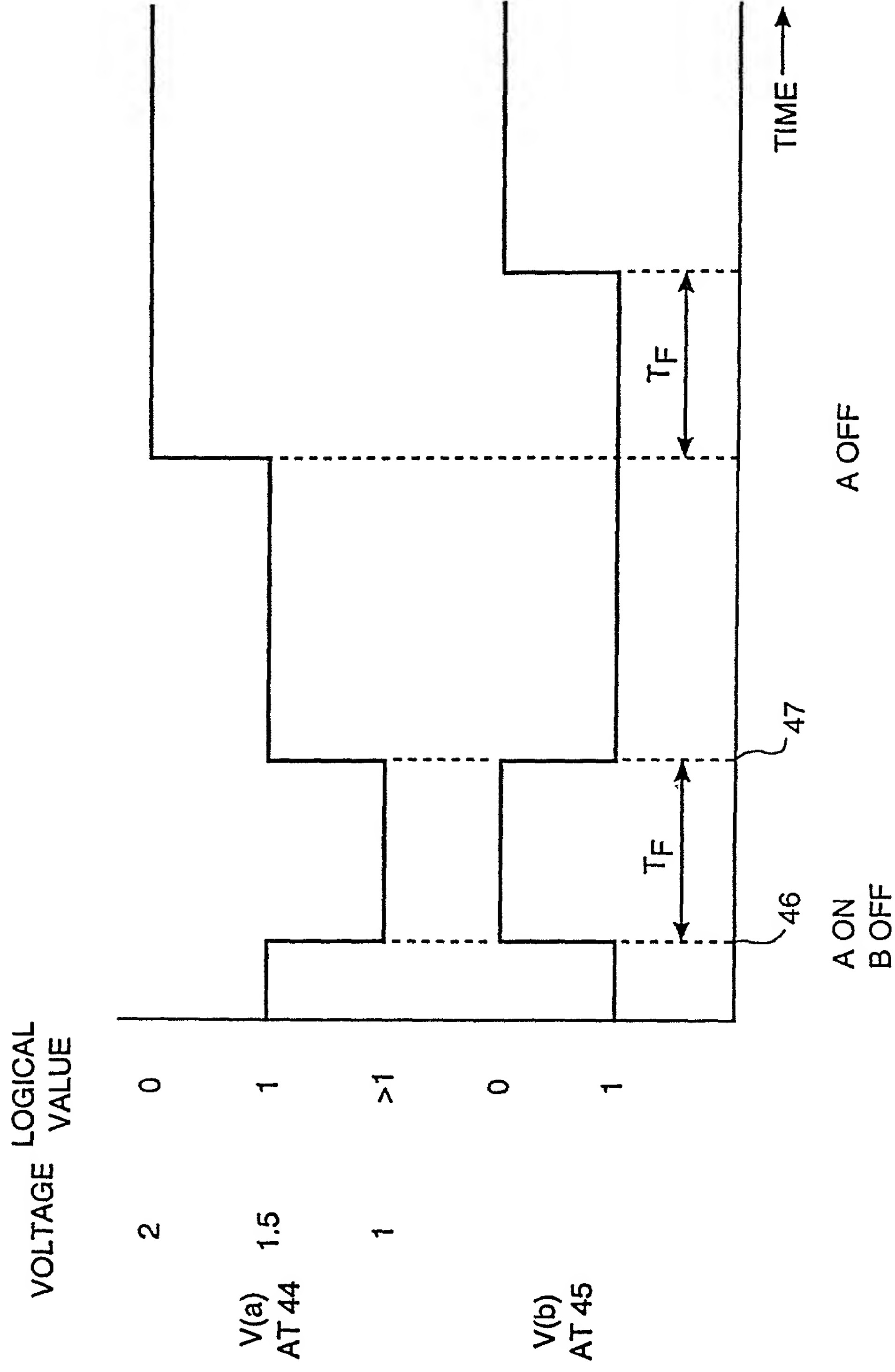


FIG 7B

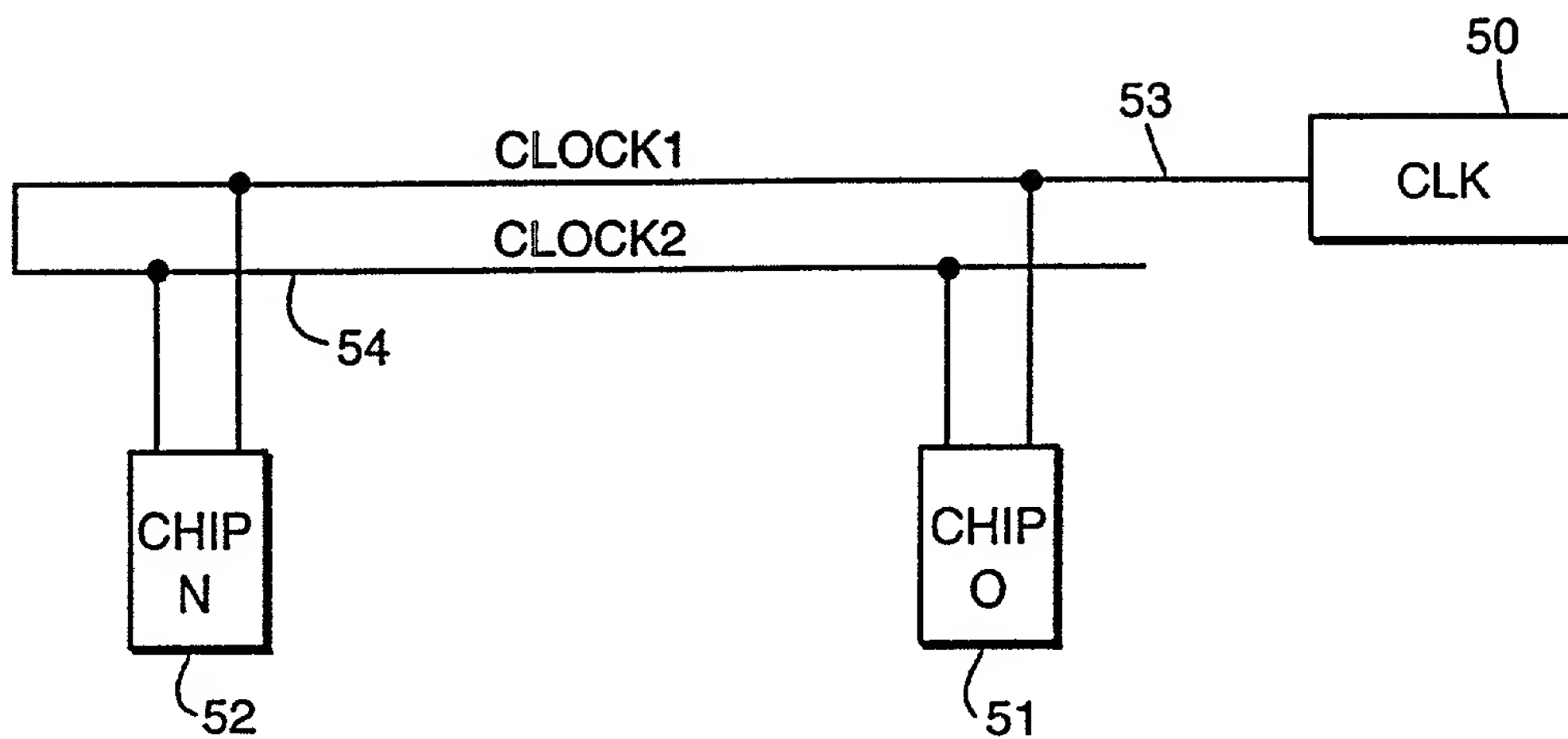


FIG 8A

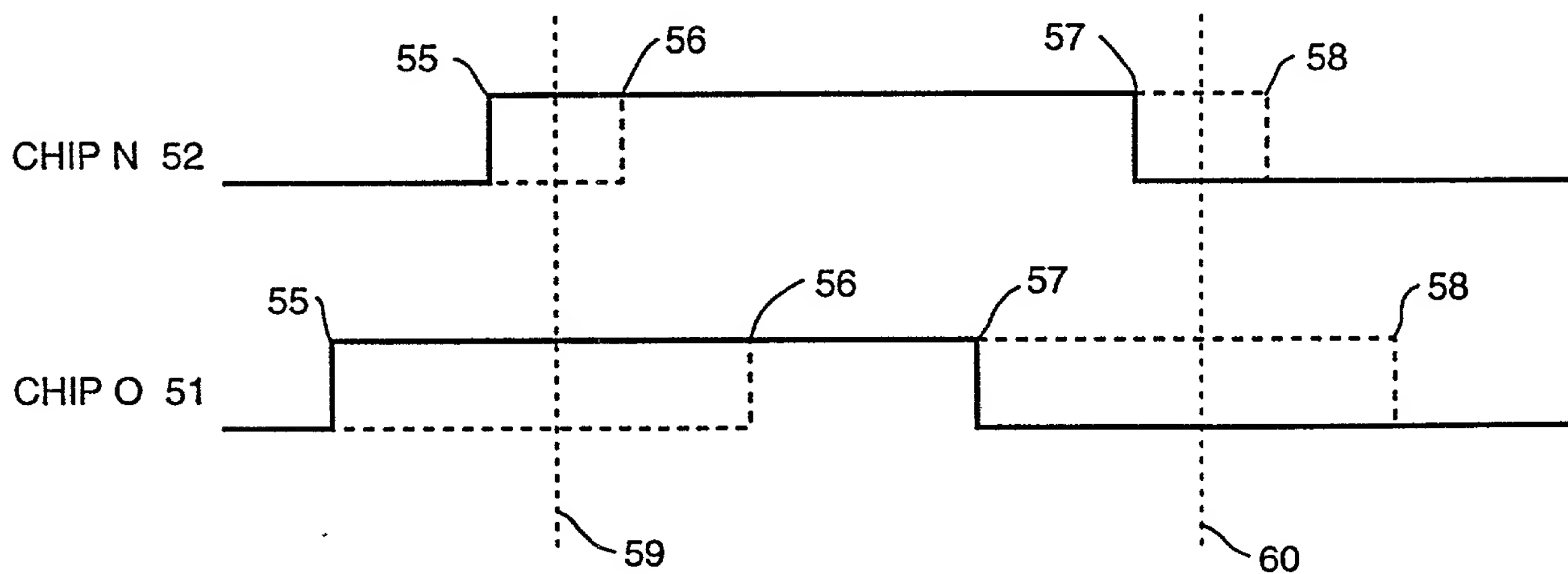
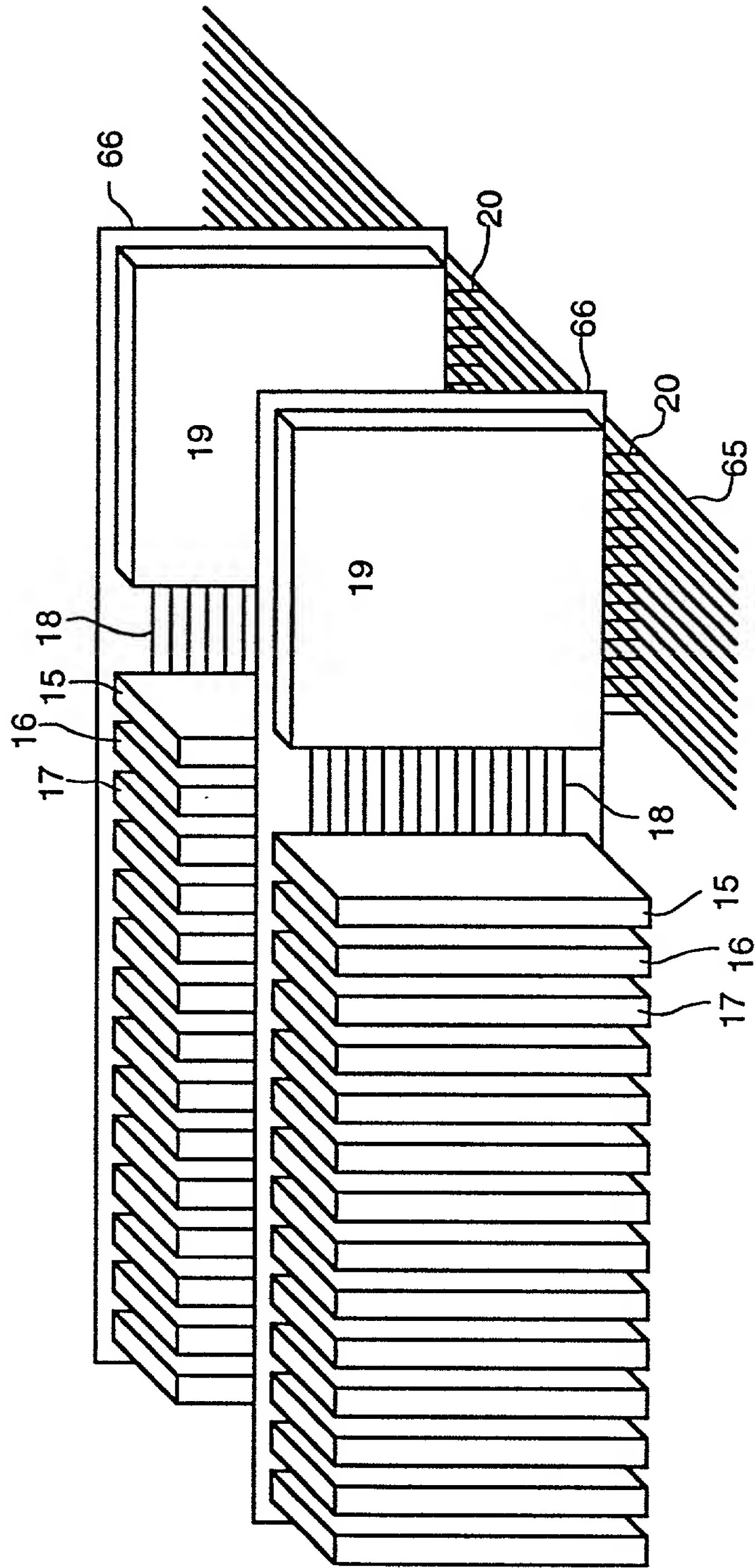


FIG 8B

FIG 9



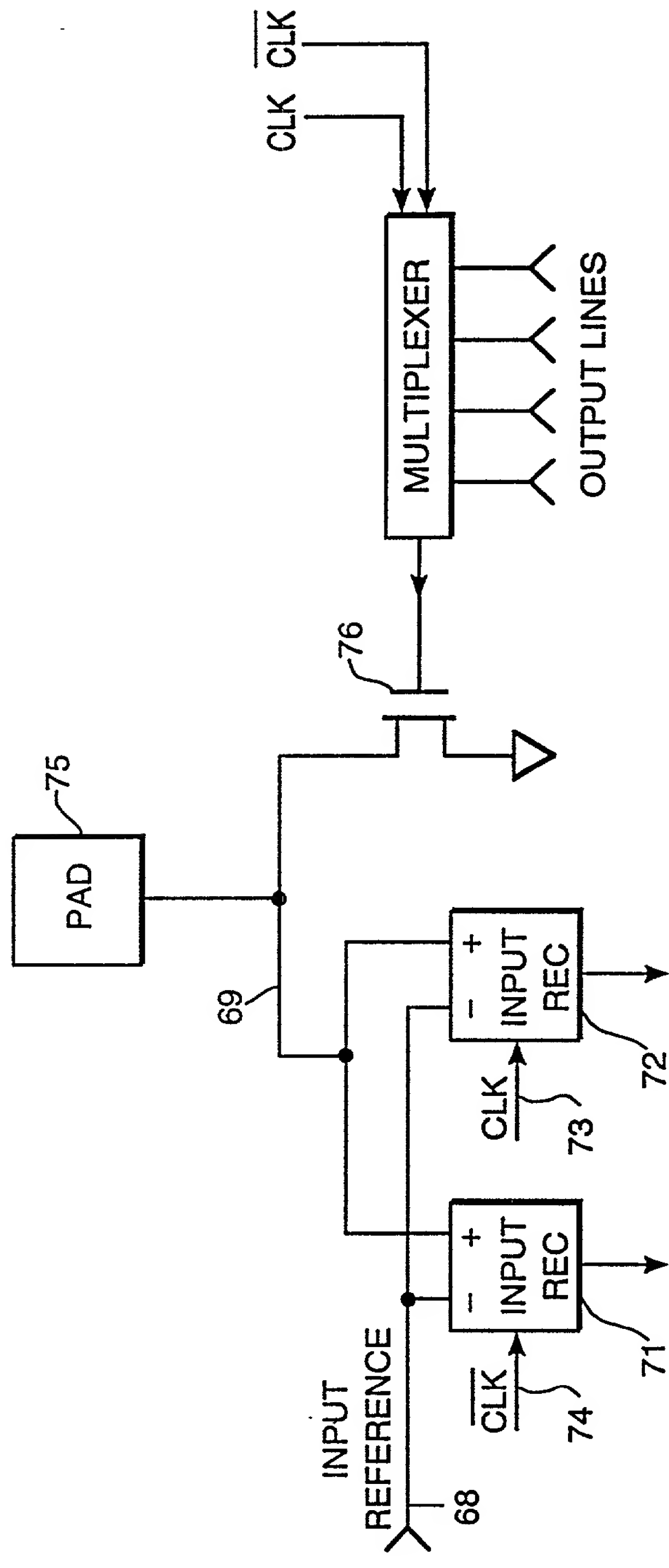


FIG 10

FIG 11

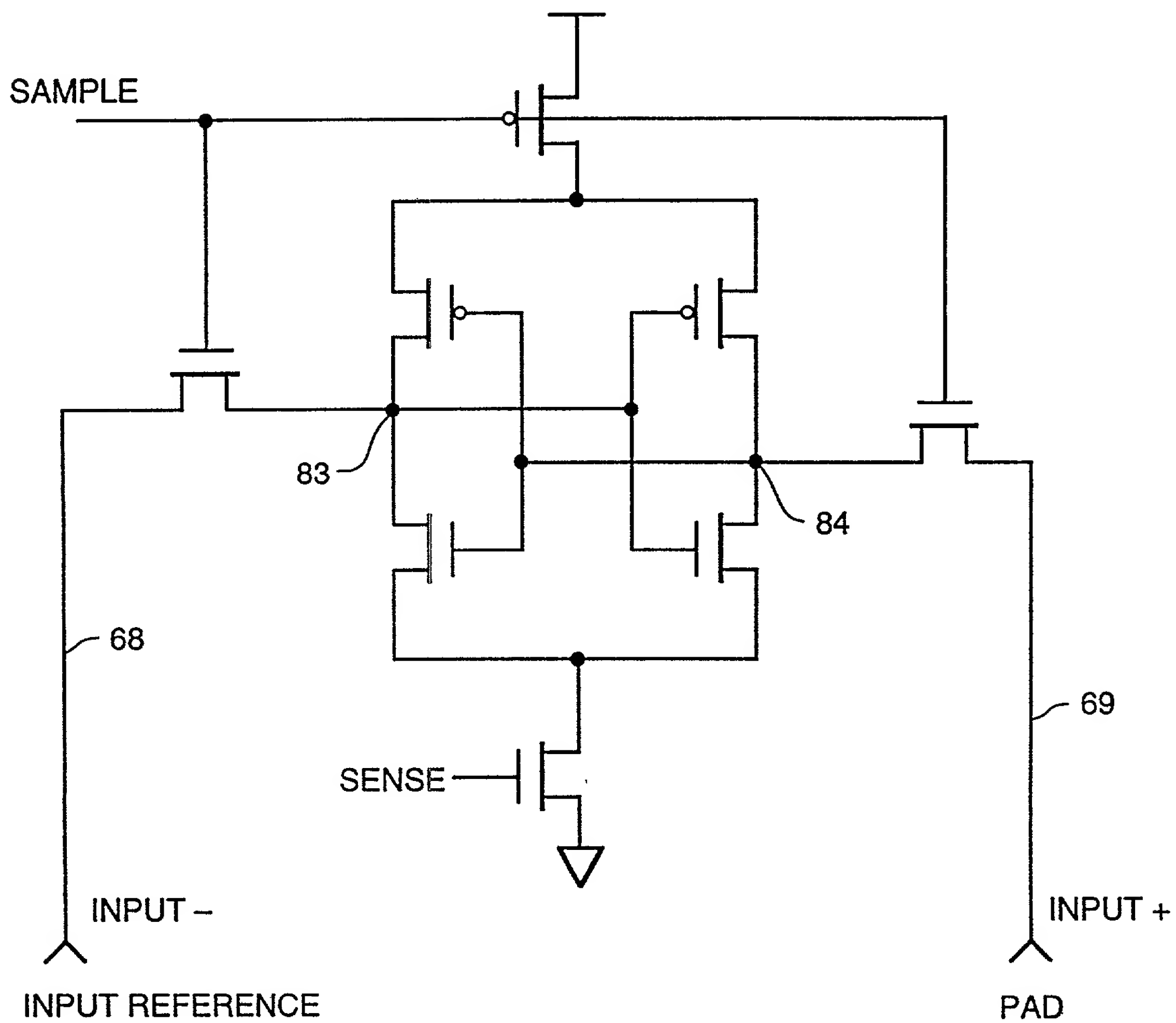


FIG 12

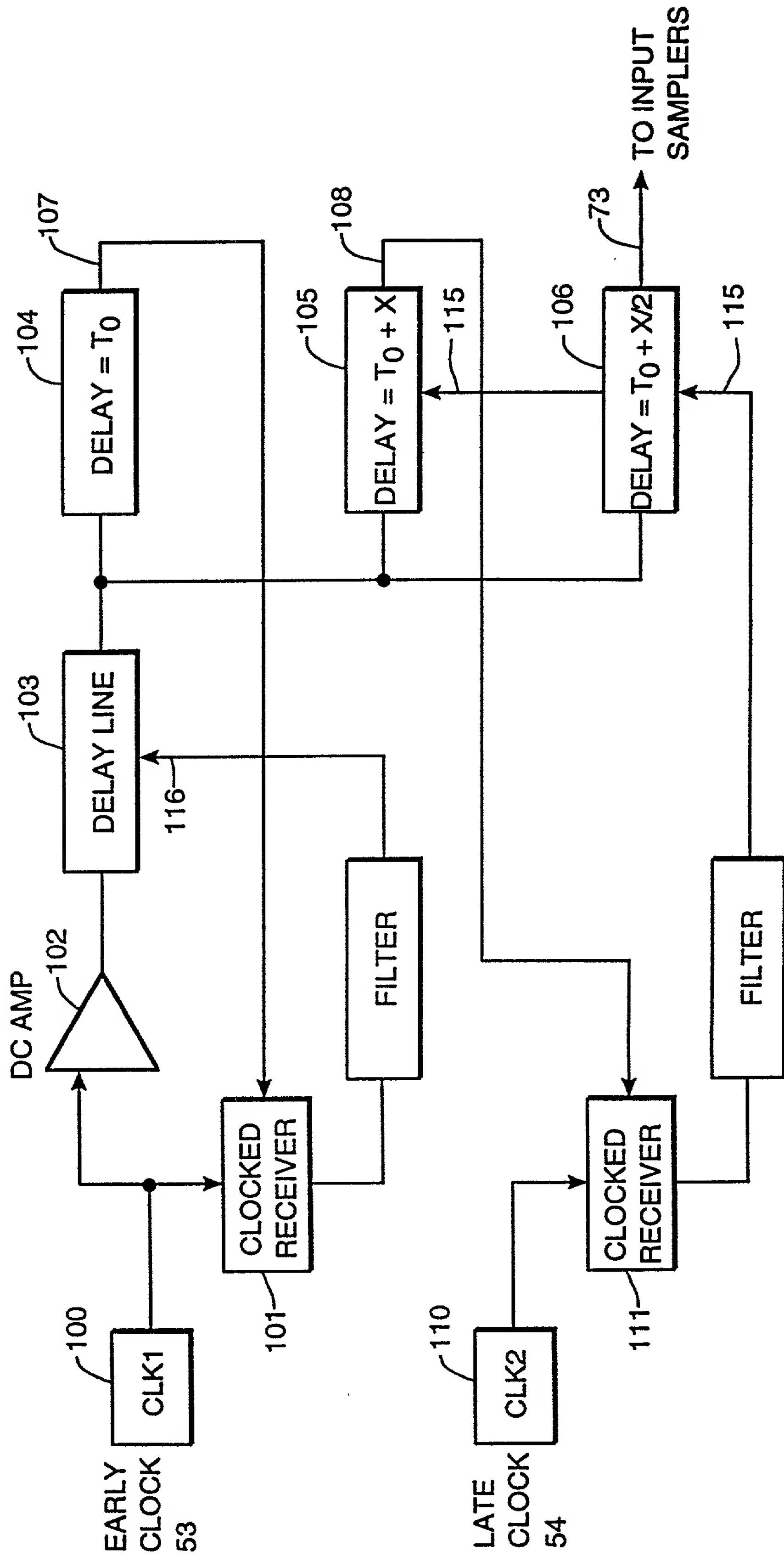
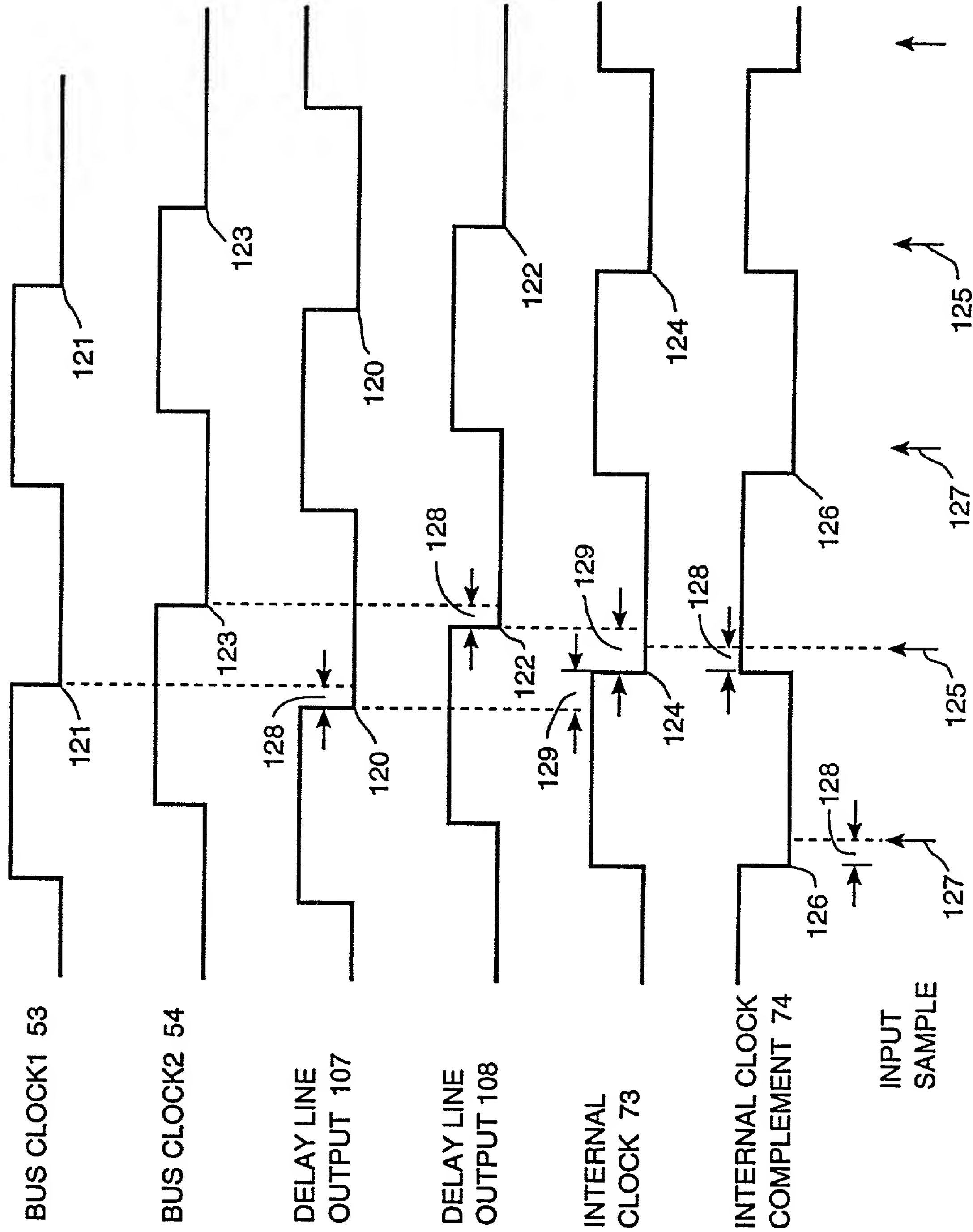


FIG 13



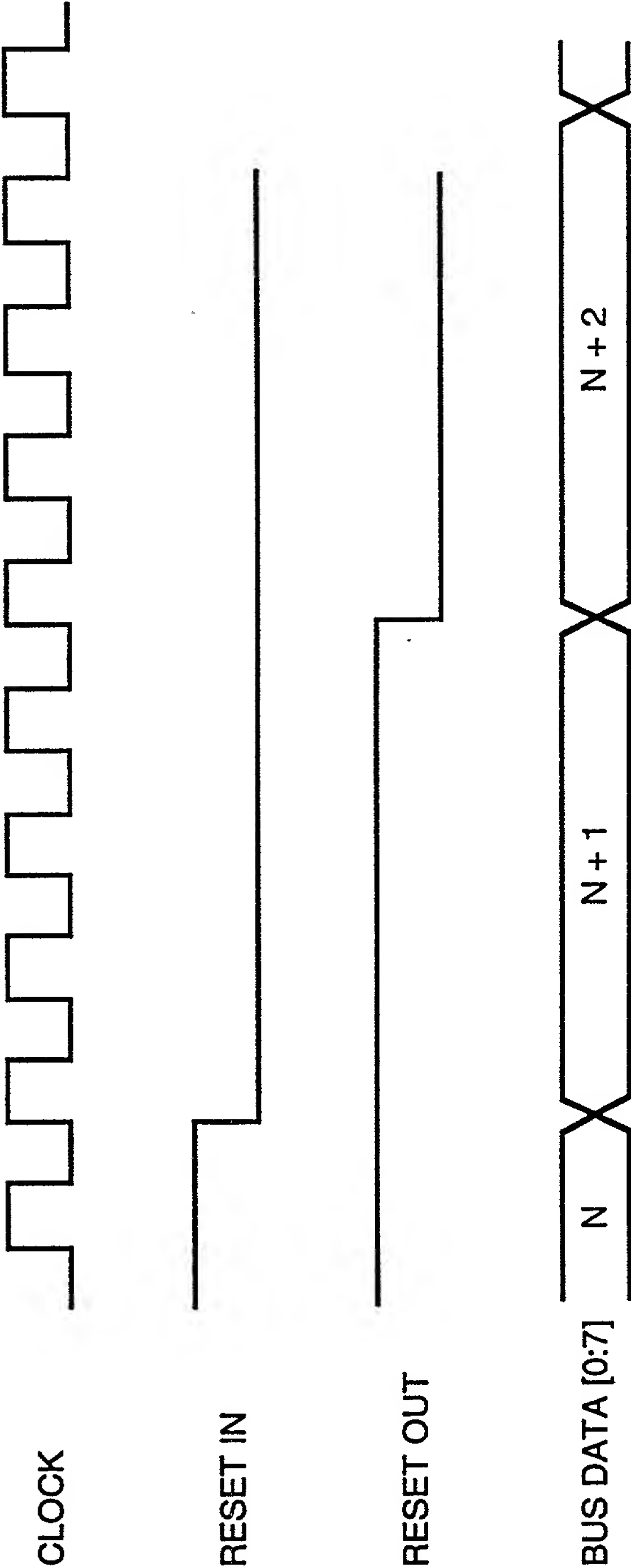
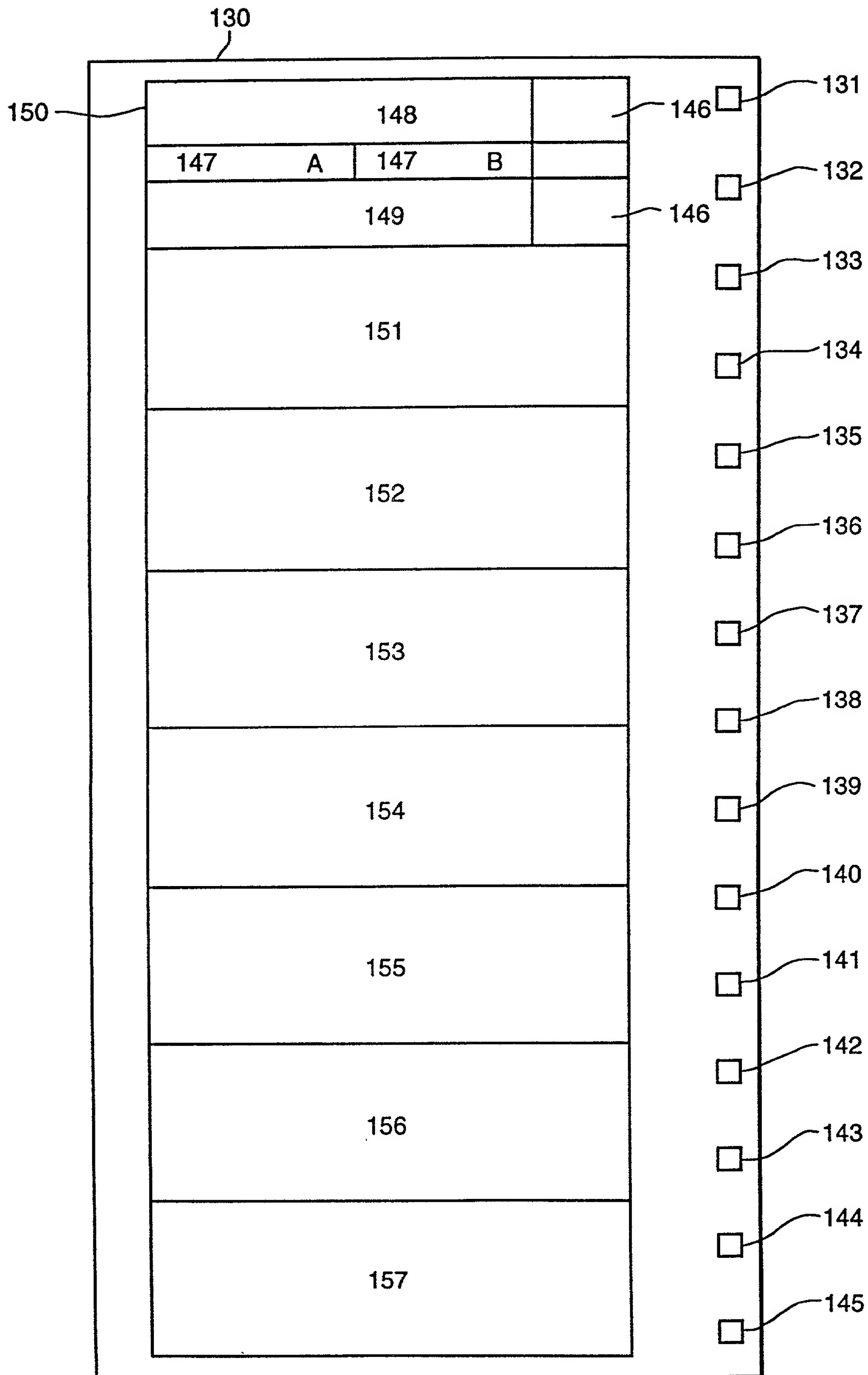


FIG. 15



DECLARATION AND POWER OF ATTORNEY FOR PATENT APPLICATION

As a below named inventor, I hereby declare that:

My residence, post office and citizenship are as stated below, next to my name.

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled INTEGRATED CIRCUIT I/O USING A HIGH PERFORMANCE BUS INTERFACE the specification of which

XX is attached hereto.

_____ was filed on _____ as
Application Serial No. _____
and was amended on _____
(if applicable)

I hereby state that I have reviewed and understand the contents of the above-identified specification, including the claims, as amended by any amendment referred to above. I do not know and do not believe that the same was ever known or used in the United States of America before my invention thereof, or patented or described in any printed publication in any country before my invention thereof or more than one year prior to this application, that the same was not in public use or on sale in the United States of America more than one year prior to this application, and that the invention has not been patented or made the subject of an inventor's certificate issued before the date of this application in any country foreign to the United States of America on an application filed by me or my legal representatives or assigns more than twelve months prior to this application.

I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, Section 1.56(a).

I hereby claim the benefit under Title 35, United States Code, Section 120 of any United States application(s) listed below and, insofar as the subject matter of each of the claims of this application is not disclosed in the prior United States application in the manner provided by the first paragraph of Title 35, United States Code, Section 112, I acknowledge the duty to disclose material information as defined in Title 37, Code of

Federal Regulations, Section 1.56(a) which occurred between the filing date of the prior application and the national or PCT international filing date of this application:

<u>(Application Serial No.)</u>	<u>(Filing Date)</u>	<u>(Status-patented pending, abandoned)</u>
---------------------------------	----------------------	---

<u>(Application Serial No.)</u>	<u>(Filing Date)</u>	<u>(Status-patented pending, abandoned)</u>
---------------------------------	----------------------	---

I hereby appoint Roger S. Borovoy, Reg. No. 20,193, and David J. Larwood, Reg. No. 33,191, 600 Hansen Way, Suite 100, Palo Alto, California 94306, telephone (415) 856-9411, my attorneys with full power of substitution and revocation, to prosecute this application and to transact all business in the Patent and Trademark Office connected herewith. Please address all correspondence to Mr. Larwood.

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under Section 1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issued thereon.

Full Name of Sole/First Inventors: Michael Farmwald

Residence 82 Eucalyptus Rd., Citizenship U.S.A.
Berkeley, California 94705 (Country)
(City, State)

Inventor's Signature Paul Michael Farmwald Date Apr. 17, 1990

Full Name of Joint/Second Inventor: Mark Horowitz

Residence 2024 Columbia Street Citizenship U.S.A.
Palo Alto, California 94306 (Country)

Inventor's Signature Mark Horowitz Date Apr. 17, 1990

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
(Case No. RA043D2DC)

In the Application of:)	
)	
FARMWALD ET AL.)	Group
)	Art Unit:
Serial No: CONTINUATION OF 09/161,090)	
)	Before
Filed: Herewith)	Examiner:
)	
Title: INTEGRATED CIRCUIT HAVING MEMORY)	
WHICH SYNCHRONOUSLY SAMPLES)	
INFORMATION WITH RESPECT TO)	
EXTERNAL CLOCK SIGNALS)	

Assistant Commissioner for Patents
Washington, DC 20231

POWER OF ATTORNEY BY ASSIGNEE,
REVOCATION OF ALL PRIOR POWERS OF ATTORNEY
AND
CERTIFICATE UNDER 37 CFR 3.73(b)

Sir:

The undersigned, being empowered to sign this Power of Attorney, Revocation of All Previous Powers of Attorney and Certificate under 37 CFR 3.73(b) on behalf of Rambus, Inc., the assignee of the entire right, title and interest in the above-referenced application, hereby revokes all prior powers of attorney and hereby appoints Neil A. Steinberg, Reg. No. 34,735, with full power of substitution and revocation to prosecute this application and to transact all business before the United States Patent and Trademark Office in the above-referenced application.

Rambus, Inc., formerly a California corporation with a place of business at 4920A El Camino Real, Los Altos, California 94022, certifies that it is the assignee of the entire right, title and interest in the above-referenced patent application by virtue of an assignment from the inventors, Michael Farmwald and Mark Horowitz. The assignment of the parent patent application (Application Serial No. 07/510,898) and all continuing and divisional application thereof to Rambus Inc. was filed on April 18, 1990 and recorded in the U.S. Patent and Trademark Office at Reel 5385, Frame 875.

The undersigned has reviewed all the documents in the chain of title of the above-referenced application and, to the best of the undersigned's knowledge and belief, title is in Rambus, Inc., the assignee identified above.

Please direct all correspondence in the above-referenced patent application to:

Neil A. Steinberg, Esq.
Rambus Inc.
2465 Latham Street
Mountain View, California 94040
Telephone: 650-944-7772
Facsimile: 650-944-8080

I hereby declare that all statements made herein of my own knowledge are true and that all statements made on information and believed to be true; and further that these statements were made with the knowledge that willful false statements and the like so

1. 1990-1991 2. 1991-1992 3. 1992-1993 4. 1993-1994 5. 1994-1995 6. 1995-1996 7. 1996-1997 8. 1997-1998 9. 1998-1999 10. 1999-2000 11. 2000-2001 12. 2001-2002 13. 2002-2003 14. 2003-2004 15. 2004-2005 16. 2005-2006 17. 2006-2007 18. 2007-2008 19. 2008-2009 20. 2009-2010 21. 2010-2011 22. 2011-2012 23. 2012-2013 24. 2013-2014 25. 2014-2015 26. 2015-2016 27. 2016-2017 28. 2017-2018 29. 2018-2019 30. 2019-2020 31. 2020-2021 32. 2021-2022 33. 2022-2023 34. 2023-2024 35. 2024-2025 36. 2025-2026 37. 2026-2027 38. 2027-2028 39. 2028-2029 40. 2029-2030 41. 2030-2031 42. 2031-2032 43. 2032-2033 44. 2033-2034 45. 2034-2035 46. 2035-2036 47. 2036-2037 48. 2037-2038 49. 2038-2039 50. 2039-2040 51. 2040-2041 52. 2041-2042 53. 2042-2043 54. 2043-2044 55. 2044-2045 56. 2045-2046 57. 2046-2047 58. 2047-2048 59. 2048-2049 60. 2049-2050 61. 2050-2051 62. 2051-2052 63. 2052-2053 64. 2053-2054 65. 2054-2055 66. 2055-2056 67. 2056-2057 68. 2057-2058 69. 2058-2059 70. 2059-2060 71. 2060-2061 72. 2061-2062 73. 2062-2063 74. 2063-2064 75. 2064-2065 76. 2065-2066 77. 2066-2067 78. 2067-2068 79. 2068-2069 80. 2069-2070 81. 2070-2071 82. 2071-2072 83. 2072-2073 84. 2073-2074 85. 2074-2075 86. 2075-2076 87. 2076-2077 88. 2077-2078 89. 2078-2079 90. 2079-2080 91. 2080-2081 92. 2081-2082 93. 2082-2083 94. 2083-2084 95. 2084-2085 96. 2085-2086 97. 2086-2087 98. 2087-2088 99. 2088-2089 100. 2089-2090 101. 2090-2091 102. 2091-2092 103. 2092-2093 104. 2093-2094 105. 2094-2095 106. 2095-2096 107. 2096-2097 108. 2097-2098 109. 2098-2099 110. 2099-2100 111. 2100-2101 112. 2101-2102 113. 2102-2103 114. 2103-2104 115. 2104-2105 116. 2105-2106 117. 2106-2107 118. 2107-2108 119. 2108-2109 120. 2109-2110 121. 2110-2111 122. 2111-2112 123. 2112-2113 124. 2113-2114 125. 2114-2115 126. 2115-2116 127. 2116-2117 128. 2117-2118 129. 2118-2119 130. 2119-2120 131. 2120-2121 132. 2121-2122 133. 2122-2123 134. 2123-2124 135. 2124-2125 136. 2125-2126 137. 2126-2127 138. 2127-2128 139. 2128-2129 140. 2129-2130 141. 2130-2131 142. 2131-2132 143. 2132-2133 144. 2133-2134 145. 2134-2135 146. 2135-2136 147. 2136-2137 148. 2137-2138 149. 2138-2139 150. 2139-2140 151. 2140-2141 152. 2141-2142 153. 2142-2143 154. 2143-2144 155. 2144-2145 156. 2145-2146 157. 2146-2147 158. 2147-2148 159. 2148-2149 160. 2149-2150 161. 2150-2151 162. 2151-2152 163. 2152-2153 164. 2153-2154 165. 2154-2155 166. 2155-2156 167. 2156-2157 168. 2157-2158 169. 2158-2159 170. 2159-2160 171. 2160-2161 172. 2161-2162 173. 2162-2163 174. 2163-2164 175. 2164-2165 176. 2165-2166 177. 2166-2167 178. 2167-2168 179. 2168-2169 180. 2169-2170 181. 2170-2171 182. 2171-2172 183. 2172-2173 184. 2173-2174 185. 2174-2175 186. 2175-2176 187. 2176-2177 188. 2177-2178 189. 2178-2179 190. 2179-2180 191. 2180-2181 192. 2181-2182 193. 2182-2183 194. 2183-2184 195. 2184-2185 196. 2185-2186 197. 2186-2187 198. 2187-2188 199. 2188-2189 200. 2189-2190 201. 2190-2191 202. 2191-2192 203. 2192-2193 204. 2193-2194 205. 2194-2195 206. 2195-2196 207. 2196-2197 208. 2197-2198 209. 2198-2199 210. 2199-2200 211. 2200-2201 212. 2201-2202 213. 2202-2203 214. 2203-2204 215. 2204-2205 216. 2205-2206 217. 2206-2207 218. 2207-2208 219. 2208-2209 220. 2209-2210 221.	
--	--

[Handwritten signature]

Page - 3 -